

AIRCRAFT ATTITUDE MEASUREMENT USING
A VECTOR MAGNETOMETER

Research Report

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Preface

The following report is based on work performed as a part of NASA Grant 05-017-031 by the University of Santa Clara, Department of Electrical Engineering and Computer Science.

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CHAPTER I

A VECTOR AUTOPILOT SYSTEM

1-1 INTRODUCTION

An essential requirement of an aircraft attitude control system is that deviation of the body axes relative to a reference axes frame must be sensed. In addition, to overcome the ever-present possibility of errors or failure of the sensors, various configurations of redundant sensors are usually employed to assist in detection and correction of errors. To this end, there has been a continuing effort to improve existing sensors, to develop new sensor configurations, and to develop new sensor devices.

This chapter discusses the role of a vector magnetometer¹ as a new instrument for aircraft attitude determination. Although magnetometers have played a role in the attitude measurement of missiles and satellites [Ref. 1-1], there is an apparent lack of application in aircraft systems. By providing independent measures of attitude, the solid state vector magnetometer sensor system can not only assist in improving accuracy and reliability of existing systems but can also reduce component count with obvious benefits in weight and cost. Additionally, since a large number of aircraft heading reference systems depend on measurement of the Earth's magnetic field, it can be shown that by substituting a three-axis magnetometer for the remote sensing unit; both heading and attitude measurement functions can be derived using common elements, thereby further reducing the component count.

¹Aviation use to date has been essentially scalar magnetometry.

To investigate the feasibility of the above system, this chapter will proceed by developing a technique to determine attitude given magnetic field components. Sample calculations are then made using the Earth's magnetic field data acquired during actual flight conditions. Results of these calculations are compared graphically with measured attitude data acquired simultaneously with the magnetic data. The role and possible implementation of various reference angles are discussed along with other pertinent considerations. Finally, it is concluded that the Earth's magnetic field as measured by modern vector magnetometers can play a significant role in attitude control systems.

1-2 ATTITUDE DETERMINATION

Coordinate systems are usually defined by orthogonal right-handed sets of three unit vectors. An example of such a set is illustrated in Fig. 1-1 where the orientation of the body fixed frame used in this paper is delineated. Angular rotations are conventionally defined as rotations in the plane normal to a unit vector with the positive sense of rotation defined by the right-hand rule [Ref. 1-2].

To derive relationships of attitude variations as a function of magnetic vector component variation, we can proceed by considering matrix representations of an orthogonal transformation. If H_x , H_y , and H_z are the magnetic components measured at a desired airframe attitude and H_x' , H_y' , and H_z' are the components measured after any rotation of the body, vector $H' = [H_x' \ H_y' \ H_z']^T$ can be related to vector $H = [H_x \ H_y \ H_z]^T$ by an orthogonal linear transformation $H' = AH$. Here A must satisfy the orthogonality condition $AA^T = I$, where A^T is the transpose of A ; additionally, the determinant of A must be unity [Ref. 1-3, 1-4].

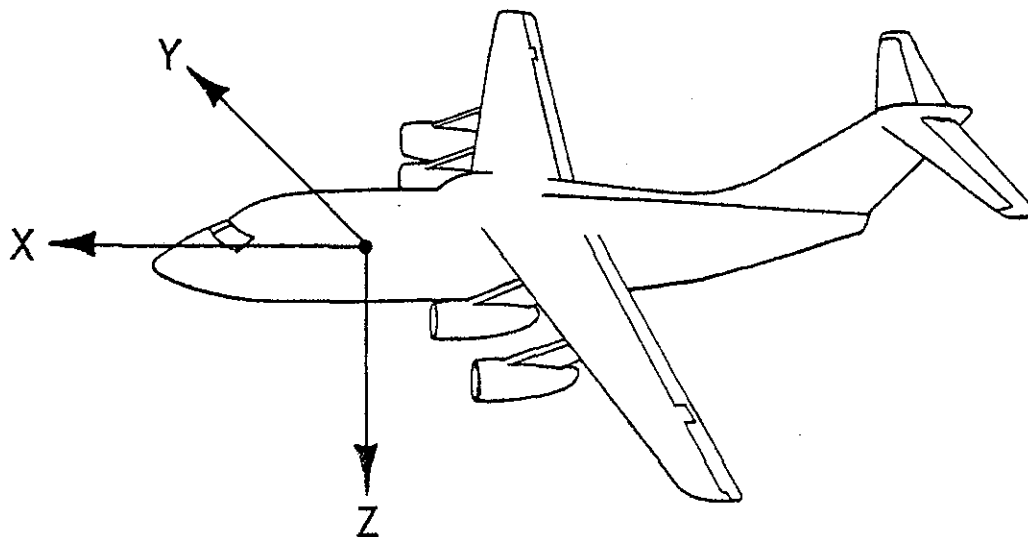


Fig. 1-1 AXIS ORIENTATION

Rotations about the z axis in Fig. 1-1 result in yaw deviations (ψ) and in new components (H'), as shown by

$$\begin{bmatrix} Hx' \\ Hy' \\ Hz' \end{bmatrix} = \begin{bmatrix} \cos \psi & \sin \psi & 0 \\ -\sin \psi & \cos \psi & 0 \\ 0 & 0 & 1 \end{bmatrix} \begin{bmatrix} Hx \\ Hy \\ Hz \end{bmatrix} \quad (1-1)$$

Similarly, independent rotations about the y axis and the x axis result in pitch (θ) and roll (ϕ) dependent variations in the measured H components, as shown by

$$\begin{bmatrix} Hx' \\ Hy' \\ Hz' \end{bmatrix} = \begin{bmatrix} \cos \theta & 0 & -\sin \theta \\ 0 & 1 & 0 \\ \sin \theta & 0 & \cos \theta \end{bmatrix} \begin{bmatrix} Hx \\ Hy \\ Hz \end{bmatrix} \quad (1-2)$$

$$\begin{bmatrix} Hx' \\ Hy' \\ Hz' \end{bmatrix} = \begin{bmatrix} 1 & 0 & 0 \\ 0 & \cos \phi & \sin \phi \\ 0 & -\sin \phi & \cos \phi \end{bmatrix} \begin{bmatrix} Hx \\ Hy \\ Hz \end{bmatrix} \quad (1-3)$$

The effect of a combined rotation can be expressed by using the product of the transformation matrices. In addition, if the rotations are small, the total rotation experienced by applying sequential rotations is independent of the order in which the rotations are performed [Ref. 1-3,1-4].

$$\begin{bmatrix} Hx' \\ Hy' \\ Hz' \end{bmatrix} = \begin{bmatrix} \cos \psi & \sin \psi & 0 \\ -\sin \psi & \cos \psi & 0 \\ 0 & 0 & 1 \end{bmatrix} \begin{bmatrix} \cos \theta & 0 & -\sin \theta \\ 0 & 1 & 0 \\ \sin \theta & 0 & \cos \theta \end{bmatrix}$$

$$\begin{bmatrix} 1 & 0 & 0 \\ 0 & \cos \phi & \sin \phi \\ 0 & -\sin \phi & \cos \phi \end{bmatrix} \begin{bmatrix} Hx \\ Hy \\ Hz \end{bmatrix} \quad (1-4a)$$

$$\begin{bmatrix} Hx' \\ Hy' \\ Hz' \end{bmatrix} = \begin{bmatrix} \cos \psi \cos \theta & \sin \psi \cos \phi + \sin \theta \cos \psi \sin \theta \\ -\sin \psi \cos \theta & \cos \psi \cos \phi - \sin \phi \sin \psi \sin \theta \\ \sin \theta & -\cos \theta \sin \phi \end{bmatrix}$$

$$\begin{bmatrix} \sin \phi \sin \psi - \sin \theta \cos \psi \cos \phi \\ \cos \psi \sin \phi + \sin \psi \sin \theta \cos \phi \\ \cos \phi \cos \theta \end{bmatrix} \begin{bmatrix} Hz \\ Hy \\ Hz \end{bmatrix} \quad (1-4b)$$

Assume that the angular variations θ , ψ , and ϕ are small enough so that the small angle approximations

$$\begin{aligned}\sin \theta &\approx \theta, \sin \psi \approx \psi, \sin \phi \approx \phi, \\ \cos \theta &\approx \cos \psi \approx \cos \phi \approx 1\end{aligned}$$

can be made. Then, if the products of small angles (in radians) can be assumed to be much smaller than the angles alone, the expression reduces to

$$\begin{bmatrix} Hx' \\ Hy' \\ Hz' \end{bmatrix} = \begin{bmatrix} 1 & \psi & -\theta \\ -\psi & 1 & \phi \\ \theta & -\phi & 1 \end{bmatrix} \begin{bmatrix} Hx \\ Hy \\ Hz \end{bmatrix} \quad (1-5)$$

Further modifications in the form of the matrices result in

$$\begin{bmatrix} Hx' \\ Hy' \\ Hz' \end{bmatrix} = \begin{bmatrix} -Hz & Hy & 0 \\ 0 & -Hx & Hz \\ Hx & 0 & -Hy \end{bmatrix} \begin{bmatrix} \theta \\ \psi \\ \phi \end{bmatrix} + \begin{bmatrix} Hx \\ Hy \\ Hz \end{bmatrix} \quad (1-6)$$

By subtracting, we arrive at an expression for the difference in H components as functions of angular deviation.

$$\begin{bmatrix} Hx' \\ Hy' \\ Hz' \end{bmatrix} - \begin{bmatrix} Hx \\ Hy \\ Hz \end{bmatrix} = \begin{bmatrix} \Delta Hx \\ \Delta Hy \\ \Delta Hz \end{bmatrix} = \begin{bmatrix} -Hz & Hy & 0 \\ 0 & -Hx & Hz \\ Hx & 0 & -Hy \end{bmatrix} \begin{bmatrix} \theta \\ \psi \\ \phi \end{bmatrix} \quad (1-7)$$

It is significant to note at this point that the transformation matrix is singular implying that solutions for θ , ψ , and ϕ are not independently available.

1-3 ATTITUDE DETERMINATION EMPLOYING MAGNETIC FIELD COMPONENTS

A given orthogonal set of three unit vectors can be displaced in Euclidean space by rotating the system through any angle δ about a directed rotation axis. It is also customary to represent this rotation vectorially as a directed line segment whose length is proportional to the rotation angle. This rotation is analogous to the rotation experienced by the body fixed frame of Fig. 1-1 as the aircraft experiences combined pitch, yaw, and roll variation. During flight the body fixed set rotates about this rotation axis assuming new (possibly erroneous) attitudes in space. The task of the attitude sensing system is to provide measures of compounded pitch, yaw, and roll that would result in the same attitude assuming that the rotations occurred sequentially about the x, y and z axes rather than the actual rotation axis.

It was shown in the previous section that a compounded rotation of an orthogonal set can be described by a product of respective transformation matrices. Additionally it was noted that for small angular rotations the order of multiplication is unimportant. Using the relationships of (1-7), expressions for the angular deviations in terms of measured magnetic vector components can be derived.

$$\Delta H_x = -H_z\theta + H_y\psi \quad (1-8a)$$

yields

$$\theta = (H_y\psi - \Delta H_x)/H_z \quad (1-8b)$$

$$\psi = (\Delta H_x + H_z\theta)/H_y \quad (1-8c)$$

Similarly,

$$\Delta H_y = -H_x \psi + H_z \phi \quad (1-9a)$$

yields

$$\psi = (H_z \phi - \Delta H_y) / H_x \quad (1-9b)$$

$$\theta = (\Delta H_y + H_x \psi) / H_z \quad (1-9c)$$

and

$$\Delta H_z = H_x \theta - H_y \phi \quad (1-10a)$$

yields

$$\theta = (\Delta H_z + H_y \phi) / H_x \quad (1-10b)$$

$$\phi = (H_x \theta - \Delta H_z) / H_y \quad (1-10c)$$

Assuming that H_x , H_y and H_z are nominal vector components as measured in a reference attitude and that H_x' , H_y' and H_z' are new field components at the new attitude, then $\Delta H_x = H_x' - H_x$, $\Delta H_y = H_y' - H_y$, $\Delta H_z = H_z' - H_z$ are expressions of the incremental changes in field components. Additionally, before using (1-8), (1-9) or (1-10) to solve for attitude variations (pitch, yaw, or roll), one additional angle from an auxiliary sensor² must be supplied. Using one additional angle of rotation (about any one axis) the remaining two rotations can then be calculated.

To illustrate this point, flight data acquired during the flight of a NASA flown Convair 900 instrumented with a three-axis magnetometer and a Litton inertial navigation system were used to calculate roll, pitch, and yaw.

²It was noted following (1-7) that a unique solution for attitude variation is not possible using magnetic field data alone.

Attitude variation about each of the three axes was calculated using measured magnetic field components supported by one angle from the inertial system. The results of these calculations are plotted in Figs. 1-2 through 1-4.

It is significant to note that the rotations shown occurred simultaneously (i.e., time base is the same for all three figures). The flight was at an altitude of approximately 5000 ft at an airspeed of approximately 250 nmi/h.

Although the data used to plot the attitudes shown in Figs. 1-2 through 1-4 were not acquired specifically for this purpose, the correlations in measured and calculated attitude clearly show that; within the limits of instrument accuracy, signals proportional to attitude variation can be derived using flight data.

1-4 A POSSIBLE SYSTEM CONFIGURATION

Since the intent of this chapter is to introduce the notion that magnetometer technology has advanced to the point where three-axis magnetometers can be incorporated in aircraft attitude sensing systems on a cost effective basis, the system discussion will be limited in scope to describing a possible combined heading and attitude measurement method.

Heading references fall into three classes; 1) those that depend on the Earth's magnetic field, 2) those that depend on the use of low-drift gyroscope to retain a preset azimuth, and 3) those (gyrocompasses) that depend on sensing the Earth's rotation [Ref.1-5]. By far the greatest number of aircraft heading systems depend on the Earth's magnetic field, although many of these include gyroscopes to improve the performance characteristics.

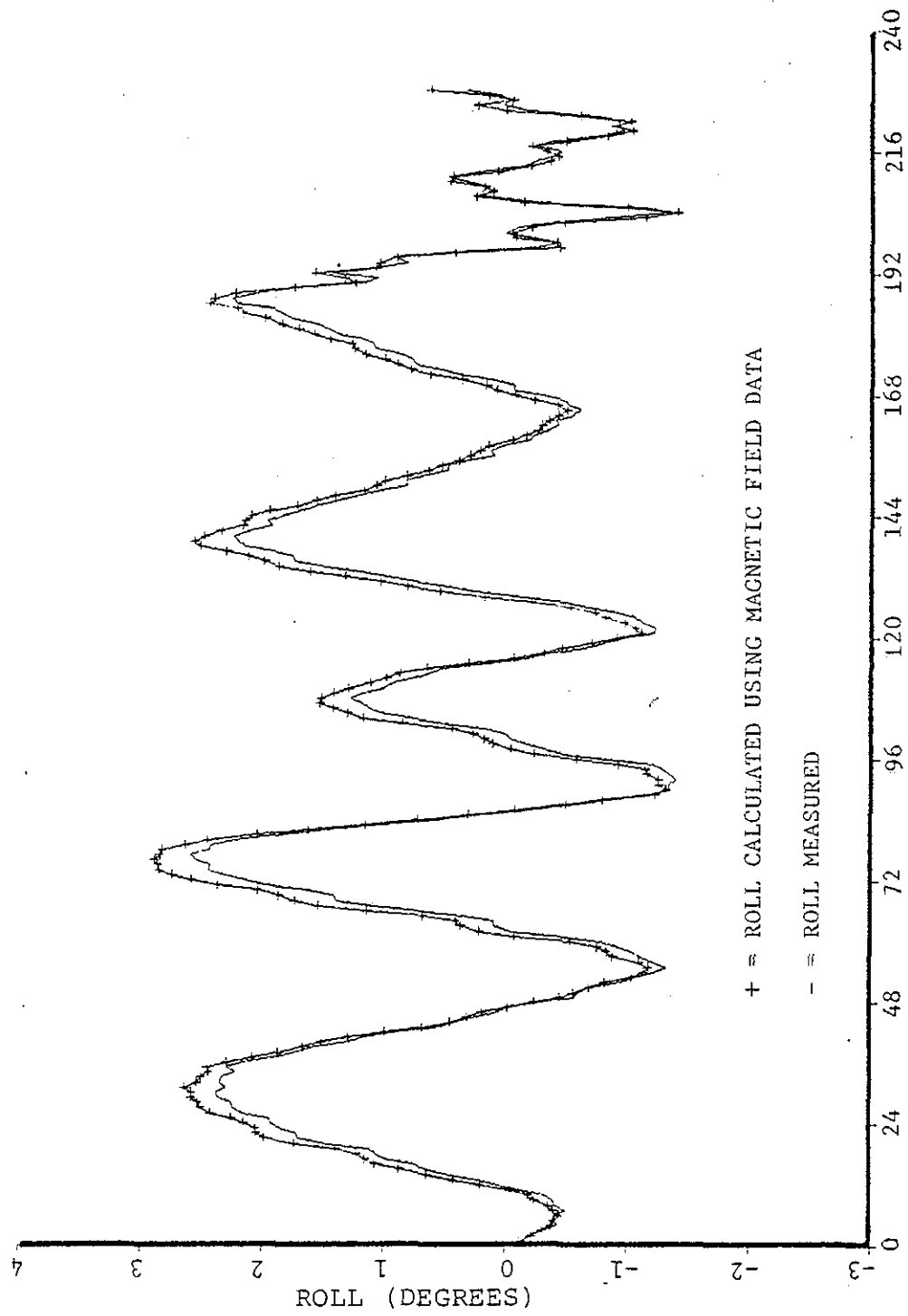


FIGURE 1-2 ROLL AXIS

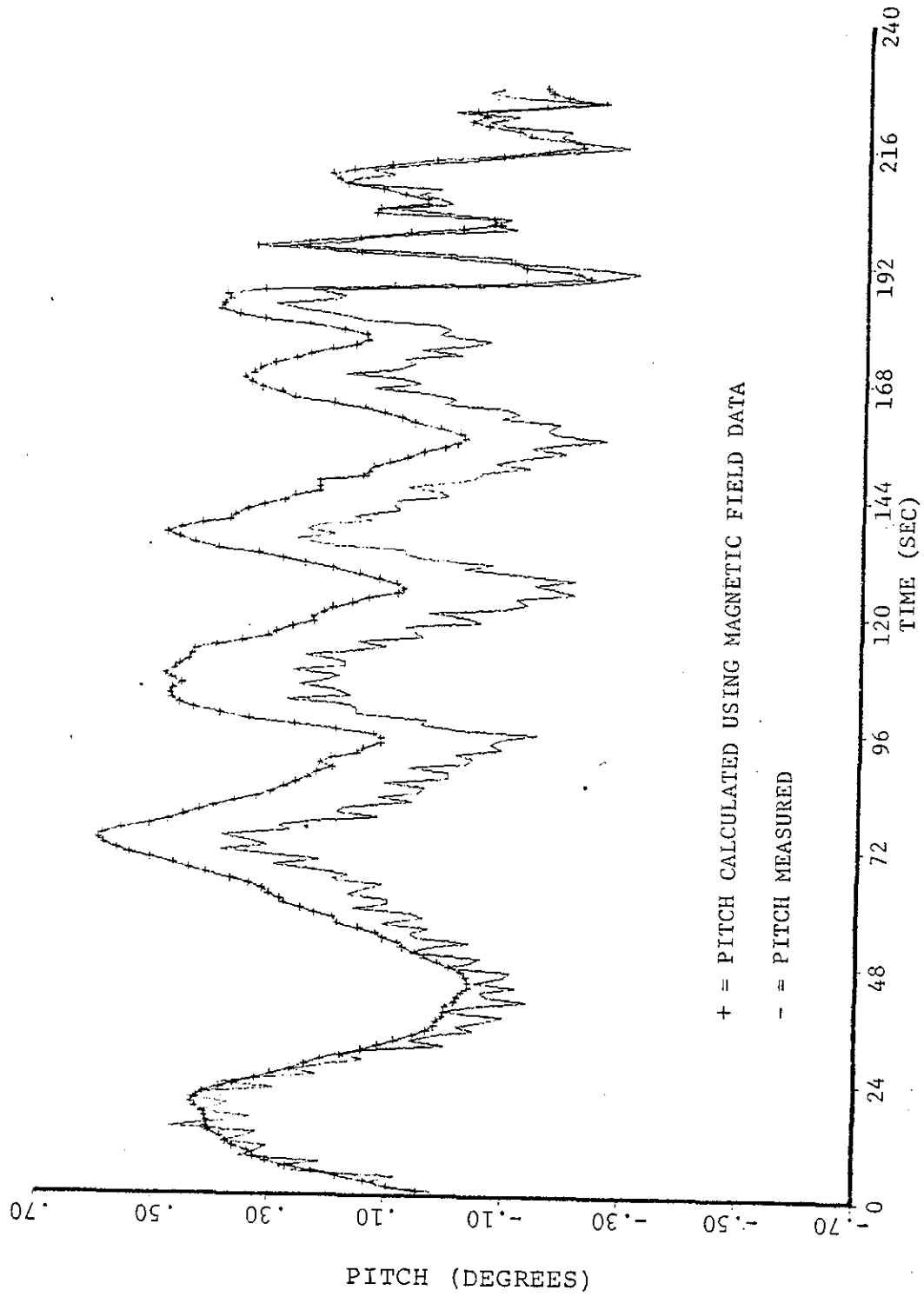


FIGURE 1-3 PITCH AXIS

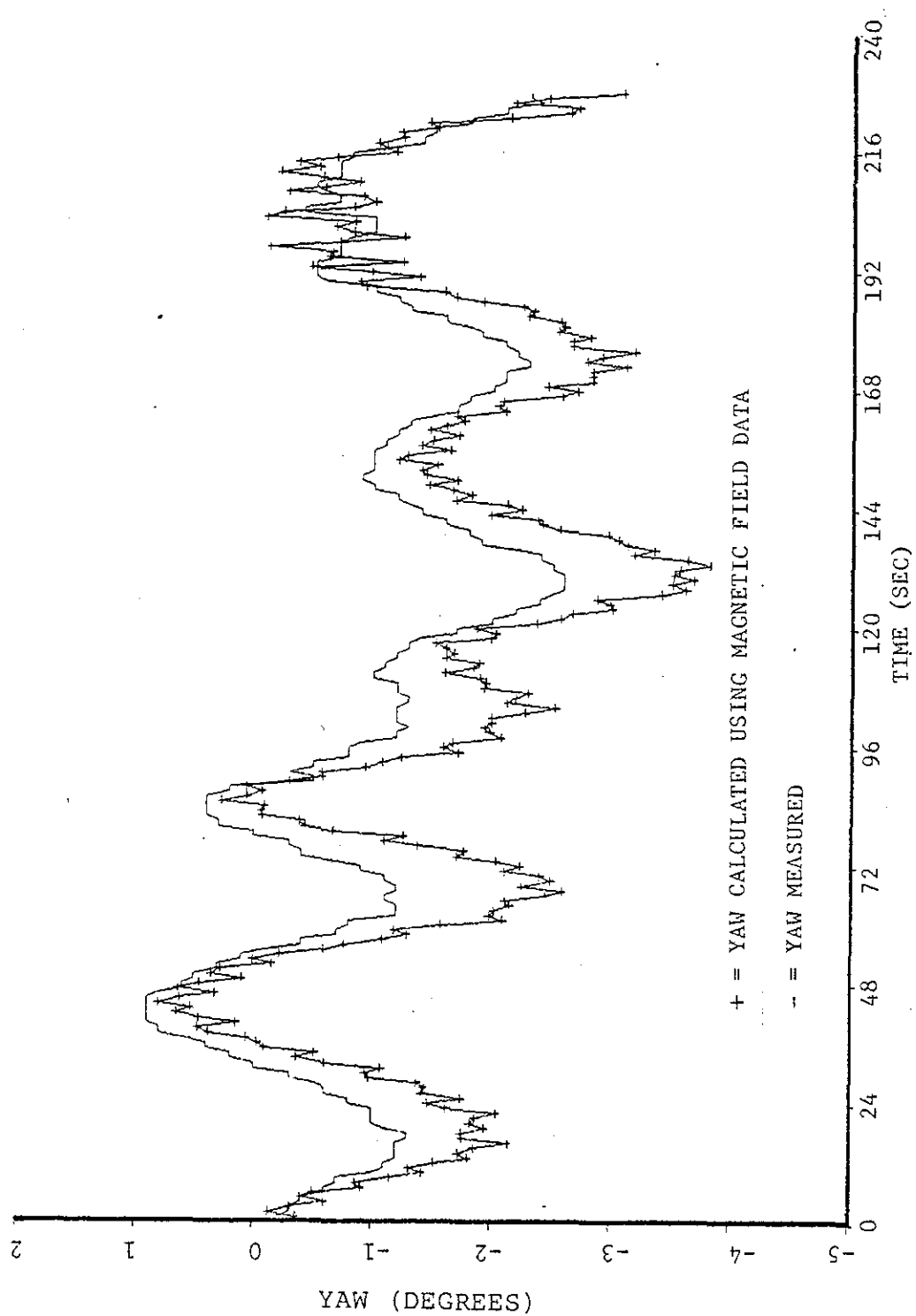


FIGURE 1-4 YAW AXIS

A popular system combination (with no gyro) is to combine a pendulous remote magnetic sensor and a synchro receiver in a null seeking circuit. The philosophy being to attempt to measure only the horizontal component of the Earth's magnetic field and to swing the receiver into alignment with it. Under acceleration, departures of the sensor unit from the horizontal result in angular heading errors ϵ [Ref. 1-5].

$$\epsilon = (aH/g) \tan \gamma \sin \theta$$

where aH is the horizontal acceleration, g is the acceleration due to gravity, θ is the angle between the acceleration vector and magnetic north, and γ is the magnetic field dip angle; $\arctan$ (vertical field/horizontal field).

Accuracy of this system can be improved by incorporating a strapped-down solid state magnetic sensing unit (free of acceleration errors) that measures and displays the angle of the Earth's horizontal magnetic component relative to the aircraft. This system can be implemented as follows:

1) Determine the direction of the magnetic vector F relative to the sensors (and the airframe), by measuring the x , y and z components (Figs. 1-1 and 1-5). The direction cosines $\cos \alpha$, $\cos \beta$, $\cos \gamma$ are the cosines of the angles α , β , γ between the magnetic vector and the positive x , y and z axes. Additionally,

$$\cos \alpha = x/(x^2 + y^2 + z^2)^{\frac{1}{2}}$$

$$\cos \beta = y/(x^2 + y^2 + z^2)^{\frac{1}{2}}$$

$$\cos \gamma = z/(x^2 + y^2 + z^2)^{\frac{1}{2}}$$

- 2) Using either a vertical reference³ or knowledge of aircraft attitude, we can effectively rotate the body axes such that the x-y plane is horizontal (see Chapter II).
- 3) Simple application of direction cosines will yield the direction of magnetic north in the aircraft's x-y plane.

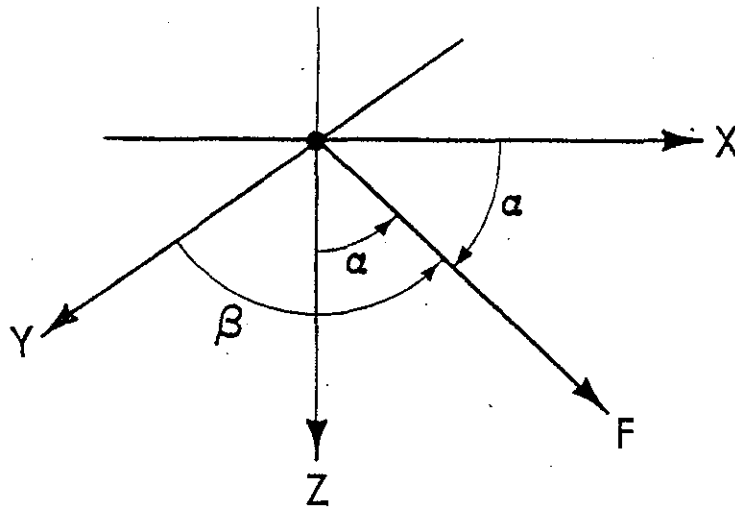


Fig. 1-5 FIELD VECTORS AND DIRECTION COSINES

Although the preceding discussion implies that heading can be determined by using a strapped-down magnetometer, there remains the problem of attitude determination. Another widely used system for obtaining a heading reference

³Not necessarily derived inertially [Ref. 1-11].

is to combine the relatively excellent short term stability of a directional gyroscope with the long term stability of magnetic field measurements. By slaving the directional gyroscope to the magnetic field [Ref. 1-5, sec. 10.4.7], gyroscopes with relatively large free drift error can be used to provide an excellent heading reference.

Replacement of the pendulous remote sensing unit of this type of system with a strapped-down vector magnetometer would result in both heading and attitude information on a continuous basis. This combination would operate as follows:

- 1) The system is initialized by determining a reference attitude (perhaps by using a primary inertial attitude system).
- 2) The angular position of the horizontal magnetic field component is computed as above and used to slave the directional gyroscope.
- 3) The directional gyroscope, with relatively good short term stability (devices with free drift of less than 0.5 deg/h have been designed), is used to determine yaw (ψ) errors.
- 4) For small angle deviations, (1-8), and (1-9), and (1-10) can be employed to recalculate aircraft attitude. The process loops back to step 2) closing the loop on a combined attitude and heading reference system.

The sampling frequency required to maintain an acceptable level of error is of course determined by the aircraft performance expected (angular rates) and by the gyro error (drift rate plus errors due to additional sources such as

gyroscope tilt from vertical). The overall system is such that heading can be determined as before with errors due to sensor departures from horizontal substituted for long term accumulation of attitude uncertainty (this can be corrected by looping to step 1) at a frequency dependent on error rates). Additionally one gains measurements of attitude with minimal computation and replacement of a mechanical remote sensing unit with a solid state strapped-down magnetometer sensor.

1-5 OTHER CONSIDERATIONS

The characteristics of the Earth's magnetic field and its variations have long been established [Ref. 1-6-1-10]. Since the field is to be used as a reference in the attitude measurement scheme, there is a need here to discuss its adverse characteristics. Although the field does experience variation, most of the variation is either in amplitude (ionospheric contributions) or has time constants that make the variation negligible (secular variation).

In traversing local anomalies, there will, however, be deflections in the ambient field due to the additive effect of local dipoles or monopoles. The effect of local terrain caused anomalies can be visualized by picturing the main field vector oriented in space with a second modulating vector rotating at its tip. Maximum angular error would occur when this modulating vector has maximum magnitude and is positioned at right angles to the main vector.

To illustrate the effect of local anomalies one can calculate the level of anomaly required to cause an error. Since the Earth's main field is typically in the order of 0.50 G it is readily apparent that a local anomaly of approximately 0.01 G at right angles to the local field is

required to cause an error of 1 deg. Furthermore, the local anomaly would have to be aligned with one of the aircraft body axes to result in one degree of attitude error in any one axis. Fortunately, anomalies with components of this magnitude positioned at right angles to the main field are extremely rare. In addition, the anomalies are localized over ore bodies or other geophysical irregularities, have magnitudes that diminish as the cube of altitude, and tend to average to zero over relatively short distances. In summary, the probability of encountering an anomaly that would cause as much as a 1 degree error is relatively small. The error, if introduced, will be short lived and, unlike drift error, will average to zero.

Fundamental to a magnetic field referenced system is the ability to measure orthogonal components of the field vector. Precision and accuracy of measurement of the components is of course specified by the desired control specifications.

Since the Earth's magnetic field varies in magnitude on a global basis between 0.3 G and 0.6 G (30,000 gamma to 60,000 gamma), it is apparent that full scale measurements of 0.6 G can be expected. Sensors mounted at right angles to the field will monitor no measureable field and thus define the lower limit of measurement to be zero. For the continental United States the declination varies between 60 and 80 deg, resulting in a range in horizontal component of 0.15 to 0.25 G with vertical component in the range of 0.4 to 0.55 G. Heading variations (yaw) result in changes of the horizontally sensed field components and would specify the maximum precision required. In addition, flight at $45 \text{ deg} \pm (n \times 90 \text{ deg})$ (where n is any whole number) with respect to magnetic north results in minimum sensitivity of the x and y

axes measurements. In this case sensor inputs would range between 0.106 and 0.177 G with minimum field at the north. Assuming the preceding ambient measurements, variations in component magnitude of approximately 0.0180 to 0.0305 G/deg for small angle variations can be expected.

A brief survey of commercial magnetometer manufacturers reveals that triaxial magnetometers that measure from zero to 0.6 G with linearities of 0.5 percent, noise less than ± 1 mG and sensitivities of at least 2.5 V per 600 mG are currently available. In addition, these devices have a bandwidth of direct current to at least 500 Hz and are rated to have less than 1 deg error in orthogonality.

From a precision standpoint, it is apparent that variations in yaw for this worst case situation can be sensed to better than 0.1 deg with currently available magnetometer technology. The sensor technology required to implement an attitude sensing system of reasonable specifications is available (more detailed analysis is presented in Chapter III).

Although the preceding calculations indicate that for small angular variations attitude can be calculated using measured magnetic data, there is a need to consider the effects of larger finite rotations. In this case the small angle assumptions would not be valid and an Euler transformation would have to be made. Measurement of three axes of field components could be used to develop the direction cosines required to determine the orientation of the axis of rotation, the angular rotation about it, and the three angular rotations of pitch, roll, and yaw.

For the special case where the axis of rotation aligns with the magnetic vector, there would of course be no

measured component changes.⁴ By measuring the attitude of a second vector (not in alignment with the magnetic vector), we could resolve the ambiguous situation cited above and provide additional redundancy.

The optimum auxiliary vector would be one that could be sensed without using inertial devices. The Earth's electric field can be considered. The main reason for considering this field as a means of providing an auxiliary angular reference is that the resultant system has the potential of being completely solid state. The electric field vector can be used to determine attitude variation in a manner analogous to the magnetic vector system. Inherent limitations of each single vector system can be obviated if the vectors are not coincident.

Although Hill [Ref. 1-11] reported success in controlling pitch and roll using the electrostatic field alone, comments by Markson [Ref. 1-12] indicate that the electrostatic field is not always a reliable vertical reference. Employment of the electrostatic field for this attitude measurement system is limited to augmenting the magnetic field measurements by eliminating ambiguity of motion around the magnetic vector. The requirement of vertical electrostatic field is thus removed and replaced by a requirement that the field direction is relatively stable.

By using two independently derived vectors we have sufficient data to obviate the ambiguity just cited and we have the potential of providing redundancy as well.

⁴An example of this would be yaw rotation while flying straight and level over the magnetic poles or roll rotation while flying towards a pole at the magnetic equator.

1-6 CONCLUSION

This chapter has identified a novel method of measuring aircraft attitude using relatively inexpensive, well developed instrumentation. It has recognized that magnetic field sensing systems have been used to some extent in attitude sensing and control of space vehicles; it has also suggested, however, that with appropriate support, magnetometers can find increased application in aircraft attitude measurement systems.

This claim is corroborated by actual flight test data. Magnetometers have evolved to a point where three axis measurements of the Earth's magnetic field can be made with sufficient precision and accuracy to enable measurement of small angle attitude variations.

This chapter has also discussed a possible system configuration combining heading determination and attitude measurement functions. By replacing the conventional remote sensing unit with a three-axis magnetometer, it has been suggested that both functions can be obtained with the hardware required previously for heading measurement alone.

As with any system, there are limitations imposed. The main limitation for a vector magnetometer system seems to be the inability to sense rotations around the magnetic vector itself. This problem is not unlike the ambiguity experienced by magnetic heading systems at high latitudes. By judiciously incorporating auxiliary instruments, not only can the ambiguities be removed but a degree of redundancy can be added while still maintaining a cost and weight advantage over comparable systems.

CHAPTER II

AN ATTITUDE INDEPENDENT REMOTE MAGNETIC INDICATOR

2-1 INTRODUCTION

Preliminary investigation [Ref.2-1] revealed that aircraft attitude can be calculated using measurements of earth's magnetic field vector and a single auxiliary rotation angle. An algorithm to compute the two remaining aircraft rotational angles was developed. Using flight data, it was demonstrated that an excellent correlation in computed versus actual aircraft attitude could be achieved. In addition to providing measurements of the magnetic field for redundant attitude computations (to improve accuracy and reliability of existing autopilot systems), it was noted that the vector magnetometer could substitute for the remote magnetic sensing unit. In this manner both heading and attitude measurements could be derived using common elements with obvious benefits in weight and cost.

This chapter discusses the mechanization of a microprocessor based computer system that uses a three axis magnetometer plus gyro data to compute heading. The magnetometer is a three axis solid state device that can be mounted in a strapped down configuration resulting in an attitude independent remote magnetic indicator. Gyro measurements of pitch and roll angle plus three axis magnetic measurements are used by the algorithm to compute aircraft heading. The system can function independently to compute heading or by simply increasing the stored program could implement the attitude computing algorithm of [Ref. 2-1] as well.

The chapter proceeds by developing an algorithm to compute aircraft heading using the strapped down magnetometer

and two gyro measured angles. Practical aspects of designing the system including both hardware and software are then presented. In addition, the limitations in instrument accuracy and operation as determined by sensor errors, signal processing errors, arithmetic precision and computation speed are discussed. Considerable computational capability inherent in the system enables minimization of systematic errors. It is demonstrated that inexpensive sensors can be employed with offset and orthogonality errors compensated by microprocessor programming. Finally, it is concluded that a microprocessor based computer with a solid state magnetometer can play a significant role in aircraft instrumentation.

2-2 AN ALGORITHM TO COMPUTE AIRCRAFT HEADING

Coordinate frames are usually defined by orthogonal right-hand sets of three unit vectors. An example of such a set is illustrated in Fig. 1-1 where the orientation of the body fixed frame used in this chapter is delineated. The reference coordinate frame referred to in this chapter is oriented with axes x and y in the horizontal plane and axis z vertical (z down is positive). Pitch attitude angle (θ) of an aircraft is defined [Ref. 2-2] as the angle between some preferred longitudinal axis and the horizontal reference. In this chapter, pitch angle is the angle between the x axis of the aircraft and the x - y plane of the reference axis set. Since angular rotations are conventionally defined as rotations in the plane normal to a unit vector with the positive sense of rotation defined by the right-hand rule [Ref. 1-2], we will define positive pitch angle (θ) as the "nose up" or positive rotation about the y axis when the y axis is horizontal. The roll and yaw angles (ϕ and ψ) will then simply be rotations about the x and y axes respectively.

By aligning the three magnetometer axes with the respective x, y and z axes of the aircraft, we can measure magnetic field components of the aircraft at any attitude. For the trivial case where pitch (θ) and roll (ϕ) are both zero degrees, Hx and Hy are the horizontal field components and we can compute yaw from the horizontal vectors as follows:

$$\psi_1 = \cos^{-1}(H_x / (H_x^2 + H_y^2)^{\frac{1}{2}}) \quad (2-1a)$$

or

$$\psi_1 = \sin^{-1}(H_y / (H_x^2 + H_y^2)^{\frac{1}{2}}) \quad (2-1b)$$

We select either (2-1a) or (2-1b) based on the relative magnitudes of Hx and Hy. By minimizing the numerator of the argument we guarantee that the inverse trigonometric operation results in an angle between zero and forty-five degrees with maximum sensitivity ensured. Heading is then computed using the signs of Hx and Hy to select the appropriate equation from Table 2-1.

Hx Hy	NEGATIVE	POSITIVE
	Negative $\psi = 180 - \psi_1$	Positive $\psi = \psi_1$
	Positive $\psi = \psi_1 + 180$	Negative $\psi = 360 - \psi_1$

Table 2-1. Formulae to Compute Heading

For most cases, the pitch and roll angles are not zero and inverse rotations are required to determine the actual horizontal field components Hx and Hy. Since any aircraft attitude can be represented as a sequence of rotations about each axis beginning at some reference attitude, we can

determine the reference Hx and Hy field components by performing an inverse roll followed by an inverse pitch computation¹.

The inverse roll computation can be developed by considering vector components of an arbitrary vector $\bar{H}$ in Fig. 2-1. The first set (x_2, y_2, z_2) represents the vector components measured in a reference orientation. The second set has common origin and aligns with common x axis component. It is rotated (rolled) about the x axis resulting in new y and z values. We can describe vector $\bar{H}$ in both coordinate frames as

$$\bar{H} = x_2 \cdot \hat{i}_2 + y_2 \cdot \hat{j}_2 + z_2 \cdot \hat{k}_2 \quad (2-2)$$

and

$$\bar{H} = x_3 \cdot \hat{i}_3 + y_3 \cdot \hat{j}_3 + z_3 \cdot \hat{k}_3 \quad (2-3)$$

Since the vector $\bar{H}$ is unique, we note that equations (2-2) and (2-3) are equal. Furthermore if we form dot products we solve for the horizontal components x_2, y_2 , and z_2 in terms of the rotated values and the roll angle (ϕ).

From (2-2) we obtain

$$\bar{H} \cdot \hat{i}_2 = x_2(\hat{i}_2 \cdot \hat{i}_2) + y_2(\hat{j}_2 \cdot \hat{i}_2) + z_2(\hat{k}_2 \cdot \hat{i}_2) \quad (2-4a)$$

$$\bar{H} \cdot \hat{i}_2 = x_2 \quad (2-4b)$$

and from (2-3) we obtain

$$\bar{H} \cdot \hat{i}_2 = x_3(\hat{i}_3 \cdot \hat{i}_2) + y_3(\hat{j}_3 \cdot \hat{i}_2) + z_3(\hat{k}_3 \cdot \hat{i}_2) \quad (2-5a)$$

$$\bar{H} \cdot \hat{i}_2 = x_3 \quad (2-5b)$$

¹Since pitch is defined as the angle between the x axis and the horizontal plane we can assume that at any heading, aircraft attitude results due to a pitch followed by a roll.

then

$$x_2 = x_3 \quad (2-6)$$

Similarly,

$$\bar{H} \cdot \hat{j}_2 = y_2 = x_3(\hat{i}_3 \cdot \hat{j}_2) + y_3(\hat{j}_3 \cdot \hat{j}_2) + z_3(\hat{k}_3 \cdot \hat{j}_2) \quad (2-7a)$$

$$y_2 = y_3 \cos \phi - z_3 \sin \phi \quad (2-7b)$$

and

$$\bar{H} \cdot \hat{k}_2 = z_2 = x_3(\hat{i}_3 \cdot \hat{k}_2) + y_3(\hat{j}_3 \cdot \hat{k}_2) + z_3(\hat{k}_3 \cdot \hat{k}_2) \quad (2-8a)$$

$$z_2 = y_3 \sin \phi + z_3 \cos \phi \quad (2-8b)$$

These expressions can be summarized as

$$\begin{bmatrix} x_2 \\ y_2 \\ z_2 \end{bmatrix} = \begin{bmatrix} 1 & 0 & 0 \\ 0 & \cos \phi & -\sin \phi \\ 0 & \sin \phi & \cos \phi \end{bmatrix} \cdot \begin{bmatrix} x_3 \\ y_3 \\ z_3 \end{bmatrix} \quad (2-9)$$

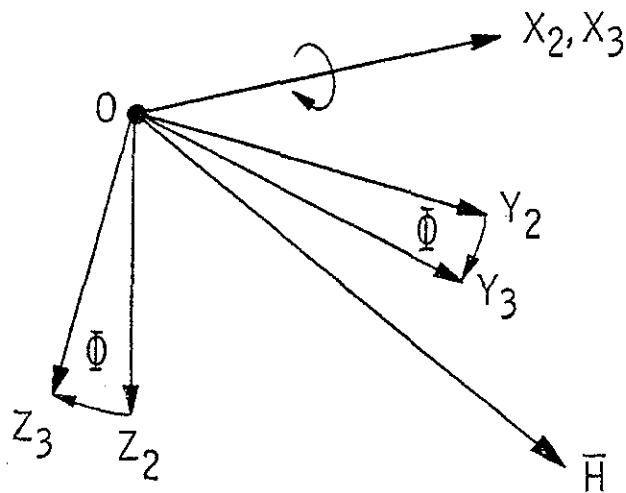


Fig. 2-1 AXES ROTATED IN ROLL

Similarly, considering an axis set rotated in pitch as shown in Fig. 2-2, we can express the reference set x_1, y_1, z_1 in terms of the rotated set x_2, y_2, z_2 as follows

$$\begin{bmatrix} x_1 \\ y_1 \\ z_1 \end{bmatrix} = \begin{bmatrix} \cos \theta & 0 & \sin \theta \\ 0 & 1 & 0 \\ -\sin \theta & 0 & \cos \theta \end{bmatrix} \cdot \begin{bmatrix} x_2 \\ y_2 \\ z_2 \end{bmatrix} \quad (2-10)$$

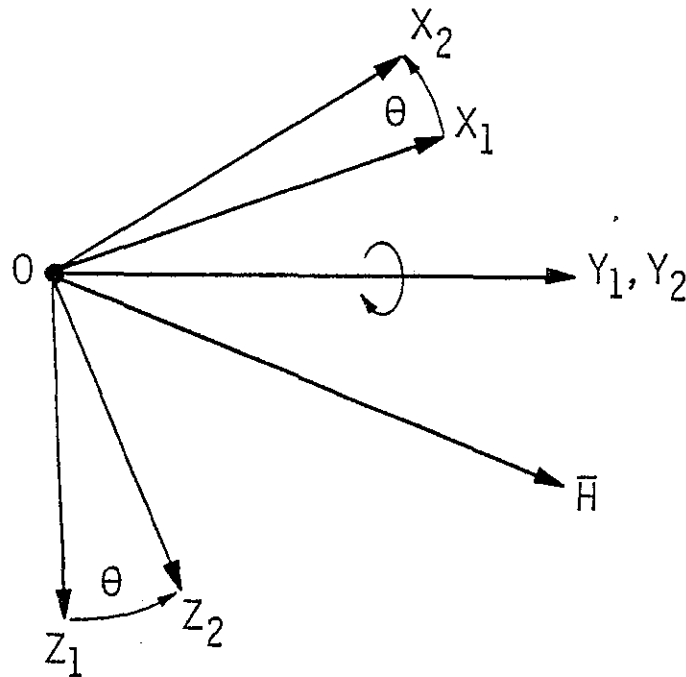


Fig. 2-2 AXES ROTATED IN PITCH

Finally, if we assume that the axis set subscripted with ³ represents components of Earth's magnetic vector measured at an arbitrary aircraft attitude, we can derive the magnetic components (H_{xh}, H_{yh}, H_{zh}) in the horizontal plane for a given heading

$$\begin{bmatrix} H_{xh} \\ H_{yh} \\ H_{zh} \end{bmatrix} = \begin{bmatrix} \cos \theta & 0 & \sin \theta \\ 0 & 1 & 0 \\ -\sin \theta & 0 & \cos \theta \end{bmatrix} \begin{bmatrix} 1 & 0 & 0 \\ 0 & \cos \phi & -\sin \phi \\ 0 & \sin \phi & \cos \phi \end{bmatrix} \cdot \begin{bmatrix} H_{x_3} \\ H_{y_3} \\ H_{z_3} \end{bmatrix} \quad (2-11a)$$

$$\begin{bmatrix} H_{xh} \\ H_{yh} \\ H_{zh} \end{bmatrix} = \begin{bmatrix} \cos \theta & (\sin \theta \sin \phi) & \sin \theta \cos \phi \\ 0 & \cos \phi & -\sin \phi \\ -\sin \theta & (\cos \theta \sin \phi) & \cos \phi \cos \theta \end{bmatrix} \cdot \begin{bmatrix} H_{x_3} \\ H_{y_3} \\ H_{z_3} \end{bmatrix} \quad (2-11b)$$

The algorithm to be implemented with the microprocessor would therefore require operations as outlined in Fig. 2-3. Details of programming method, modifications to the above equations to facilitate programming and computation speed versus accuracy tradeoffs are discussed in following sections.

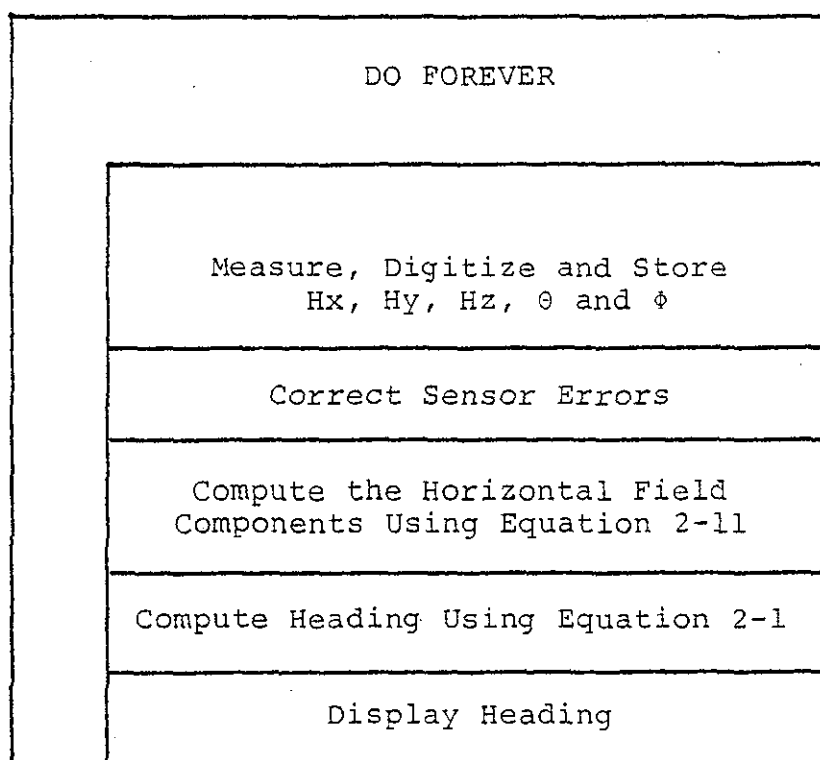


Fig. 2-3 LOGICAL OPERATIONS REQUIRED TO COMPUTE HEADING

2-3 MECHANIZATION OF THE HEADING ALGORITHM

A. General Considerations

To evaluate the performance of an integrated system experimentally, an instrument was designed to implement the algorithm developed above. Several approaches were considered to implement the heading instrument for experimentation:

1) A minicomputer implementation incorporating an HP-2100 minicomputer supported by peripheral interface and analog circuitry. Programming of the HP-2100 would have enabled the computer to control multiplexing and processing of sensor data as suggested by Parish and Lee [Ref. 2-3].

2) A hybrid system composed of a remote data acquisition system to collect data from sensors for subsequent processing by a computer (possibly an HP-2100).

3) A digital/analog electronic implementation incorporating the design of a special purpose computer to perform the required functions of a heading instrument.

The first two approaches were abandoned since it was desirable to perform the experiments at various locations remote from a computer facility and to have data available immediately without having to rely on off-line computations at a later date. The design task then evolved to the design of a special purpose computer system to implement the algorithm, provide a means for evaluating the performance of the proposed algorithm and to allow modifications to the system if required.

B. Design Criteria

Having decided on the general approach to implementing

the algorithm it became necessary to consider the performance criteria desired of the instrument.

1) Accuracy

As a design goal, an absolute accuracy of $\pm 1.0^\circ$ in heading uncertainty was selected for the laboratory implementation. This accuracy is compatible with commercially available heading systems.

2) Computation Speed

The bandwidth of the system is determined mainly by the computation speed of the computer². As a design goal, complete heading updates once per second was established.

3) Flexibility

A desirable feature of the laboratory evaluation instrument was considered to be flexibility. Revisions or additions to the algorithm as predicted by experimental data should be incorporated with minimal redesign of the instrument.

2-4 CONCLUSIONS

An instrument designed to implement the heading algorithm developed above uses a three axis magnetometer to measure magnetic field data in the vicinity of an aircraft. Since the magnetometer proposed is a solid state three axis fluxgate device and is permanently mounted in a strapped down configuration, the implementation results in an attitude independent

²The response times of the various sensors and analog circuitry are orders of magnitude greater than the desired one second sample interval.

remote magnetic indicator³.

Several factors will contribute to system inaccuracy. Although the major error sources can be evaluated mathematically (Chapter IV), there is a need to evaluate the implementation experimentally. Systematic errors that arise can be reduced by instrument computation. This capability (inherent with a computer based system) enables incorporation of less expensive sensors in the heading instrument with less concern with factors such as temperature regulation, sensor orthogonality and sensor offset⁴.

Since the algorithm can be implemented using a microprocessor as the major computer element, the resulting instrument will have inherent computation capability, be small in size and consume relatively little power. These factors make the instrument an ideal device for aircraft application where the need for redundant distributed processing capability is invaluable.

³Current remote magnetic indicators are pendulous and rely on gravity to enable measurements of the horizontal magnetic vector (not attitude independent).

⁴Assuming that the sensors have repeatable or measurable characteristics, algorithms can be developed to correct previously measured erroneous data.

CHAPTER III

DESIGN OF A MICROPROCESSOR BASED HEADING INSTRUMENT

3-1 INTRODUCTION

Progress in device and component technologies during the 1970's has led to an assortment of sophisticated integrated circuits (IC) devices [Ref. 3-1] which enable the design of instruments with a high degree of sophistication and accuracy. Of these devices, the microprocessor has to date been the most exploited component in industrial control and instrumentation applications [Ref. 3-2 through 3-7]. There have been many papers presented addressing the general application and feasibility of applying microcomputers to particular design tasks [Ref. 3-8 through 3-21].

Although much of the literature to date on microprocessors has addressed the design of commercial products (usually the final result of a carefully orchestrated effort beginning with a market survey), the design of a laboratory instrument for algorithm evaluation differs in design philosophy. In particular, the laboratory instrument is designed to evaluate a proposed algorithm under laboratory conditions. The traditional benchmark evaluations and attempts to match the microprocessor to the application is not only difficult but unnecessary. If the processor is much more powerful than necessary, the "overkill" is little noticed; but if an insufficiently endowed microprocessor is selected, the effects can be devastating. Not only will the program be difficult to write and voracious of memory, it would be difficult to change to a more powerful microprocessor part way through the project. With these considerations in mind, a general purpose, flexible microprocessor with powerful architecture and instruction set the Signetics 2650 microprocessor [Ref. 3-22] was selected.

3-2 HARDWARE DESIGN CONSIDERATIONS

The design of a microprocessor based system begins by considering the total system level block diagram to be implemented (Fig. 3-1). Inputs from five sensors including x, y and z axis magnetic data plus pitch and roll angles (H_x , H_y , H_z , θ and ϕ) are to be multiplexed, sequentially sampled and converted to a digital representation prior to processing (executing the algorithm developed above). The main subsystem of Fig. 3-1, the central processing unit (CPU), operates under control of instructions stored in the system memory and interfaces with the input and output subsystems via data ports.

At this early stage in the design, it is significant to note that the block diagram of Fig. 3-1 differs slightly from that of a classical discrete hardware solution. The input subsystem (composed of analog multiplexer, sample and hold, and analog to digital converter) differs from a conventional data acquisition in that it is devoid of a control section. The microprocessor will control the data acquisition sampling and conversion in addition to performing the arithmetic function associated with the algorithm.

Having established a tentative block diagram of the instrument, the design continues by addressing relevant characteristics and limitations of each subsystem. These characteristics will then in turn be considered in configuring the final system and program to be executed.

1) The Analog Subsystem

Composed of the analog multiplexer, sample/hold and analog to digital converter, the analog subsystem of Fig. 3-1 affects both system accuracy and throughput rate. The

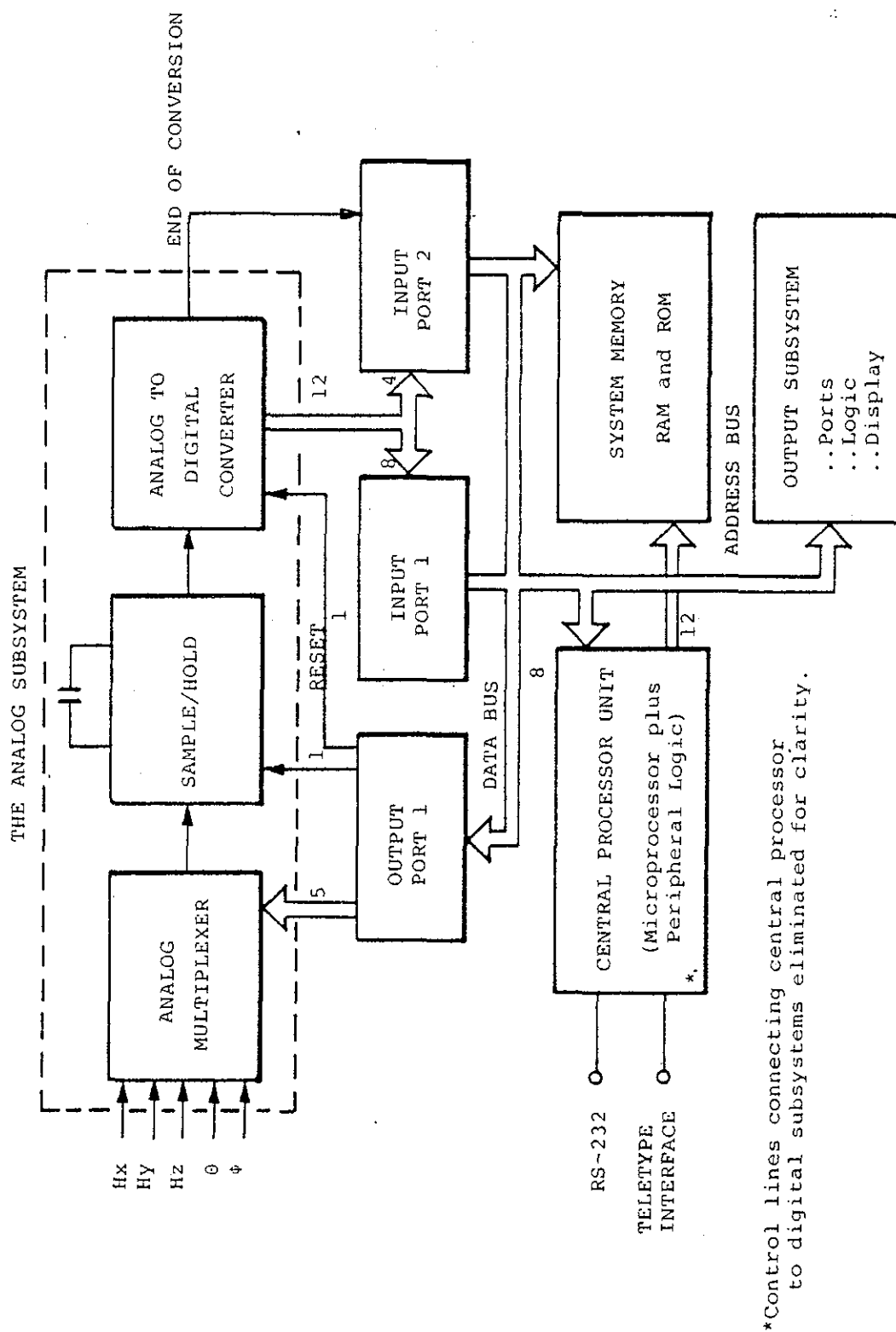


Fig. 3-1. SYSTEM BLOCK DIAGRAM

well-known Shannon theorem [Ref. 3-23, 3-24] on sampling theory defines one of the basic limits on throughput rate stating that the minimum frequency for sampling must be double the highest significant frequency of the signal, including the noise on the signal. This minimum frequency is necessary, the theorem states, if the sampled signal is to contain all of the information needed for undistorted reconstruction. At a lower sampling frequency ailiasing can occur¹. The minimum sampling rate for data to be used in this heading instrument (based on the design goal of Chapter II) then results in a system bandwidth of 30 hertz. The analog signals from each sensor are low pass filtered to reduce frequency content above 60 hertz. A survey of commercially available multiplexers, sample and hold modules and analog to digital convert modules (ADC) [Ref. 3-25 to 3-28] reveals that subsystems with throughput characteristics exceeding the requirements of a system sampled at one second intervals are readily available (pertinent specifications are discussed in more detail in Chapter IV). The limiting parameter determining total system speed performance will then be the execution time of the algorithm (a programming consideration). A further system consideration is the ability to adjust analog system offset and gain. These adjustments are made using variable resistors (trim pots) connected to appropriate leads on the sample and hold and analog to digital converter modules.

2) The Central Processing Unit (CPU)

The central processing unit (Fig. 3-2) is composed of the microprocessor (Signetics 2650) supported by peripheral logic elements (Fig. 3-2). Design of this subsystem involved medium

¹That is, the sampled data derived from a sine wave of frequency f sampled at a frequency less than $2f$ can be fitted with sine waves of a frequency other than f .

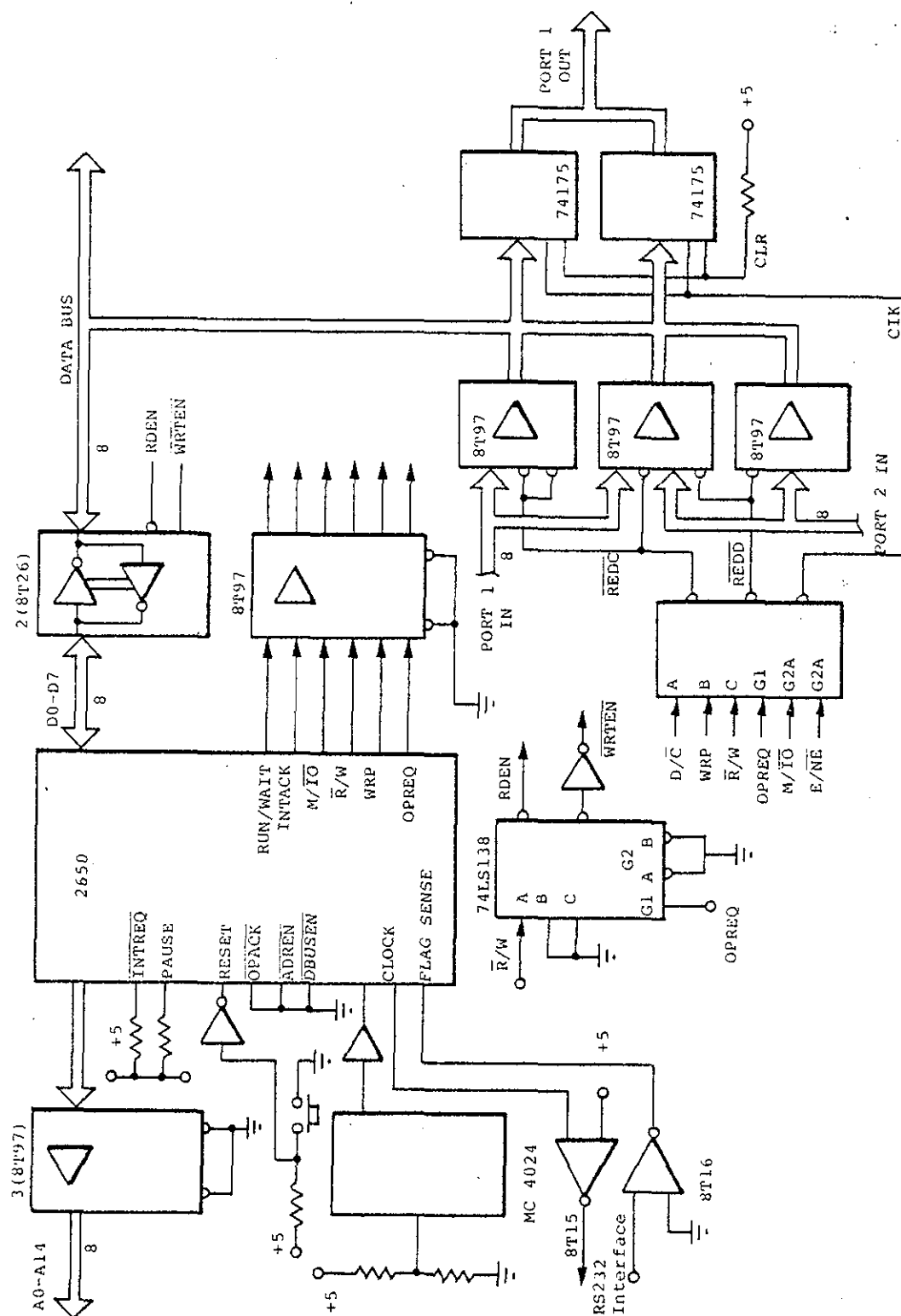


Fig. 3-2. THE CPU SUBSYSTEM

and small scale integrated circuits using well-known [Ref. 3-29 through 3-31] design techniques. To facilitate system development several features were included in the design of the CPU subsystem (features that would not necessarily be required in a production instrument). These include:

- a) System reset, single step and normal run mode operation controlled by switches and logic elements.
- b) An RS-232 teletype interface is included to enable manual intervention and development capability during program development. The program was developed by loading and executing instructions into the random access memory (RAM) under control of the PIPBUG² program.

3) The Memory Subsystem

The memory subsystem (Fig. 3-3) was organized onto cards each with two thousand byte capability. In this manner system memory could easily be expanded (or reduced) in increments of 2K bytes. The memory chips selected were organized as 256 four bit words and feature pin for pin compatibility with commercially available random access (RAM) and programmable read only memory (PROM) chips. Program segments could then be developed in RAM and finally "burned" into PROM chips for a permanent, nonvolatile operation. In this manner the system development begins with 1K bytes of memory devoted to the resident PIPBUG program (in ROM chips) with the remainder of memory allocated as RAM for both program and scratch pad usage.

²Signetics tradename for the 2650 resident loader and monitor program.

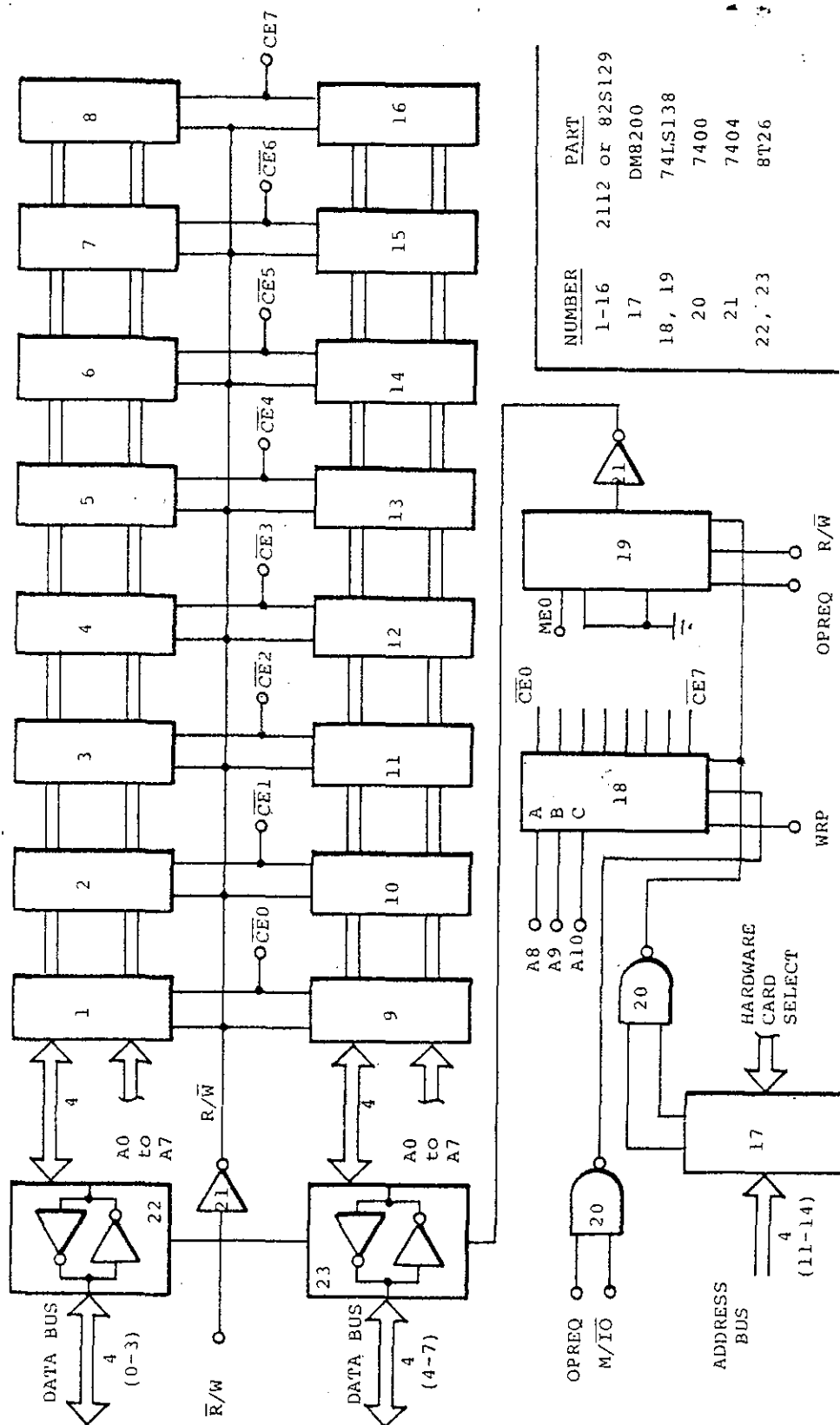


Fig. 3-3. MEMORY SUBSYSTEM (1 Card)

As the program is developed, additional memory is added in increments of 2K bytes per card or 256 bytes on the card. Modifications to the program can be easily made using the PIPBUG program and teletype.

4) The Output Subsystem

For laboratory development the output subsystem of Fig. 3-4 was designed to provide seven segment visual output of the aircraft heading with three significant digits displayed. To expediate the design cycle and to enhance system throughput rate, the outputs were designed as ports with latches and decoder driver functions provided by hardware. In other applications a hardware/software tradeoff could be made with the data decoding and driving implemented using table lookup and multiplexing controlled by the CPU.

3-3 SOFTWARE DESIGN CONSIDERATIONS

The general purpose processor selected to implement the CPU was designed to implement programmed logic and to perform conventional computer operations. This heading instrument takes advantage of both areas. Since the instrument is actually a special purpose computer under control of a stored program, the functional specialization resides in the program rather than the hardware logic. Modifications can be made relatively easily, satisfying the flexibility design goal of Chapter II.

Having decided on the tentative hardware structure described in Section 3-2 above, the program development leading to the final listing in Appendix B proceeded as follows:

- 1) Structured flow charts were developed depicting the total system operation as an ordered sequence of operations. Each

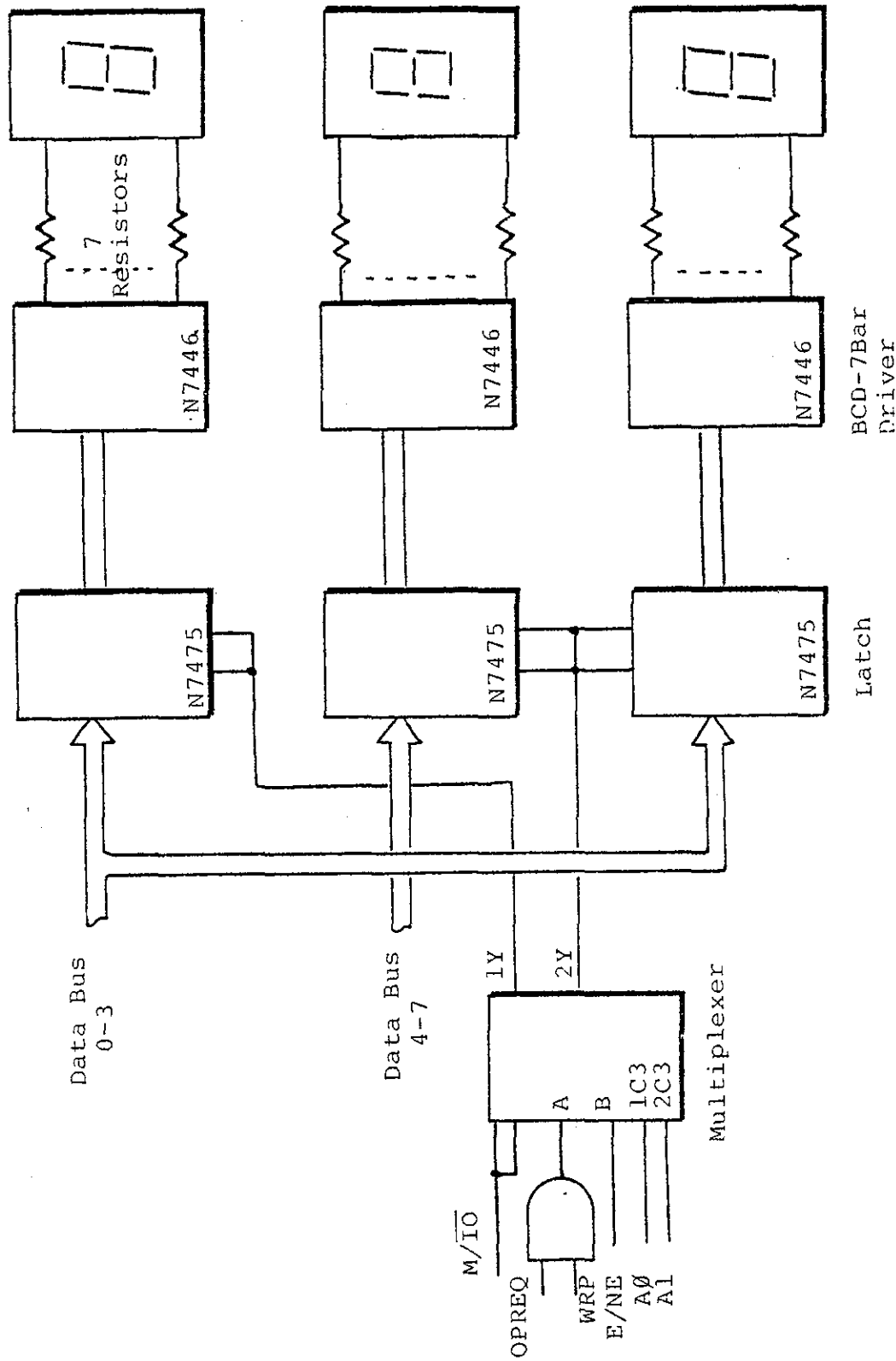


Fig. 3-4 THE OUTPUT SUBSYSTEM

operation is identified as a separate subroutine which in turn can have "nested" subroutines of its own (Fig. 3-5).

2) System accuracy requirements were next investigated (discussed in detail in Chapter IV) to ascertain the precision requirements³ of the various subroutines.

3) The respective subroutines outlined in 1) above were developed and implemented using a cross assembler program [Ref. 3-32]. Each subroutine was then loaded into the development hardware and "debugged" prior to total program integration. The above program development depicts a top down strategy of program development [Ref. 3-33] and leads to an expedient system development with subroutines being individually developed to yield a modular program construction.

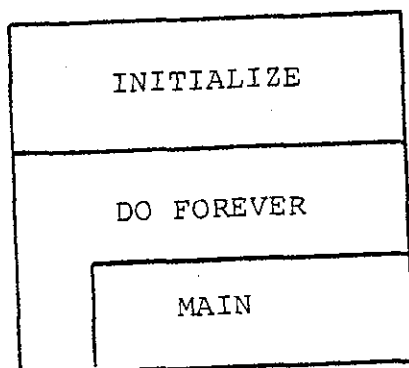
3-4 DESIGN OF SUBROUTINES

The total program consists of an overall system program composed of nested subroutines. The discussion in this section is limited in scope to the design of the more complex subroutines required to implement the solid state remote magnetic heading algorithm.

1) Subroutine "SAMP" (Fig. 3-6a)

The first portion of this subroutine is dedicated to the control function of selecting an analog channel via the multiplexer, sampling and holding the data, resetting and reading data from the analog to digital converter (ADC). Prior to or during the programming of this section, data fields in

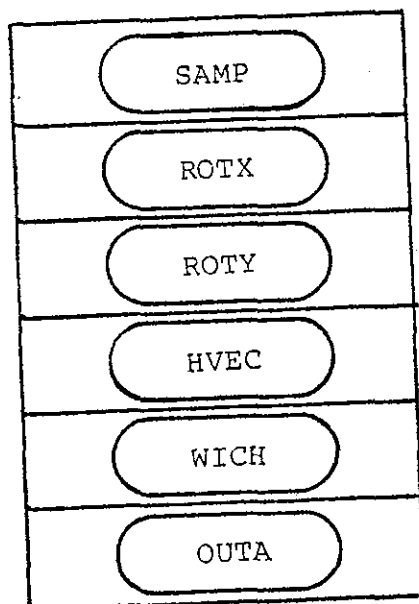
³This step is vital to determine whether the operations outlined in 1) above are to be carried out in a single or multiprecision manner.



Power on reset of all registers
and subsystems

Compute the aircraft heading

Fig. 3-5a. SYSTEM PROGRAM



Sample all analog channels

Compute the horizontal Hx field

Compute the horizontal Hy field

Compute the horizontal field
vector

Compute heading

Output the data

Fig. 3-5b. SUBROUTINE "MAIN"

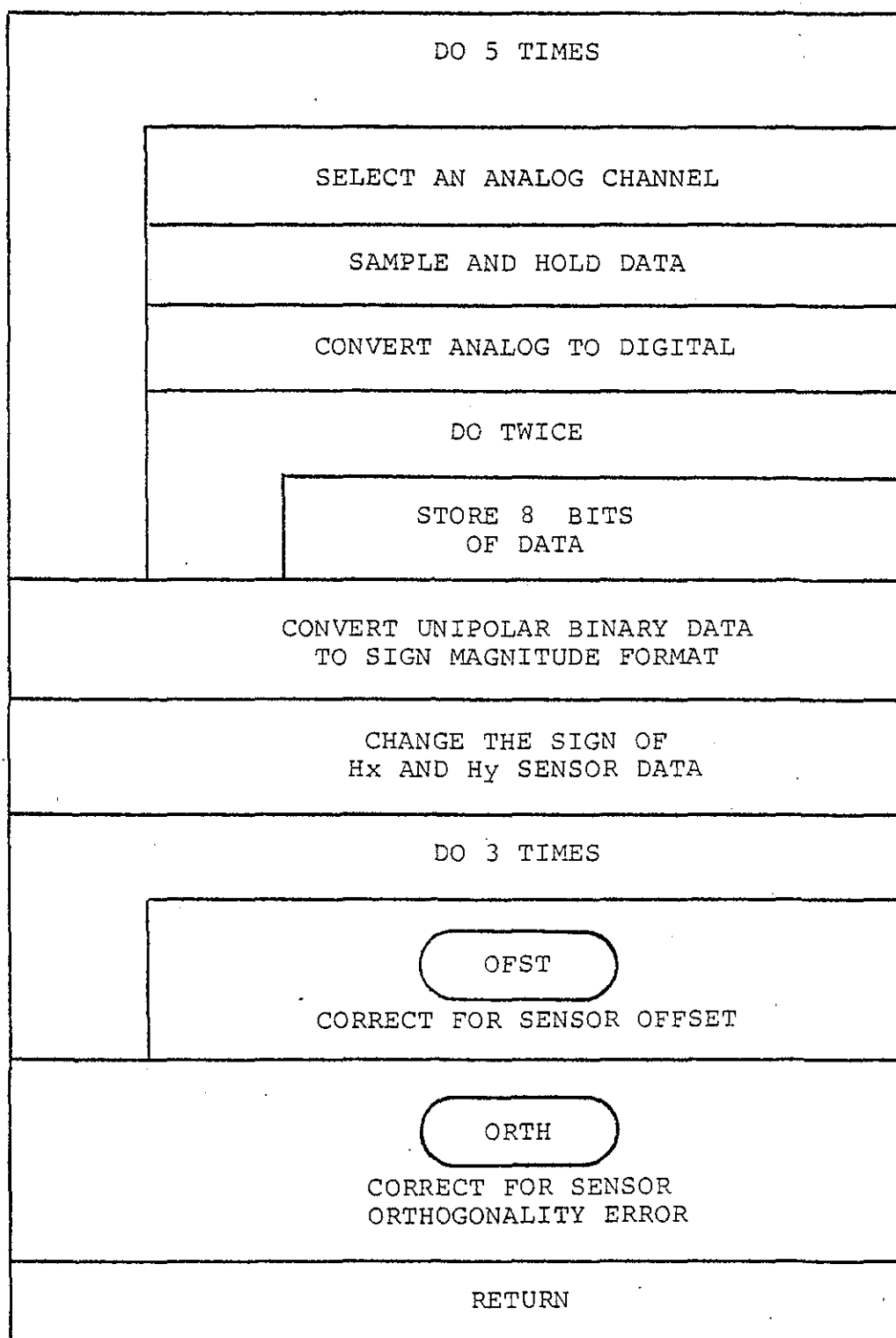


Fig. 3-6a. SUBROUTINE "SAMP"

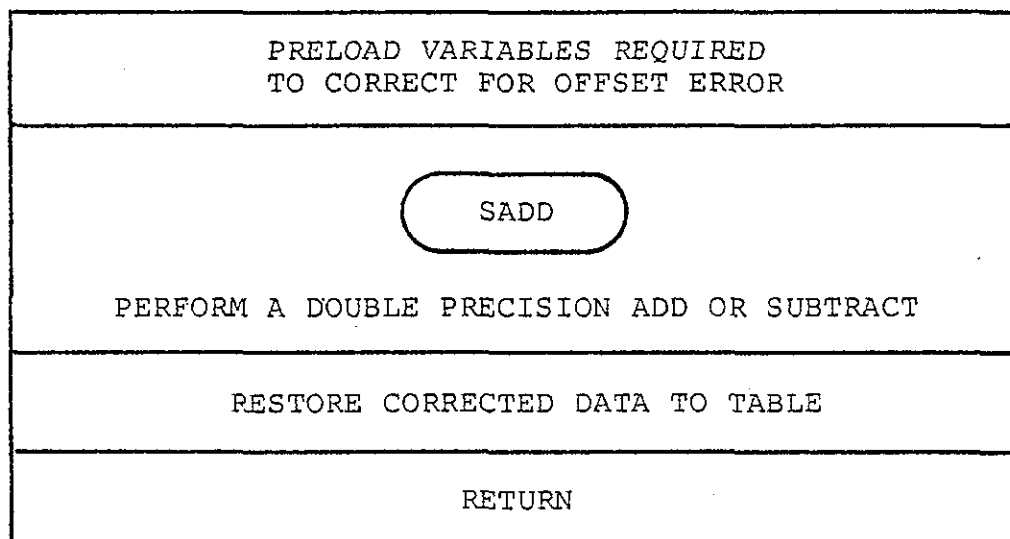


Fig. 3-6b. SUBROUTINE "OFST"

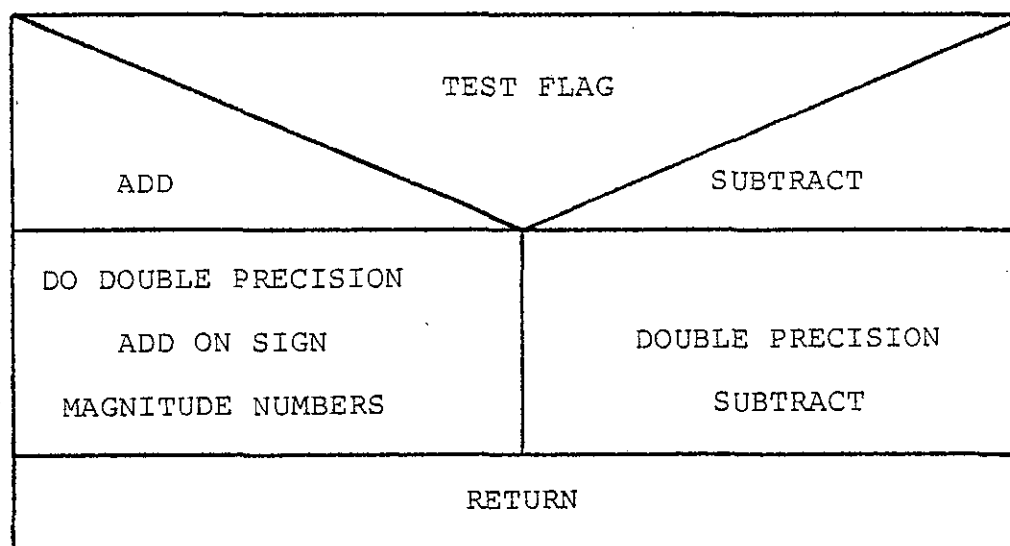


Fig. 3-6c. SUBROUTINE "SADD"

input ports 1 and 2 and output port 1 of Fig. 3-1 are allocated. Control information is then passed to the peripheral module by writing control words to output port 1. Analog to digital converter status and the 12 bit data field are sampled by reading input ports 1 and 2.

Sensor outputs were biased at +2.5 Volts with transfer characteristics as depicted in Fig. 3-7a [Ref. 3-34]. The ADC selected for this laboratory instrument had a binary output data format related to analog input as shown in Fig. 3.7b [Ref. 3-35]. The second function of the sampling subroutine "SAMP" was to convert data from a unipolar binary format to a sign magnitude format. Since the total transfer function from sensor input to ADC output (Fig. 3-7a and b) indicates an offset of 2.5 Volts or 1/2 the ADC output range, the sign magnitude format can be generated as shown in Fig. 3-8.

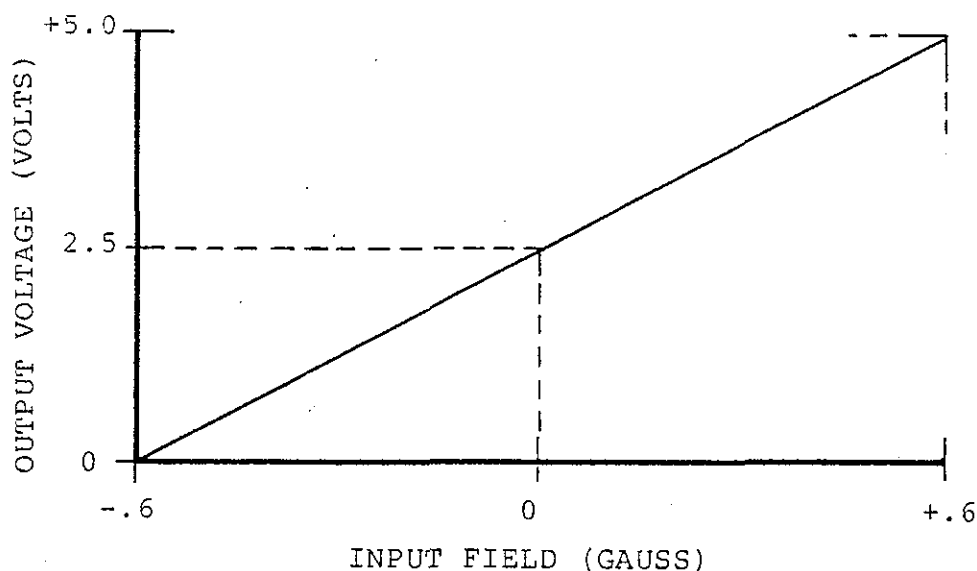


Fig. 3-7a. SENSOR TRANSFER CHARACTERISTIC

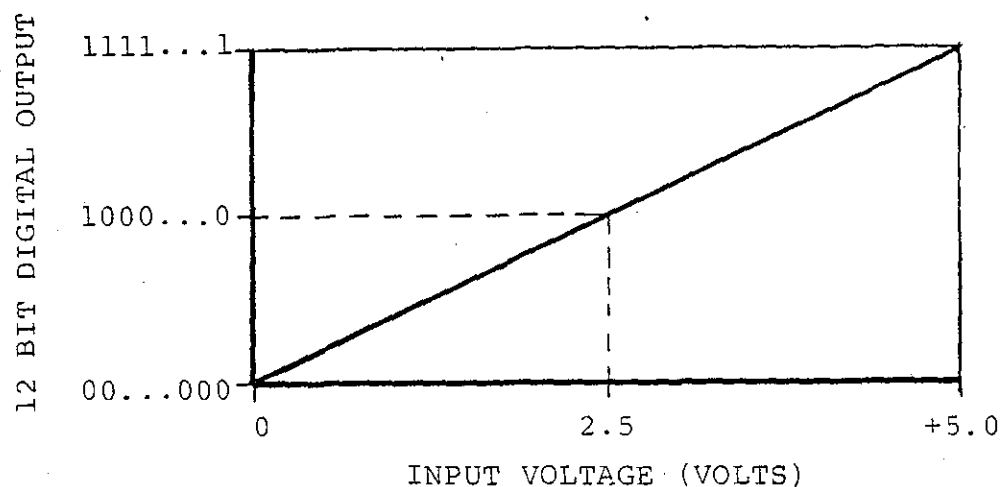


Fig. 3-7b. VDC TRANSFER CHARACTERISTICS

SIGN BIT	
1	0
$x = x_0 + \sum_{i=1}^{11} x_i \cdot 2^i$ ($x = x_0 + x^*$) Where: $x_0 = 0$ $x^* =$ The 11 least significant bits of the binary number	$x = x_0 + 2$'s complement of the 11 least significant bits $x_0 = 1$ (indicating negative quantity)

Fig. 3-8 CONVERSION OF DATA

The third function of the "SAMP" subroutine was to reverse the sign of the Hx and Hy data (to correct a test fixture problem) and to correct for sensor offsets. Although analog subsystem offsets are corrected by adjusting either the sample and hold module or the ADC, the independent sensors themselves have offsets⁴. Offset errors for the laboratory instrument were compensated by determining the offset correction term for each sensor (method described in detail in Chapter V) and then either adding or subtracting the term to the respective data during the sample subroutine. By characterizing the sensor errors⁵, actual datum could be improved further during this step.

The final function of the "SAMP" subroutine was to correct for sensor orthogonality error (subroutine "ORTH"). Although the sensors were physically aligned and specified to have orthogonality characteristic [Ref. 3-34] less than ± 1 degree relative to the base coordinates, this nonorthogonality contributes appreciably to total system error (see error analysis in Chapter IV). The physical misalignment of the sensors was determined experimentally (Chapter V) and determined to be mainly a misalignment of sensor x in the x-y plane as illustrated in Fig. 3-9.

The actual data measured with the x axis sensor is then related to the true Hx and Hy values as

$$Hx^1 = Hx \cos \epsilon - Hy \sin \epsilon .$$

⁴With zero stimulus applied the sensors have a finite nonzero output. This error in the fluxgate magnetometer is a function of temperature, voltage and magnetic remanence in the sensor magnetics [Ref. 3-36].

⁵Sensor characteristics relating the temperature and power supply coefficients of offset error and nonlinearity can be derived empirically.

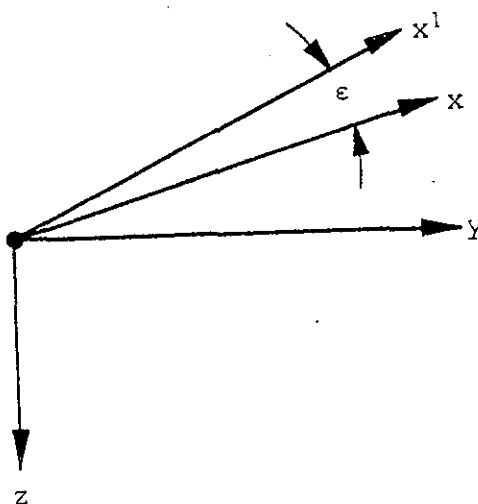


Fig. 3-9 X AXIS NONORTHOGONALITY

Using small angle approximations, we can solve for the desired true value of H_x

$$H_{x^1} \approx H_x - H_y \sin \epsilon \quad (3-1a)$$

$$H_x = H_{x^1} + H_y \sin \epsilon \quad (3-1b)$$

By measuring ϵ (Chapter V) and storing the angle as a constant, the x axis data was then restored using equation 3-1b above in subroutine "ORTH".

2) Subroutines ROTX and ROTY

These subroutines compute arithmetic values for H_{xh} and H_{yh} of equation 2-11b using sign magnitude quantities and table lookup to determine solutions for the transcendental functions. Subroutines "SADD" and "SMPY" are nested and used to perform double precision add and multiply as required.

3) Subroutine HVEC

Following computation of the horizontal X and Y axis magnetic vector, the subroutine "MAIN" calls subroutine "HVEC" to compute the square of the horizontal vector. Vectors Hx and Hy are squared by calling subroutine "SQU" then added, yielding $H(\text{HORIZONTAL})^2$.

4) Subroutine WICH

To compute heading, equation 2-1 (or a similar form) must be solved using the horizontal magnetic field vector and either the x or y axis horizontal field component. Although the square root operation implied in equation 2-1 could be implemented using a numerical technique [Ref. 3-37, 3-38], the computation time is decreased by using a table lookup method. Subroutine "WICH" (Fig. 3-10) compares the absolute magnitude of the two horizontal field vectors Hx and Hy to determine the relative heading of the aircraft⁶ with respect to the north-south and east-west axes (Fig. 3-11).

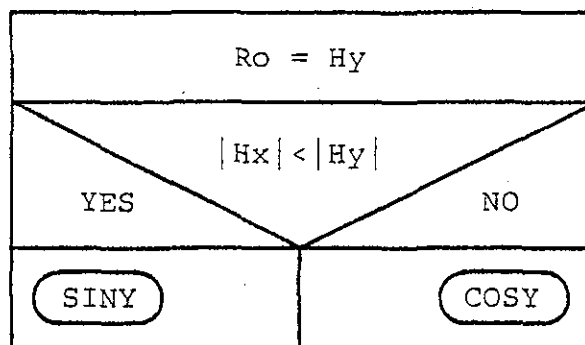


Fig. 3-10. SUBROUTINE "WICH"

⁶If $|Hx| < |Hy|$, then an equation similar in form to 2-1a must be used.

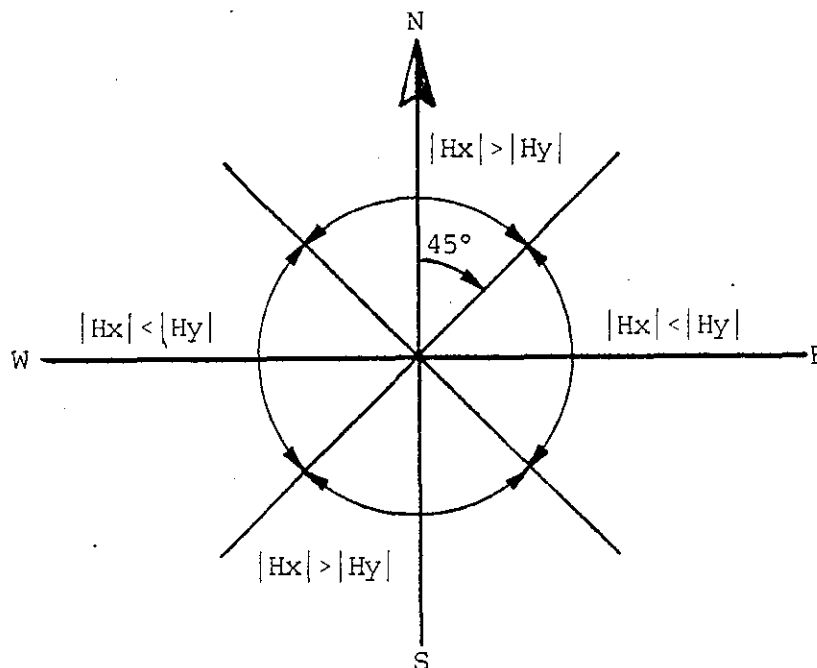


Fig. 3-11. MAGNITUDES OF H_x AND H_y RELATED AIRCRAFT HEADING

5) Subroutines COSY and SINY (Fig. 3-12, 3-13)

Depending on the relative absolute magnitudes of H_x and H_y , either "COSY" or "SINY" is called to compute aircraft heading. These subroutines invoke subroutine "DIVI" to form the quotient of the axis vector squared and the horizontal field vector squared (a double precision operation). Subroutine "ANGL" is then called to perform an associative table lookup operation using successive approximation and interpolation to complete the inverse cos squared operation. The double precision binary quantity is then converted to three digit binary coded decimal format (BCD) prior to computation of aircraft heading (subroutine "HDG").

The subroutine "SINY" of Fig. 3-12 includes a subtraction of the computed angle from 90 degrees following conversion to BCD format. This operation ensures that the angle passed to

Ro, Rl = Hx ²	
DIVI	A = Hx ² /Hh ²
ANGL	B = arcos ² (A)
BCDA	Convert B to BCD Format
HDG	Compute Heading
RETURN	

Fig. 3-12. SUBROUTINE "COSY"

Ro, Rl = Hy ²	
DIVI	A = Hy ² /Hh ²
ANGL	B = arcos ² (A)
BCDA	Convert B to BCD Format
B = 90 - B	
HDG	Compute Heading
RETURN	

Fig. 3-13. SUBROUTINE "SINY"

the calling subroutine upon exiting either "SINY" or "COSY" is an aircraft heading angle relating sensor x to the north-south axis.

6) Subroutine HDG (Fig. 3-14)

The function of this subroutine is to compute aircraft heading having established the angle between the x axis sensor and the north-south geodetic axis. Determination of the actual heading is accomplished by comparing the signs of both the x and y axis horizontal vectors prior to computing heading (Fig. 3-15). It should be noted that all of the preceding computations leading to horizontal vector data were on sign magnitude quantities preserving the correct horizontal vector polarities⁷.

3-5 CONCLUSIONS

This chapter has outlined the practical aspects of designing an instrument to evaluate both the heading algorithms and solid state magnetic indicator proposed in previous chapters. The chapter outlined a design approach that can be used to implement a microprocessor based instrument. In particular, the need to consider the total system hardware requirements while simultaneously considering the programming requirements was identified. Design proceeded by outlining a system block diagram (Fig. 3-1) with major subsystems considered. The instrument required a special purpose computer with an analog subsystem to sample and digitize five sensor signals. Timing and control of the analog subsystem plus digital processing of data was controlled by a microprocessor based central processing unit (CPU). Memory for permanent storage of

⁷It is possible at certain attitudes to require sign reversals when computing horizontal vectors.

SIGN OF Hx			
POSITIVE		NEGATIVE	
SIGN OF Hy		SIGN OF Hy	
POSITIVE	NEGATIVE	POSITIVE	NEGATIVE
HDG = 360 - ANGLE	HDG = ANGLE	HDG = 180 + ANGLE	HDG = 180 - ANGLE
HDG =360 360			
HDG = 0			
RETURN			

Fig. 3-14. SUBROUTINE "HDG"

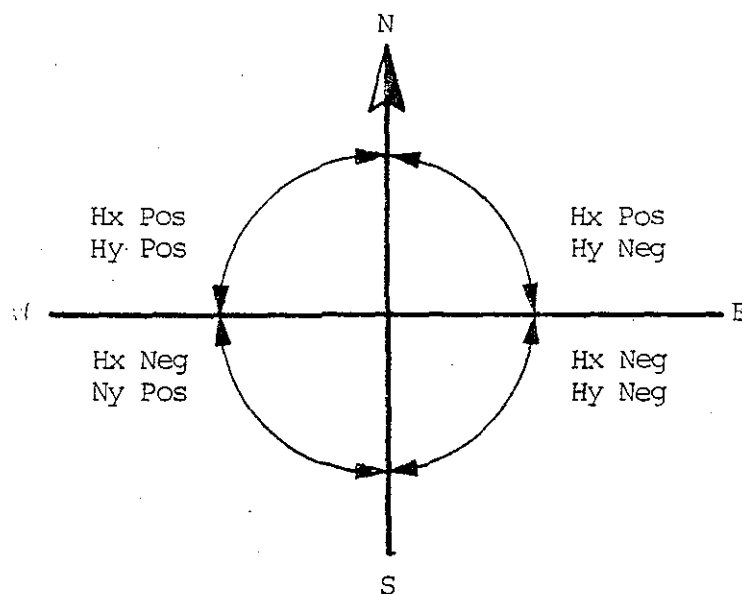


Fig. 3-15. POLARITIES OF HORIZONTAL VECTORS RELATED TO AIRCRAFT HEADING

instructions and temporary storage of data was implemented using memory chips organized on cards with 2048 byte capacity. The particular memory chips selected feature pin compatibility⁸ with both read only and volatile random access versions. System inputs consisted of sensor signals from a three axis solid state fluxgate magnetometer plus two analog signals simulating gyroscope outputs. System outputs consist of visual seven segment readout displaying computed heading. In addition, an RS-232 teletype interface was provided to facilitate system development and experimentation.

By identifying the total system in block diagram form at the very beginning, the role and requirements of each subsystem as well as the supporting software were identified. The design then evolved on a modular basis with each subsystem and its supporting program developed in parallel. In this manner pin assignments for input/output ports and critical timing requirements that involved both hardware and software consideration were handled efficiently. By outlining the program requirements in flow chart form (analogous to the block diagram of the hardware subsystem), subroutines were identified facilitating a modular program development. Where possible, subroutines were shared in a nested manner avoiding replication of programming and waste of memory.

Details of error analysis and calculation of overall system throughput rate were deferred to Chapter IV. It was pointed out however, that errors induced by imprecision of data plus truncation and roundoff during processing of the algorithm were to be considered early in the design phase. These data were required to select the sensors and the analog to digital

⁸Memory integrated circuit (IC) devices of both types can be used in the same mechanical sockets with actual chip type being used transparent to the remainder of the system.

converter as well as to design the supportive software for the analog subsystem. In addition, the data precision requirements were necessary prior to programming the algorithm⁹.

By incorporating a microprocessor as the main CPU element, considerable sophistication in both control and computing performance was achieved. The overall system was designed relatively quickly, provided a convenient laboratory instrument for evaluation of the proposed algorithms and featured inherent flexibility.

⁹Some of the subroutines required double precision manipulations to maintain overall system accuracy.

CHAPTER IV

HEADING INSTRUMENT ERROR ANALYSIS

4-1 INTRODUCTION

The heading instrument designed to evaluate the heading and solid state remote magnetic indicator algorithms is prone to error from many sources. These errors will accumulate and degrade the accuracy of aircraft heading or yaw angle computations. This chapter addresses the various error sources to determine their relative magnitudes and effects on the overall computation.

Prior to beginning the hardware design of the microprocessor based instrument many of these potential error sources were considered. Their effects were considered in establishing parameters such as word lengths, A/D converter precision, computation speeds, sampling rates, magnetometer sensor accuracies, system noise tolerance, etc. As the design of the microprocessor based system evolved, the error analysis refined. Ultimately, important limitations in instrument design and operation were identified by combined error analysis and empirical data. By carefully analyzing the source and extent of the limiting parameters (such as sensor offset and non-orthogonality), the magnitude of errors unique to this laboratory sensor array were identified. Specialized software was then added (with empirically derived constants) to correct for the otherwise limiting sensor irregularities improving the total system performance.

In this manner, it is apparent that error analysis is an integral part of instrument design. Not only are important parameters identified early in the design cycle (prior to system block diagram development), but shortcomings in conventional

sensors can be improved by judicial application of error correcting algorithms. In this case, data constants were determined after the final instrument became operational. The sensor peculiarities were analyzed empirically using the instrument itself.

The chapter begins by first identifying and carefully analyzing potential error sources in the sensors. This analysis is followed by a similar consideration of errors originating in the analog subsystem. Processing errors that originate due to the finite word length and precision of the microprocessor along with the effects of simplifications made to the algorithms are finally analyzed. The chapter then concludes with a summary of measurement errors, a sample error analysis, a comparison of predicted to measured error and a summary.

4-2 SENSOR ERRORS

The heading computation algorithm employing the remote magnetic indicator (Chapter II) is prone to error proportional to both fluxgate magnetometer sensor and gyroscope measurement errors. Errors inherent in the fluxgate magnetometer are summarized on the data sheet [Ref. 3-34]. Since the experimentation employed simulated gyroscope sensors with voltage levels accurately represented, the analysis of sensor errors will assume ideal gyroscope sensors to predict experimental data.

A) Sensor Offset Error

Magnetometer sensors exhibit error caused by both electronic and magnetic phenomena. Errors in the Develco sensors were outlined by Workentine [Ref. 4-1]. These offset errors are induced in the Develco sensors by both electronic offset voltages and currents in the respective sensor electronics and

by residual magnetic fields in the magnetic mass of the sensor assemblies. Although the physical and electronic design attempts to reduce offset error, a finite non-zero output can exist when a zero input is applied.

Offset error for each sensor in the Develco model 9200C three axis magnetometer assembly is specified [Ref. 3-34] as "Zero Field Bias +2.5 Volts $\pm 1.0\%$ ". This offset translates into a worst case maximum error voltage of

$$E_{\text{OFFSET}} = \pm(2.5V \times 0.01) = \pm 25mV$$

Since the offset error is sensor dependent, correction cannot be made at a single physical point (as for analog subsystem offsets described in Section 4-3). Corrections can however be made to the measured data by simply adding or subtracting a constant equal to the offset magnitude following each data measurement¹.

Offset values for each sensor used in the experiment were obtained by rotating the sensor into alignment with earth's magnetic field vector to measure both positive and negative maximum values. The difference in magnetic measurement (assuming negligible analog subsystem error) is related to system offset error composed of sensor electronic and sensor plus test fixture induced magnetic offset error. The actual offset error can be calculated using these two measurements

¹Offset corrections were made in the sample subroutine "SAMP" illustrated in Fig. 3-6a.

$$\begin{aligned}
 |E_{\max}| &= E_f + E_o \\
 |E_{\min}| &= E_f - E_o \\
 |E_{\max}| - |E_{\min}| &= (E_f + E_o) - (E_f - E_o) = 2 E_o \\
 E_o &= (1/2) (|E_{\max}| - |E_{\min}|)
 \end{aligned}$$

where

$E_{\max}$ = The maximum positive voltage recorded when the sensor aligns with earth's field vector.

$E_{\min}$ = The maximum negative voltage recorded when the sensor aligns 180° with earth's field vector.

E_f = The magnitude of earth's magnetic vector represented in volts.

E_o = The sensor offset voltage due to both electronic and magnetic phenomena

Data recorded during x, y and z axis offset measurements as described above are recorded in Table 4-1. Since the offset error is a function of sensor magnetic permeability, the actual offset value will vary with time depending on induced magnetic fields².

Final offset correction values were determined by rotating two sensors in the horizontal plane around the third vertical axis and measuring offsets in two sensors at a time. Recorded data for each sensor was previously corrected for orthogonality error by the sample subroutine "SAMP" (discussion

²For example, magnetized screwdrivers or other tools used near the sensor will alter the residual magnetic field.

SENSOR AXIS	DATA RECORDED (HEXADECIMAL)		OFFSET (HEXADECIMAL PLUS SIGN)
	Emax	Emin	
X	628	E78	+40
Y	640	E5D	-15
Z	637	E68	-25

Table 4-1 OFFSET DATA DERIVED BY MEASURING
EARTH'S FIELD

of this correction follows in Section 4-2B). Data recorded in this manner appears in Tables 4-2 and 4-3. Final correction terms for correcting sensor offset error were calculated using these data. Offset terms to be added or subtracted from respective data channels are tabulated in Table 4-4.

By correcting system offset errors in this manner, the effective error contribution can be reduced appreciably (see final data discussion Chapter V). For a flight instrument, sensor offset characteristics as a function of temperature variation and supply voltage can be derived empirically and appropriate offset corrections made by computing the value of the correction term variable. Magnetically induced offsets can be reduced by degaussing the sensor assembly periodically.

B) Axis Alignment Errors

The error specification of [Ref. 3-34] indicates that the maximum axis alignment error is ± 1 degree relative to base referenced coordinates. This error results in sensor directional uncertainty as illustrated in Fig. 4-1. Each sensor is located within a right circular cone with axis along the true sensor axis and vertex at the common sensor origin. Although this alignment uncertainty contributes no error in determining the total magnetic vector

$$\bar{H} = (\bar{H}_x^2 + \bar{H}_y^2 + \bar{H}_z^2)^{\frac{1}{2}},$$

there is considerable uncertainty in attempting to resolve the true magnetic field component along any axis of the reference coordinate system. This alignment uncertainty of magnetic sensors limits system performance of conventional field direction measuring apparatus [Ref. 4-1].

Protractor Heading Measurement (Degrees)	Data Measured Hx Hy (Units)		Protractor Heading Measurement (Degrees)	Data Measured Hx Hy (Units)		Error Due To Offset X Y (Units)	
	Hx	Hy		Hx	Hy	X	Y
0	8	-759	180	83	720	75	-39
345	199	-743	165	-112	704	87	-39
330	383	-677	150	-292	638	91	-39
315	540	-569	135	-448	527	92	-42
300	666	-421	120	-573	381	93	-40
285	749	-249	105	-658	206	91	-43
270	783	-62	90	-696	14	87	-48
255	770	132	75	-681	-179	89	-47
240	706	314	60	-616	-362	90	-48
225	597	473	45	-504	-521	93	-48
210	449	601	30	-359	-645	90	-44
195	273	687					
180	(DATA UNAVAILABLE DUE TO TEXT FIXTURE LIMITATION)						
165							
TOTAL OFFSETS						978	477
AVERAGE OFFSETS						88.9	43.4

Table 4-2 X AND Y AXIS ERROR MEASURED BY ROTATING
X, Y AROUND Z IN THE HORIZONTAL PLANE

Protractor Heading Measurement (Degrees)	Hz Data Measured (Units)	Protractor Heading Measurement (Degrees)	Hz Data Measured (Units)	Offset Error (Units)
0.5	0	180.5	-56	-56
315.5	-527	135.5	469	-58
270.5	-763	90.5	707	-56
225.5	-571	45.5	513	-58
TOTAL OFFSET				-228
AVERAGE OFFSET				-57

Table 4-3 Z AXIS OFFSET ERROR MEASURED BY ROTATING
THE Z AXIS AROUND THE VERTICAL X AXIS

Sensor Axis	Total Average Offset (Units)	Required Correction	Amount of Correction Decimal	Binary	Hex
X	88.9	Subtraction	45	00101101	02D0
Y	43.4	Addition	22	00010110	0160
Z	47.0	Addition	29	00011101	01D0

Table 4-4 OFFSET CORRECTION VALUES

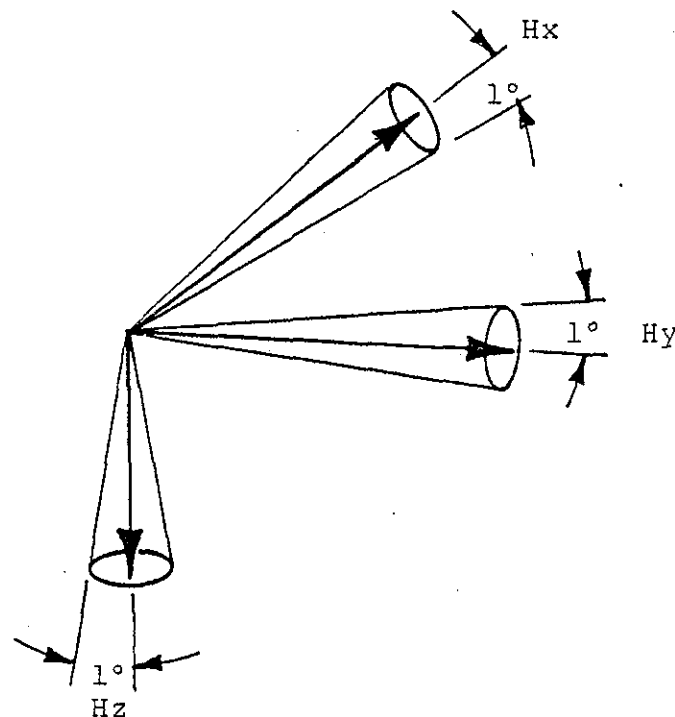


Fig. 4-1 SENSOR ALIGNMENT UNCERTAINTY

Although this error source can be reduced by physically aligning the sensors more accurately during assembly, cost of the sensors increases. Ultimately, directionality of the magnetic sensors becomes a function of the physical sensor itself and more accurate sensors are required as pointed out by Gise [Ref. 4-2]. A heading system that tolerates sensor misalignment is therefore a very desirable alternative to requiring precise alignment or more elaborate sensors.

During assembly of the Develco fluxgate magnetometer sensor array, sensor misalignment is determined by using earth's magnetic field and a precision mechanical rotation assembly. A sensor (assume the X axis) is aligned with earth's magnetic

vector by positioning the sensor to maximize electrical output³. One of the other sensors (assume the y axis) is aligned with the rotation axis of the precision calibration assembly (Fig. 4-2) and perpendicular to the first by rotating the sensor array around the second sensor axis (y axis in this case) and adjusting its relative position until a null output is achieved at all rotation angles. Mechanical orthogonality of the sensors is then limited only by the mechanical imprecision of the calibration device (orthogonality within ± 0.01 degrees can be easily achieved in the calibration tool) and by the directional characteristics of the physical sensors.

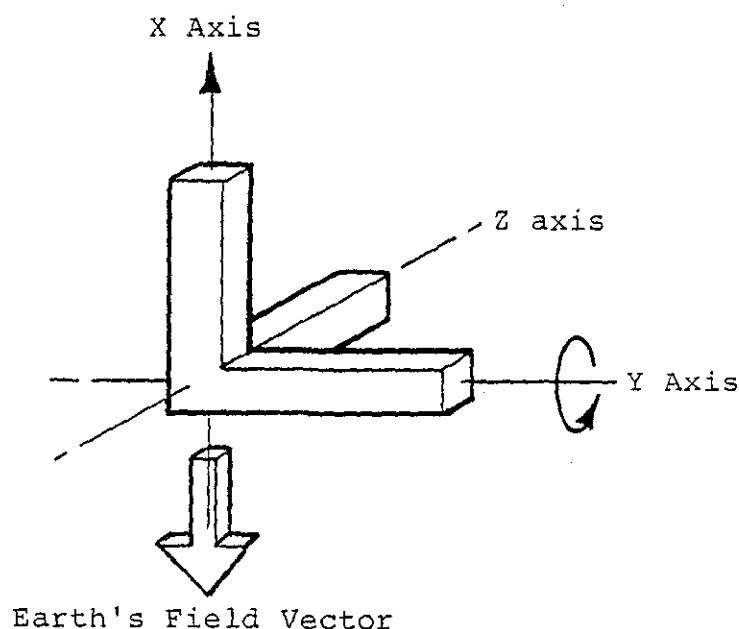


Fig. 4-2 MECHANICAL ORIENTATION OF THE MAGNETOMETER SENSORS DURING CALIBRATION

In addition to functioning as an alignment apparatus, the calibration device described above provides a convenient means

³By maximizing or nulling a measurement, the mechanical positioning is a function of only the field and the resolution of the voltage measuring device obviating errors due to physical position measurement.

to characterize sensor assemblies after final assembly adjustments are made. Any misalignment of the second sensor relative to the first results in a coning of the second sensor around the rotation axis⁴ with a sinusoidal output voltage that is a function of total earth's magnetic field and axis alignment error. The peak to peak voltage resulting from sensor coning is recorded during the final alignment test and made available to sensor purchasers. Coning voltages developed for the sensor assembly used with this experiment were obtained from Develco [Ref. 4-3] and are recorded in Table 4-5. Sensor misalignment for each axis can be derived using additional data provided by Develco along with additional empirical data derived by experimentation.

The total ambient magnetic field at the Develco laboratory is measured using the three sensors (applying equation 4-1) and is supplied as digital data. In our case, the total field measured was 1573 units or

$$\frac{1573 \text{ units}}{2048 \text{ units Full Scale (F.S.)}} \times 60,000 \text{ gamma F.S.} = 46,084 \text{ gamma } (\gamma)$$

$$\text{Sensitivity of the sensor} = \frac{2.5 \text{ Volts F.S.}}{60,000 \gamma \text{ F.S.}} = 42 \mu\text{Volts}/\gamma$$

Considering the X axis sensor, coning resulted in a signal of 38 mV peak to peak (or 19mV peak). Misalignment of the X axis sensor from the Y-Z plane can then be calculated as

⁴Assume that the first axis is initially adjusted for maximum output to align it with earth's field and the rotation axis is perpendicular to the field.

SENSOR ASSEMBLY NO. S/N 1043-013

Rotation Axis	Coning Voltage (Peak-Peak mV)	Orthogonality Error (Degrees)
X	38	0.57
Y	8	≈0
Z	51	0.76

Table 4-5 MAGNETOMETER ORTHOGONALITY MEASUREMENTS

Peak Signal = 19 mV or 456 gamma angular misalignment

$$\epsilon_x = \sin^{-1} \frac{456}{46,084}$$

$$\epsilon_x = 0.57 \text{ degrees}$$

Similarly, the Y and Z axis have misalignment errors of $\epsilon_y \approx 0$ and $\epsilon_z = 0.76$ degrees with respect to the X-Z and X-Y planes respectively (sensor orthogonality errors are tabulated in Table 4-5).

Having established that sensor orthogonality errors exist, the remaining task is to identify the direction that the sensor axis points relative to the other two sensor axes. Since the Y axis has relatively little orthogonality error, it will be assumed to be perpendicular to the X-Z plane. In addition, since the Hz data enters into the algorithm in a second order manner relative to the Hx and Hy measured data, correction and characterization of the Hx sensor was considered to be of primary concern. Orientation of the X axis sensor relative to the Y and Z axes was determined empirically.

Angular position of the X axis sensor can be described using the error angles ϵ_{xy} and ϵ_{xz} as delineated in Fig. 4-3. Characterization of sensor orthogonality error in terms of these two angles would enable algorithmic corrections of measured data.

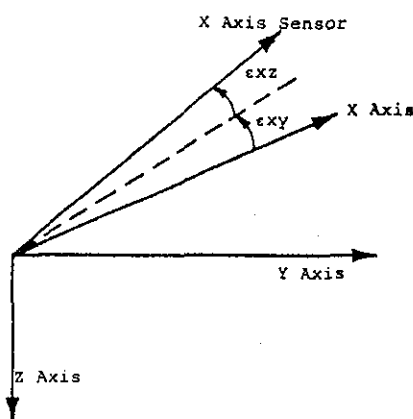


Fig. 4-3 X AXIS SENSOR ORIENTATION

1) Empirical Determination of ϵ_{xz}

The angle ϵ_{xz} (angle between the x axis sensor and the z axis of the geodetic coordinate system) was determined in several steps using the test apparatus described in Chapter V.

- i) The x and y sensors were oriented in the horizontal plane with the z axis sensor vertical downward.
- ii) The x and y sensors were rotated around the z axis with magnetic data measurements (corrected for sensor offset error as described in Section 4-2A) recorded in Table 4-6 for incremental rotation angles.
- iii) The total horizontal field at each angular position was calculated

$$H_{ht} = (H_x^2 + H_y^2)^{\frac{1}{2}}.$$

- iv) Average horizontal field H_{av} was computed by averaging the results of iii) above.
- v) The horizontal field deviation H_d was computed for each angular position; tabulated in Table 4-6 and plotted on Fig. 4-4.

$$H_d = (H_{av} - H_{ht})$$

The horizontal field deviation or error (as shown on Fig. 4-4) was now examined. An angular error ϵ_{xz} should cause the horizontal field error curve to peak at 90 and 180 degrees. Since this obviously was not the case, it was concluded that major error in x axis orthogonality was due to the component ϵ_{xy} .

Physical* Heading (Degrees)	Displayed** Heading (Degrees)	Measured Data (Units)		Total Computed Horizontal Field (Hht) (Units)	Hd (Hav-Hht) (Units)
		Hx	Hy		
355	90	12	-727	727	-3
335	70	258	-682	729	-1
315	50	477	-555	732	2
295	30	637	-362	733	3
275	10	720	-127	731	1
255	350	718	127	729	-1
235	330	628	363	725	-5
215	310	464	569	734	4
195	290	242	687	728	-2
175	270	-10	731	731	1
155	250	-258	686	733	3
135	230	-476	557	733	3
115	210	-635	362	731	1
95	190	-721	123	731	1
75	170	-718	-133	730	0
55	150	-628	-371	729	-1
35	130	-460	-565	729	-1

Total Hht = 12415

Average (Hav) = 730

*Measured using a protractor on the test apparatus.
 **Computed and displayed digitally by the instrument.

Table 4-6 MEASUREMENT OF HORIZONTAL FIELD

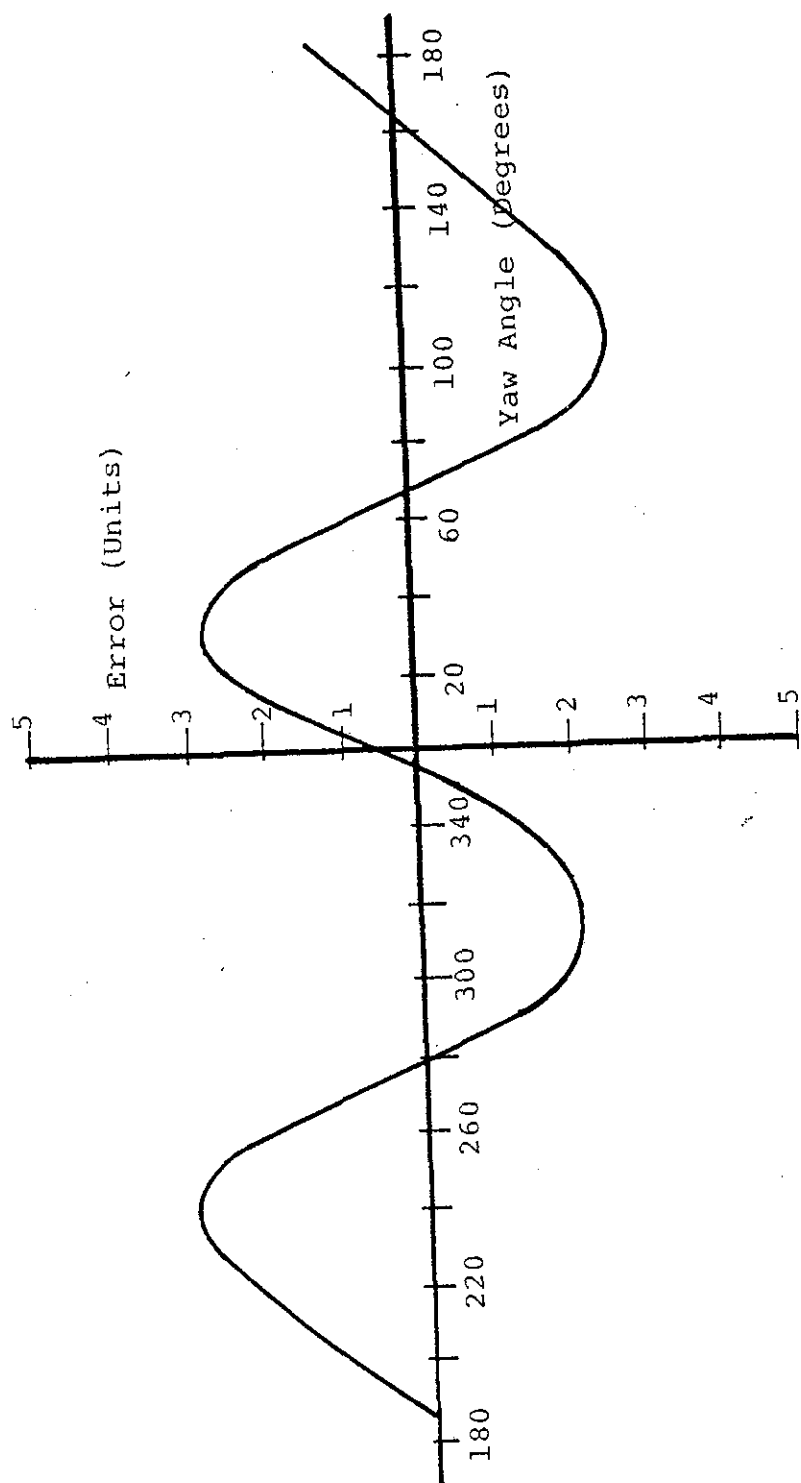


Fig. 4-4 DEVIATIONS OF THE HORIZONTAL FIELD MEASUREMENT FROM THE MEAN

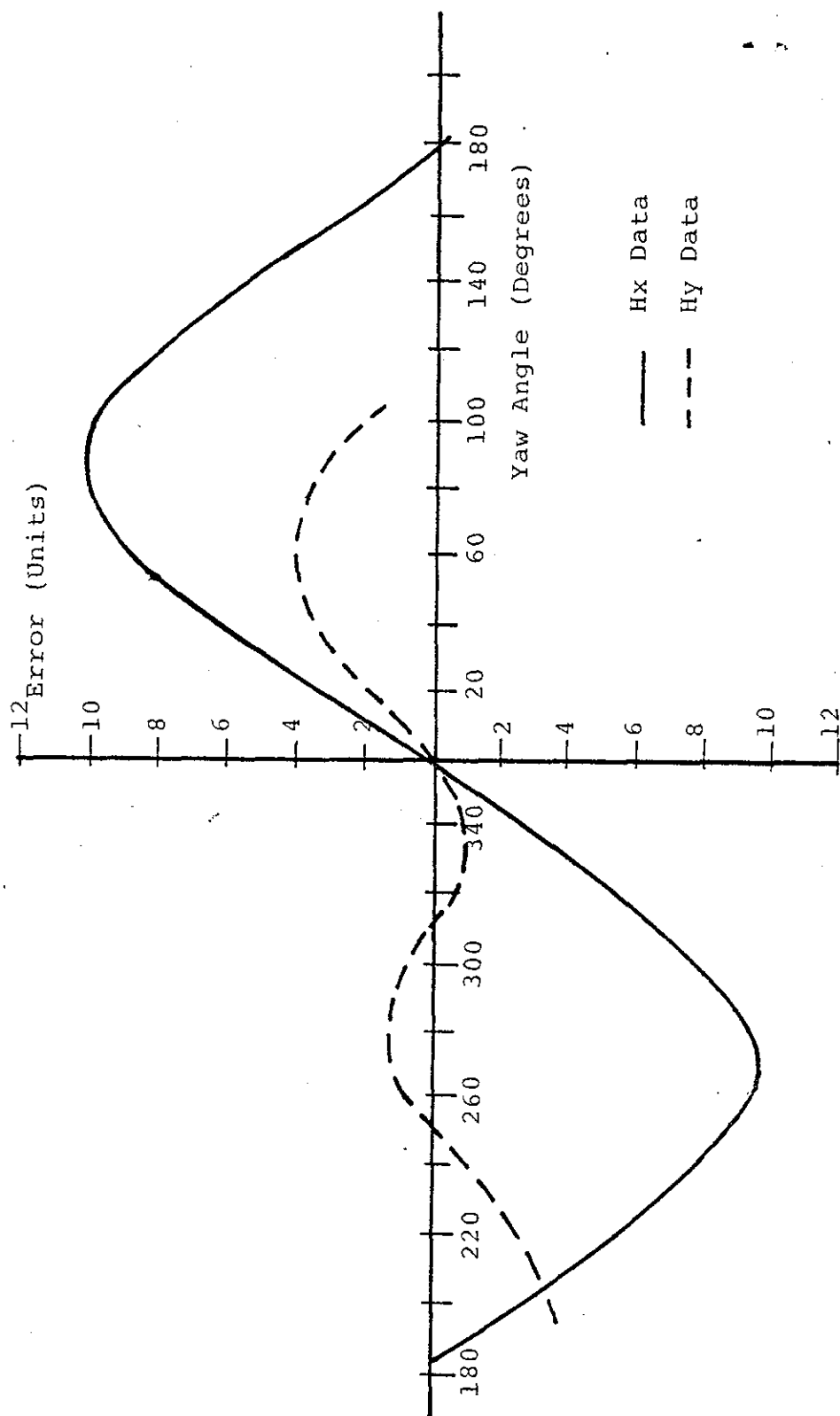


Fig. 4-5 DEVIATION OF Hx AND Hy DATA FROM THE COMPUTED FIELD COMPONENTS AS A FUNCTION OF YAW

2) Empirical Determination of ϵ_{xy}

The angle ϵ_{xy} representing x axis sensor misalignment relative to axis y was measured as follows:

Steps i) and ii) above were repeated with the exception that the calculated values for H_x and H_y (H_{xc} and H_{yc} respectively) were recorded with measured H_x and H_y data (H_{xm} and H_{ym} respectively) in Table 4-7. The calculated values were obtained by assuming that the angle ϵ_{xz} as determined above was negligible and that the y axis sensor was perpendicular to the x-z plane. With these assumptions, we note that at the heading of zero degrees (extrapolated between display of 10 and 350 degrees of Table 4-7 and Fig. 4-5), there is no error in yaw due to either H_x or H_y . By physically rotating the sensors in fixed intervals from yaw = 0 degrees and noting that the horizontal field $H_h = 730$ units, we can then compute expected H_x and H_y data at respective yaw orientations.

Physical orientation of the x axis sensor is easily determined by considering orientation at the maximum error excursions. These observations are illustrated in Fig. 4-6. We note that the only possible orientation of the x axis sensor satisfying the data in Fig. 4-5 is that of Fig. 4-6.

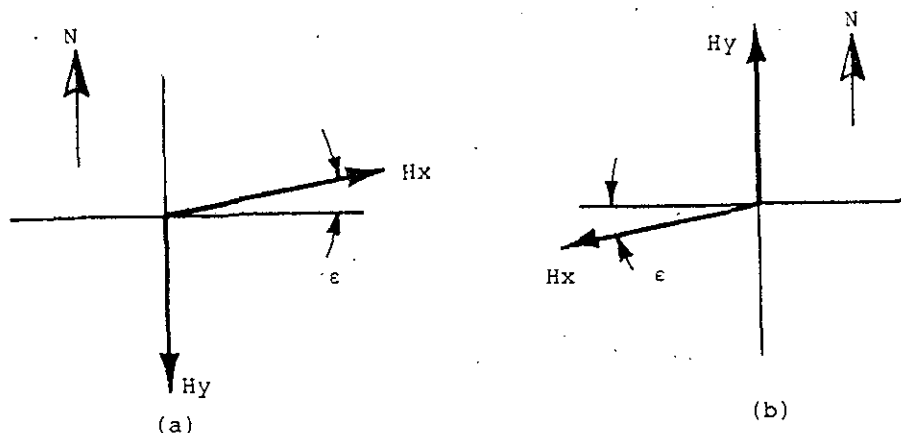


Fig. 4-6 (a) SENSORS ORIENTED AT YAW = +90 degrees
(b) SENSORS ORIENTED AT YAW = +270 degrees

Physical* Heading (Degrees)	Displayed** Heading (Degrees)	Measured Data (Units)		Computed Data (Units)		Deviation (Units) (Hxm-Hxc) (Hym-Hyc)	
		Hxm	Hym	Hxc	Hyc		
355	90	12	-727	0	-730	+12	+ 3
335	70	258	-682	250	-686	+ 8	+ 4
315	50	477	-555	469	-559	+ 8	+ 4
295	30	637	-362	632	-365	+ 5	+ 3
275	10	720	-127	719	-127	+ 1	0
255	350	718	127	719	+127	- 1	0
235	330	628	363	632	365	- 4	- 2
215	310	464	569	469	559	- 5	10
195	290	242	687	250	686	- 8	1
175	270	-10	731	0	730	-10	1
155	250	-258	686	-250	686	- 8	0
135	230	-476	557	-469	559	- 7	- 2
115	210	-635	362	-632	365	- 3	- 3
95	190	-721	123	-719	+127	- 2	- 4
75	170	-718	-133	-719	-127	1	- 6
55	150	-628	-371	-632	-365	4	- 6
35	130	-460	-565	-489	-559	9	- 6

* Measured using a protractor on the test apparatus.

** Computed and displayed digitally by the instrument.

Table 4-7 MEASURED AND COMPUTED HX AND HY DATA
IN THE HORIZONTAL PLANE

Magnitude of the angle ϵ_{xy} can be computed as follows using data from Fig. 4-5

Max. delta from Fig. 4-5 = 10 units
Average horizontal field = 730 units

$$\epsilon_{xy \text{ max}} = \sin^{-1} \frac{10}{730}$$

$$= 0.79 \text{ degrees}$$

We note that the angle of 0.79 degrees is approximately the same as determined by Develco during manufacture of the sensors (Table 4-5). The added error is due to test set inaccuracy.

C) Fluxgate Sensor Noise Induced Error

The analog output from the fluxgate sensors can exhibit an error due to signal uncertainty resulting from noise. Although the data sheet [Ref. 3-34] indicates that 5mV peak to peak of ripple can exist on the output, the frequency content centers in the 550 kHz range (driver frequency of the fluxgate magnetometer) and no appreciable ripple⁵ exists below 60 Hz (especially when the sensor output is filtered prior to data sampling). The noise specification of less than 1 gamma peak to peak in the 1 Hz bandwidth region is also negligible. In summary, no appreciable error due to noise on the magnetometer signal lines is evident.

D) Magnetometer Gain Error

The magnetometer is specified to have gain (sensitivity) of 2.5 Volts/600 milligauss, $\pm 1\%$ which translates into a maximum signal uncertainty of

⁵Verbally confirmed by Workentine of Develco [Ref. 4-1].

$$\pm(2.5V \times 0.01) = \pm 25 \text{ mV.}$$

This represents a sensor transfer function of 4.16 Volts/gauss or 0.24 gauss per volt. The uncertainty then can be expressed as

$$\begin{aligned} \pm(0.24 \text{ gauss} \times 0.01) &= \pm 2.4 \text{ milligauss} \\ &= \pm(2.4 \times 10^2) \text{ gamma} \end{aligned}$$

Since this error is not corrected in the laboratory instrument it will be considered in total in the final error analysis. It is worth noting however, that should the magnetometer gain uncertainty be characterized, gain corrections for each sensor could be made during computation by the computer. In addition the error term is proportional to actual signal level applied.

E) Magnetometer Linearity Error

D.C. linearity of the magnetometer is specified to be $\pm 0.5\%$ of signal level. This uncertainty at full scale can be expressed as $\pm(2.5 \text{ Volts} \times 0.005) = \pm 12.5 \text{ mV}$. Alternately, linearity error can cause a signal uncertainty of ± 1.2 milligauss or $\pm(1.2 \times 10^2)$ gamma. Linearity error is also not corrected during computation and is considered in the final error analysis. By simply characterizing and correcting the linearity characteristics of each sensor, considerable improvement in system accuracy could be achieved.

4-3 ANALOG SUBSYSTEM ERROR ANALYSIS

The analog subsystem of the instrument is outlined in block diagram form in Fig. 4-7. This subsystem accepts analog signals from magnetometer and gyroscope transducers, performs a time division multiplexing between the signals and digitizes

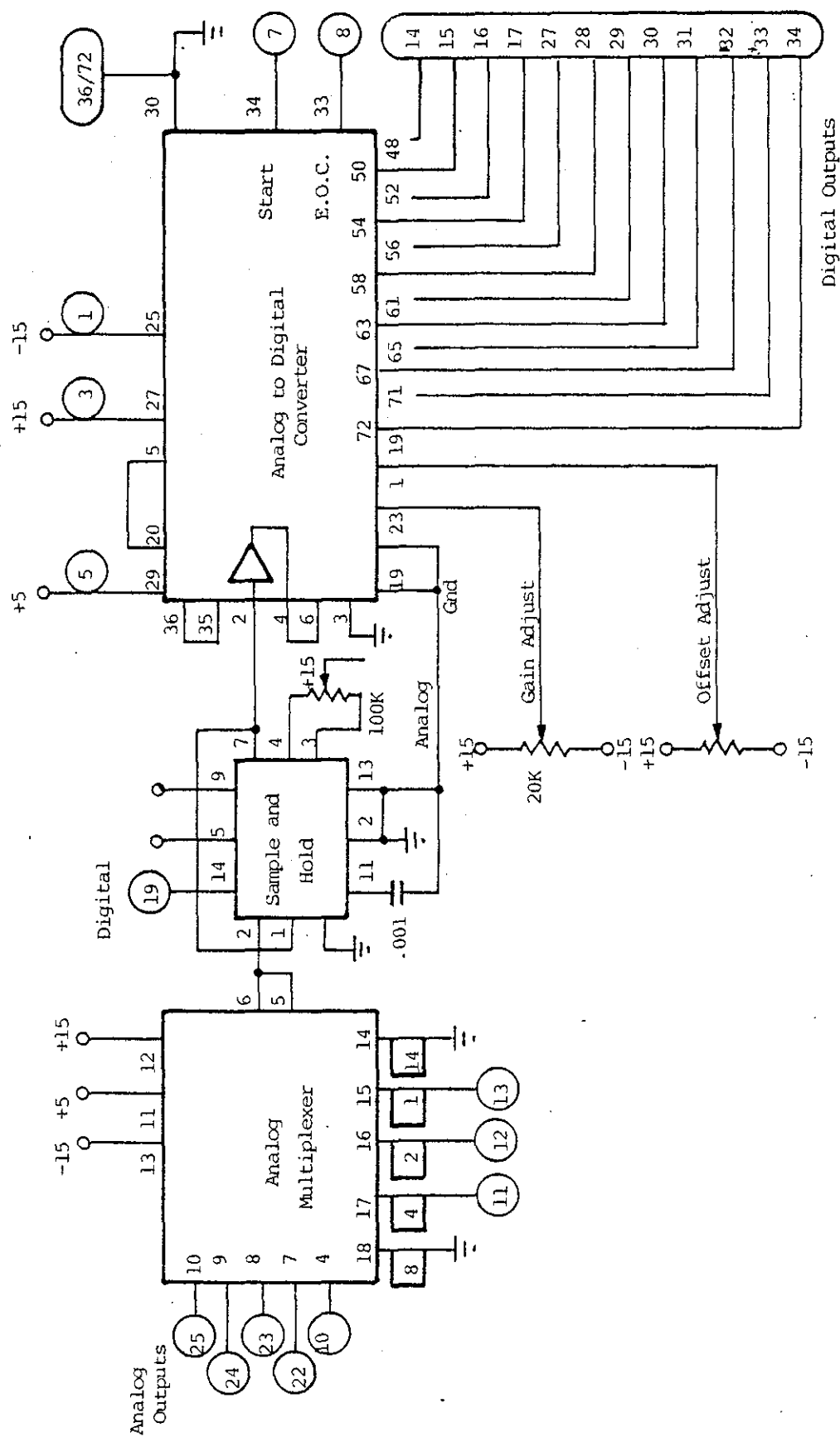


Fig. 4-7 THE ANALOG SUBSYSTEM

the respective signals prior to subsequent processing by the computer. During this data acquisition and conversion process, errors are introduced into each of the signals. This section addresses the potential error sources and computes the respective error contributions to be expected during operation of the instrument.

Although the multiplexer and sample and hold blocks of Fig. 4-7 could be eliminated (eliminating possible error sources) by digitizing each signal with a unique analog to digital converter, it can be shown that such a system would be expensive and difficult to implement. The analog to digital converter (A/D) quantizes an analog signal in a finite amount of time. Speed of conversion is predicted in a finite amount of time by both the resolution of the converter and the frequency of the signal to be converted. Time required to perform a conversion is generally called the "aperature time".

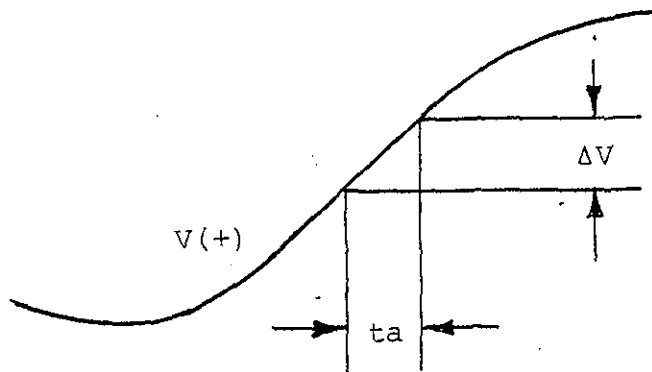


Fig. 4-8 APERATURE TIME AND AMPLITUDE UNCERTAINTY

As illustrated in Fig. 4-8, aperature time and amplitude uncertainty are related by the time rate of change of the analog signal. For the particular case of a sinusoidal signal to

be converted, the maximum rate of change occurs at the zero crossing of the waveform and the amplitude change is:

$$\Delta V = \frac{d}{dt} (V \sin wt)_{t=0} \times t_a \quad (4-1a)$$

$$\Delta V = V w t_a \quad (4-1b)$$

$$\text{giving } \frac{\Delta V}{V} = w t_a = 2 \pi f t_a. \quad (4-2)$$

From this result we can determine the aperture time required to digitize a 30 Hz signal to 12 bits resolution (a resolution of 1 part in 4096 or 0.0244%).

$$t_a = \frac{V}{V} \times \frac{1}{2 f} = \frac{.000244}{6.28 \times 30} = 1.3 \times 10^{-6}$$

This result indicates that to remain within 1 bit of resolution (0.0244%) we require an aperture time of 1.3 microseconds to process analog signals varying at a rate of 30 Hertz. It can be seen that the system would require fast A/D converters plus extremely fast computational capability to accommodate this configuration of sensors and analog subsystem. By using multiplexing and sample and hold circuitry we can however reduce the number of A/D converters required to one and alleviate the aperture and processing requirements imposed above.

The operation of sampling to be used by the instrument is illustrated in Fig. 4-9 which shows an analog signal and a train of sampling pulses. The pulses are provided by the central processing unit. A switch connects the analog signal for a very short period of time to the hold circuitry charging a capacitor and storing the sampled voltage until the next sample is required. This type of sampler is called sample and hold.

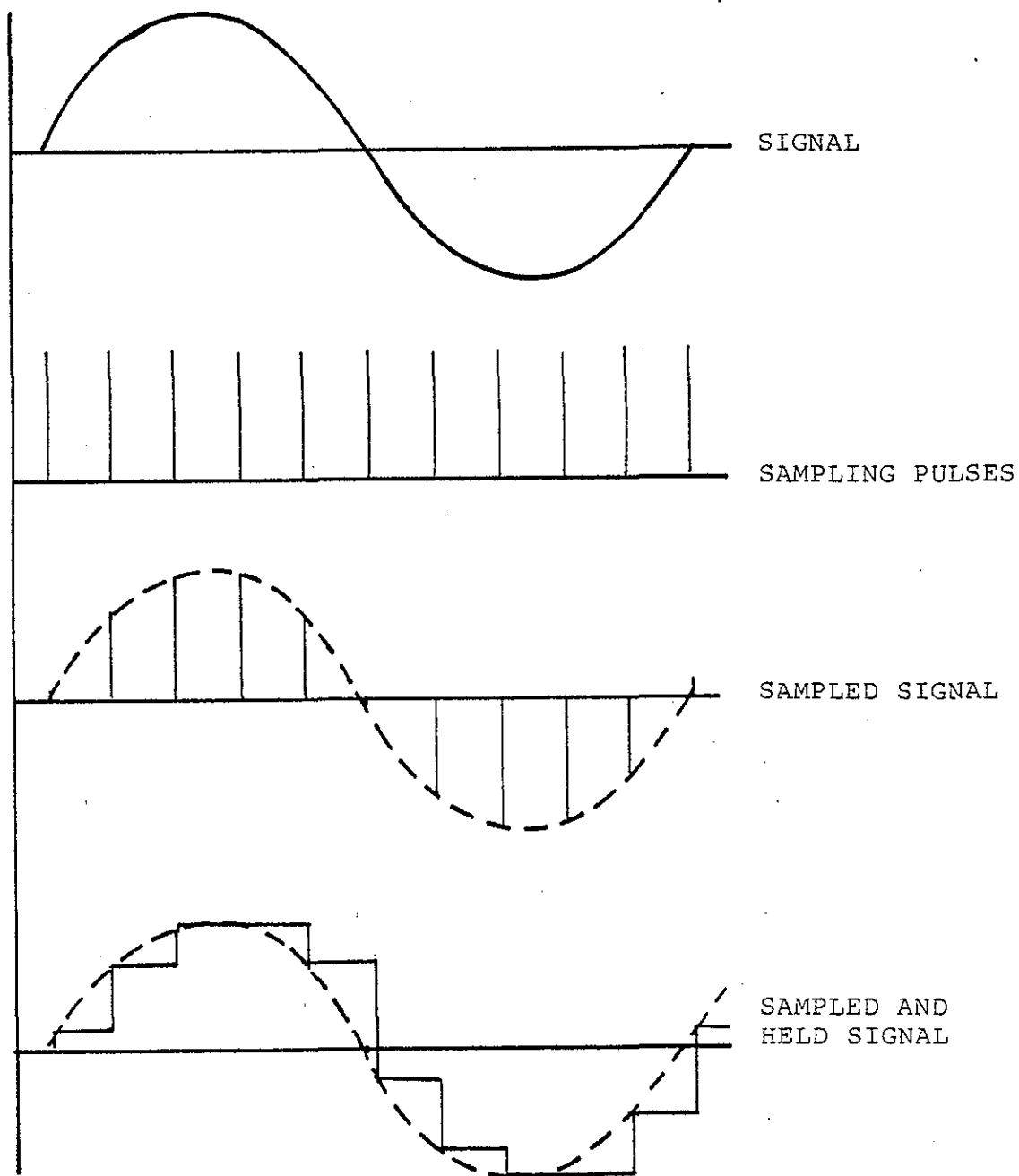


Fig. 4-9 SIGNAL SAMPLING PROCESS

A) Sampling Rate Errors

The process of uniformly sampling a function of continuous time can yield a significant source of error if the sampling period T is selected too large [Ref. 4-4, 4-5]. This error can be illustrated by considering an analog signal $x_a(t)$ that has the Fourier representation [Ref. 4-6]

$$x_a(t) = \frac{1}{2\pi} \int_{-\infty}^{\infty} X_a(j\Omega) e^{j\Omega t} d\Omega \quad (4-3a)$$

$$X_a(j\Omega) = \int_{-\infty}^{\infty} x_a(t) e^{-j\Omega t} dt \quad (4-3b)$$

The sequence $x(n)$ with values $x(n) = x_a(nT)$ is said to be derived from $x_a(t)$ by periodic sampling and T is the sampling period. The reciprocal of T is called the sampling frequency or sampling rate. In order to determine the sense in which $x(n)$ represents the original signal $x_a(t)$, it is convenient to relate $X_a(j\Omega)$, the continuous-time Fourier transform of $x_a(t)$, to $X(e^{j\Omega})$, the discrete-time Fourier transform of the sequence $x(n)$. From (4-3a) we note that

$$x(n) = x_a(nT) = \frac{1}{2\pi} \int_{-\infty}^{\infty} X_a(j\Omega) e^{j\Omega nT} d\Omega \quad (4-4)$$

From the discrete-time Fourier transform we also obtain the representation [Ref. 4-4]

$$x(n) = \frac{1}{2\pi} \int_{-\pi}^{\pi} X(e^{j\omega}) e^{j\omega n} d\omega \quad (4-5)$$

To relate the equations (4-4) and (4-5) we can express (4-4) as a sum of integrals over intervals of length $2\pi/T$, as in

$$x(n) = \frac{1}{2\pi} \sum_{r=-\infty}^{\infty} \int_{(2r-1)\pi/T}^{(2r+1)\pi/T} X_a(j\Omega) e^{j\Omega nT} d\Omega \quad (4-6)$$

Each term in the sum can be reduced to an integral over the range $-\pi/T$ to $+\pi/T$ by a change of variables to obtain

$$x(n) = \frac{1}{2\pi} \sum_{r=-\infty}^{\infty} \int_{-\pi/T}^{\pi/T} X_a \left[j\left(\Omega + \frac{2\pi r}{T}\right) \right] e^{j\left(\Omega + \frac{2\pi r}{T}\right)nT} d\Omega \quad (4-7a)$$

$$x(n) = \frac{1}{2\pi} \sum_{r=-\infty}^{\infty} \int_{-\pi/T}^{\pi/T} X_a(j\Omega + j\frac{2\pi r}{T}) e^{j\Omega nT} e^{j2\pi r n} d\Omega \quad (4-7b)$$

If we now change the order of integration and summation and note that $e^{j2\pi r n} = 1$ for all integer values of r and n , we obtain

$$x(n) = \frac{1}{2\pi} \int_{-\pi/T}^{\pi/T} \left[\sum_{r=-\infty}^{\infty} X_a(j\Omega + j\frac{2\pi r}{T}) \right] e^{j\Omega nT} d\Omega \quad (4-8)$$

Substituting $\Omega = \omega/T$ we get

$$x(n) = \frac{1}{2\pi} \int_{-\pi}^{\pi} \left[\frac{1}{T} \sum_{r=-\infty}^{\infty} X_a\left(\frac{j\omega}{T} + j\frac{2\pi r}{T}\right) \right] e^{j\omega n} d\omega \quad (4-9)$$

which is identical in form to equation (4-5). We can therefore make the identification (equating like terms of (4-5) and (4-9))

$$X(e^{j\omega}) = \frac{1}{T} \sum_{r=-\infty}^{\infty} X_a\left(\frac{j\omega}{T} + j\frac{2\pi r}{T}\right) \quad (4-10)$$

We can also express (4-10) in terms of the analog frequency variable Ω (where $\Omega = \omega/T$) as

$$X(e^{j\omega T}) = \frac{1}{T} \sum_{r=-\infty}^{\infty} X_a(j\Omega + j\frac{2\pi r}{T}) \quad (4-11)$$

The last two equations clearly reveal the relationship between the continuous-time Fourier transform and the Fourier transform of a sequence derived by sampling. For example, if $X_a(j\Omega)$ is as depicted in Fig. 4-10a then $X(e^{j\omega})$ will be as shown in Fig. 4-10b when the sampling period T is too long and as shown in Fig. 4-10c if T is short enough.

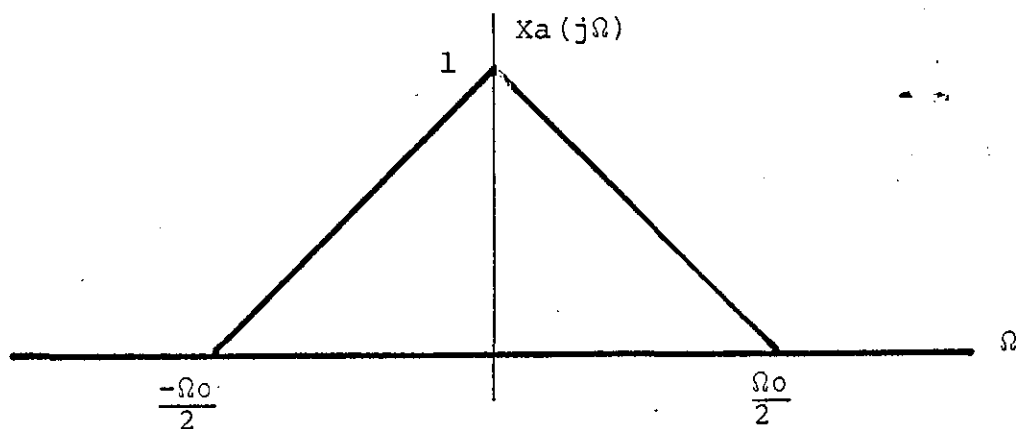
From Fig. 4-10c it is obvious that if $\frac{\Omega_0 T}{2} < \pi$, i.e., we sample at a rate at least twice the highest frequency of $X_a(j\Omega)$, then $X(e^{j\omega})$ is identical to $X_a(\omega/T)$ in the interval $-\pi \leq \omega \leq \pi$ and can be recovered from the samples $x_a(nT)$ by an appropriate interpolation formula.

For the remote magnetic indicator instrument designed in previous chapters, the analog signals are filtered with a low pass section reducing frequency content above 30 Hz. The sampling rate must therefore exceed 60 Hz ($T < 16.67$ m.s.) to enable accurate dynamic operation of the system.

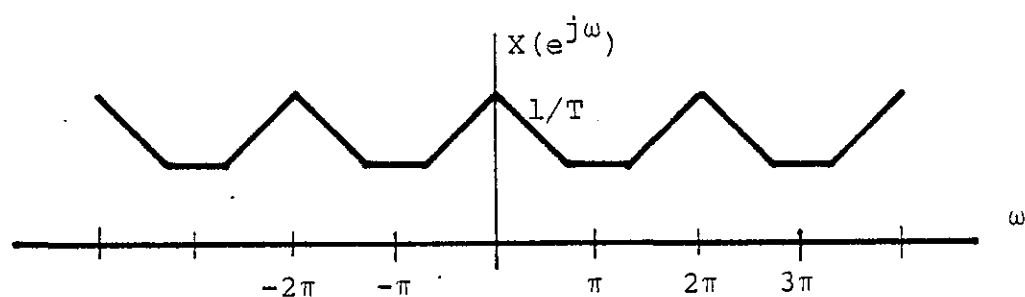
Laboratory measurements of sampling rates on the functional microprocessor based instrument revealed that the analog subsystem operated at a sampling rate of 62.5 Hz (16 m.s.) indicating that the algorithm execution rate supported a system bandwidth of 31.25 Hz. If frequency content of the analog signals is less than 31.25 Hz there is no error due to sampling.

B) Analog Multiplexer Induced Error

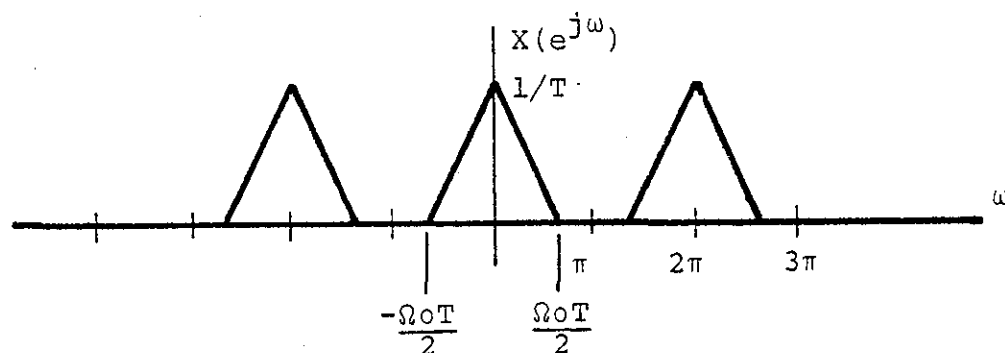
The analog multiplexer of Fig. 4-7 selectively connects one analog transducer output at a time to the input of the sample and hold subsystem. The Datel Systems, Inc., multiplexer [Ref. 4-7] selected for the remote magnetic indicator experiment features eight MOS-FET switches with associated driver circuits,



(a) Fourier transform as a continuous-time signal



(b) Fourier transform of the discrete-time signal obtained by periodic sampling (T is too large)



(c) Same as (b) except T is short enough

Fig. 4-10 FOURIER TRANSFORMS OF CONTINUOUS AND DISCRETE-TIME SIGNALS

FET pull-up to reduce propagation delays and all of the necessary decoding logic to enable random channel addressing with a four bit parallel binary input.

Several important parameters are used to characterize analog multiplexers and can contribute error.

1) Transfer Accuracy

Transfer accuracy is a function of the source impedance, switch resistance, load impedance (if the multiplexer is not buffered) and the signal frequency. It expresses the input to output error as a percentage of the input. In our case the system configuration predicates a maximum error due to transfer accuracy of ($\pm 0.01\%$) yielding an error term of

$$\pm 0.0001 \times 2.5 \text{ Volts} = \pm 25 \text{ mV}$$

2) Settling Time

This parameter defines the time elapsed from the application of a full scale step input to the time when the output has entered and remained within a specified error band around its final value. In our case the selected multiplexer has a maximum settling time of 1 microsecond to $\pm 0.01\%$ full scale (F.S.) Since the control system selecting channels is implemented using a microprocessor, the minimum time between analog subsystem commands will always be greater than 3.0 microsecond⁶. The multiplexer will therefore always have settled to the final value before the sample and hold circuit (following this subsystem) can be activated with no error due to the settling time parameter.

⁶One machine cycle time for the 2650 microprocessor with 1 MHz clock frequency.

3) Throughput Rate

The highest rate at which the multiplexer can switch from channel to channel at its specified accuracy is in this case 500 kHz. Since this rate is more than four orders of magnitude greater than the operational rate of the subsystem there is no error due to throughput rate limitations.

4) Input Leakage Current

The amount of signal coupled to the output as a percentage of input signal applied to all OFF channels together can be calculated by considering the maximum leakage current specified from OFF channels to the ON channel. In our case the maximum error signal can be calculated

$$\text{Error} = [4 (8 \text{ na} \times 2000 \text{ ohms source imped.})^2]^{\frac{1}{2}}$$

$$\text{Error} = 32 \text{ microvolts}$$

Note that in this case the voltage levels are statistically independent allowing an R.S.S. of error sources to calculate total error [Ref. 4-8, 4-9].

C) Sample and Hold Circuit Induced Errors

The sample and hold subsystem consists of a switch and capacitor arrangement as shown in Fig. 4-11. The Datel Systems, Inc., model SHM-IC-1 integrated circuit sample and hold device [Ref. 4-10] features a self-contained high gain differential input amplifier, a digitally controlled electronic switch and a high input impedance buffer amplifier. The external components used with the sample and hold circuit in the solid state remote magnetic indicator instrument consisted of the 0.001 μ f holding capacitor and a 100K offset trimpot. By connecting

the output back to the negative input of the input amplifier (Fig. 4-11), the sample and hold subsystem operated in a unity gain, noninverting mode. When the switch is closed, the unit is in the sampling or tracking mode (Digital Control = 0 Volts), and will follow a changing input signal.

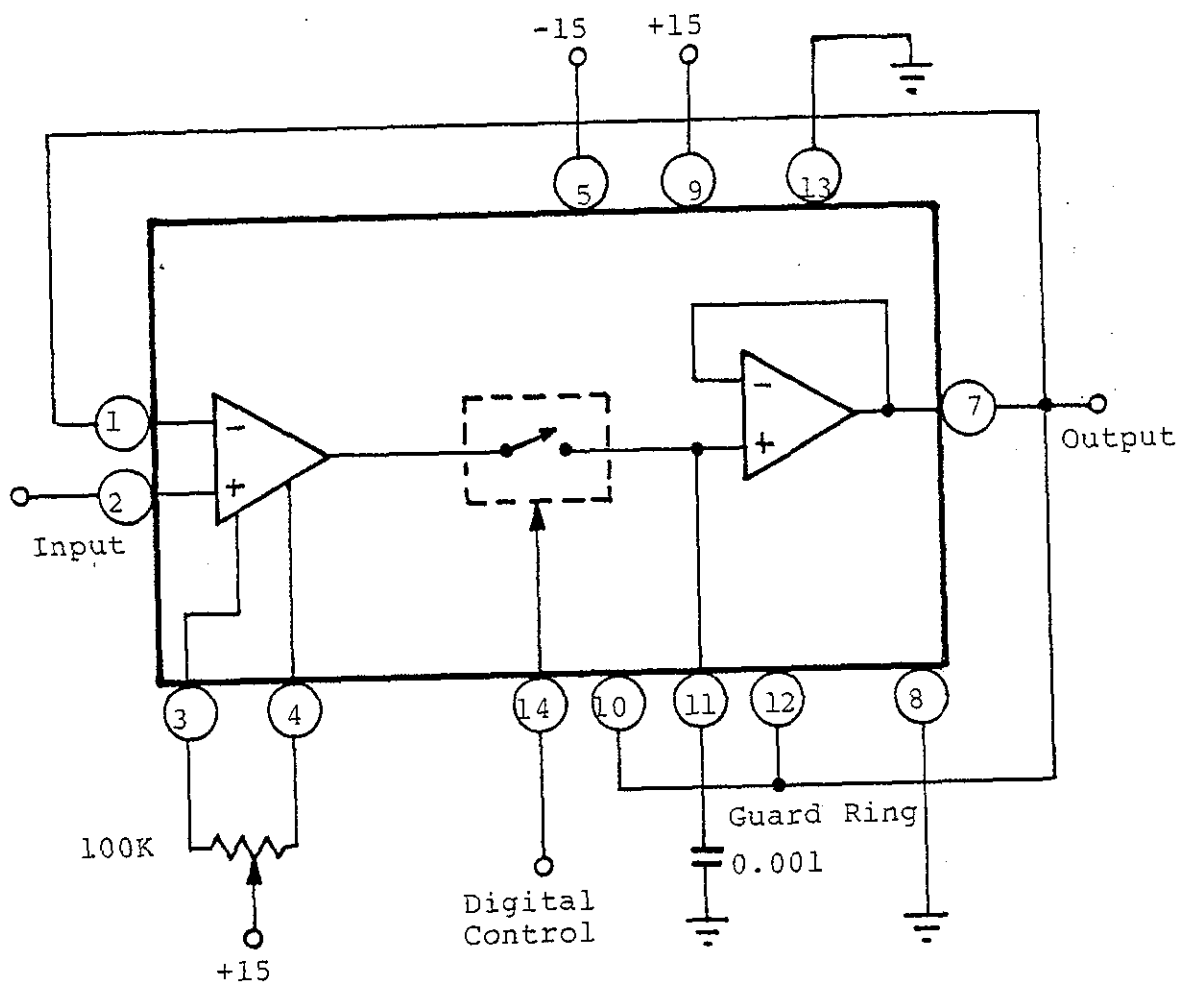


Figure 4-11 SAMPLE AND HOLD SUBSYSTEM

When the switch opens the unit is in the hold mode and retains a voltage on the capacitor for some period of time depending on capacitor and switch leakage. Sample and hold devices are characterized by a number of important parameters that must be considered in the design of a data acquisition subsystem.

1) Acquisition Time

The time lapse between the time that the sample command is given to the point where the output enters and remains within a specified error band around the input value is specified to be less than 4 microseconds time to transit from 0 to 0.1% of 10 Volts with $C = 0.001 \mu\text{f}$ [Ref. 4-10]. This implies that the control signals emanating from the central processor should allow at least 4 μs acquisition time prior to entering the hold mode. We note that the sample and hold subroutine (Appendix B) executes the instruction

IORI, R3 H'80' READY TO HOLD,

a two machine cycle instruction prior to sending the hold control signal. This instruction delays control signal transmission by $(2 \times 3 \mu\text{s}) = 6 \mu\text{s}$ allowing the sample and hold circuit ample time to settle with no appreciable error due to the acquisition time parameter.

2) Hold Mode Voltage Droop

The maximum change in output voltage as a function of time is specified to be 50 mv/sec maximum using a $0.001 \mu\text{f}$ polystyrene capacitor. Since the maximum total accumulated time to completion of the analog to digital conversion can be calculated as

5 Instructions (11 machine cycles)	= 33 μ s
1 Analog to Digital Conversion	= 20 μ s
3 Instructions if Conversion not synchronized with instructions (7 machine cycles)	= <u>21</u> μ s
	74 μ s

we can then compute droop error to be $50 \text{ mv/sec} \times (74 \times 10^{-6})$
 $\text{sec} = 3.73 \text{ mv.}$

3) Aperature Delay

The maximum time lapse between the time of hold signal receipt to opening of the switch is specified to be 50 nsec, an insignificant length of time in the instrument. There is therefore no error due to aperature delay.

4) Offset Error

Although the maximum offset error is specified to be 20 mv maximum [Ref. 4-10], the error was eliminated using the 100K trimpot offset adjustment. There was no appreciable offset error contribution due to the sample and hold circuit.

5) Gain Error

The gain error of a sample and hold circuit is apparent during the sample mode when the transfer function of the total amplifier deviates from the ideal unity slope condition (Fig. 4-12). In the noninverting unity gain mode, the specified gain error is $\pm 0.05\%$ maximum yielding a signal error of

$$(\pm 0.0005) \times 5.0 \text{ V} = 250 \text{ mV}$$

This error can, however, be eliminated with the gain

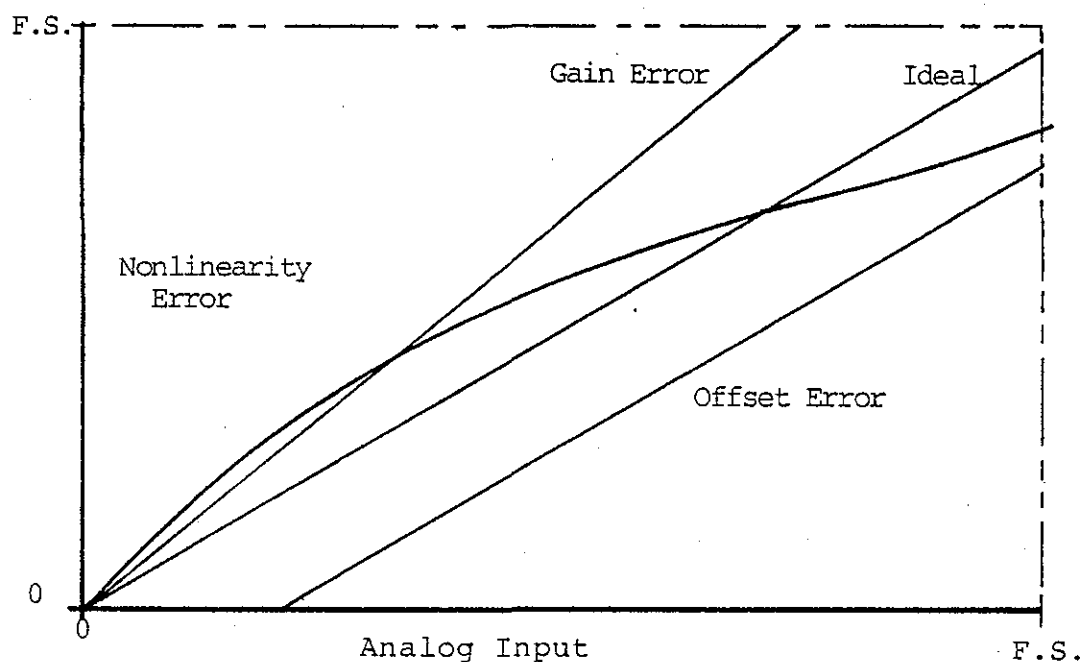


Fig. 4-12 GAIN, OFFSET AND LINEARITY ERRORS

adjustment available at the analog to digital converter. There will therefore be no appreciable net gain error due to the analog subsystem.

6) Nonlinearity Error

Nonlinearity error is apparent in the sample and hold circuit if the transfer function departs from a linear curve (Fig. 4-12). In the noninverting unity gain mode with a 0.001 μ f holding capacitor the maximum nonlinearity is 0.01% resulting in a worst case signal uncertainty of $(.0001) \times 2.5 \text{ Volts} = 25 \text{ mV}$.

7) Hold Mode Feedthrough

This error appears due to input signal appearing at the output when the unit is in the hold mode. Although the

feedthrough varies with signal frequency and the expected signal frequencies are substantially lower than the upper frequency limits of the sample and hold device (30 Hz max. versus several kiloHertz), we consider the worst case feedthrough of 0.01% [Ref. 4-10] or 25 mV.

D) Analog to Digital Converter Induced Errors

The A/D Converter selected for the solid state magnetic indicator instrument (Datel ADC-MA12B1B) [Ref. 4-11] uses the successive approximation technique to achieve excellent linearity and speed. Important parameters that potentially contribute errors are addressed below.

1) Resolution Error

The smallest analog change that can be distinguished by the A/D converter is

$$\text{Least Significant Bit (LSB)} = \frac{\text{Full Scale}}{2^n}$$

$$\text{LSB} = \frac{5}{2^{12}} = 1.22 \text{ mV}$$

this uncertainty manifests itself as an error in computing by limiting the precision of any calculation.

2) Linearity Error

The maximum deviation from a straight line drawn between the end points of the converter transfer function are specified in [Ref. 4-11] to be $\pm 1/2$ LSB (in our case ± 1.22 mV of analog signal).

3) Accuracy Error

The input to output error of the A/D converter is specified in [Ref. 4-11] to be $\pm 0.012\%$ F.S. $\pm 1/2$ LSB or

$$\pm(0.00012) \times 5.00V \pm 1.22 \text{ mV} = \pm 1.82 \text{ mV Worst Case}$$

In reality, the two error terms are unrelated and the

$$\text{Rss Error} = \pm [(.00012 \times 5V)^2 + (1.22\text{mV})^2]^{\frac{1}{2}}$$

$$\text{RSS Error} = \pm 1.36 \text{ mV}$$

4) Offset Error and Gain Error

Both the offset error and gain error were adjusted to zero using the trimming potentiometers (Fig. 4-7) and the calibration procedure outlined in Ref. 4-11. A reference signal of plus $1/2$ LSB (1.22 mV) was applied to the converter and the offset trimming potentiometer adjusted until the output flickered equally between logic "0" and logic "1". The gain was then adjusted by setting the converter input to full scale minus $1-1/2$ LSB (4.99817 Volts) and the gain trimming potentiometer was adjusted until the output flickered between logic "111...110" and logic "111...111". The above steps were repeated until no appreciable error in gain or offset was evident.

4-4 PROCESSING ERRORS

Errors in processing data accrue due to several sources including imprecision and truncation. Since the microprocessor selected for the instrument is inherently an eight bit device, single precision calculations are conducted with eight bits and double precision calculations are conducted with a total

of sixteen bits. This section addresses the effects of computational precision and truncation in the various subroutines and relates these to overall computational accuracy. The various subroutines are analyzed in chronological order as they appear in the main program.

A) Subroutine "SAMP"

The sample subroutine (delineated in Fig. 3-6a) selects and digitizes analog signals by controlling respective analog subsystem modules. During the first portion of this subroutine, A/D converter data bits are stored in two consecutive bytes⁷ in the computer memory. The A/D conversion precision of 12 bits is thereby preserved.

The second, third and fourth operations of the sample subroutine convert the unipolar binary format of the data to sign magnitude format, adds offset quantities and merely changes the signs of the Hx and Hy data. The operations are conducted in a double precision manner and precision of the data remains unaltered.

Correction of x axis orthogonality error is the final operation of the sample subroutine. Equation (3-1) is implemented at this point using a table lookup (for the sin function), multiplication and addition. The final result can be expressed as

$$Hx = Hx' + Hy \sin \epsilon$$

⁷A byte is accepted terminology for an eight bit data quantity.

where the respective quantities have the following forms

$$Hx^1 = x_1 + \sum_{i=1}^{11} a_i 2^i$$

$$Hy = x_2 + \sum_{j=1}^{11} a_j 2^j$$

$$\sin \epsilon = \sum_{k=1}^8 a_k 2^{-k}$$

and

x_1, x_2 are sign bits

$a_{i,j,k}$ equal 0 or 1 depending on whether the respective term is to exist or not

We can analyze the effects of imprecision and truncation by noting that the sin function has eight significant binary bits resulting in a resolution of $1/256$ or $90^\circ/256 = 0.352^\circ$.

The relative error in $\sin \epsilon$ is computed by Dahlquist [Ref. 4-12] as follows

let $\tilde{a}$ = the approximate value of $\sin \epsilon$
 a = the exact value of $\sin \epsilon$

then the relative error in $\tilde{a}$ is

$$(\tilde{a} - a)/a \text{ if } a \neq 0$$

Since data in the sin table has been truncated, maximum relative error can be as large as $\pm(1/2^{12})$ or $\pm 0.02\%$.

From the definition of relative error we obtain the following relationships between exact, estimate and estimated

relative error

$$\tilde{a} = a + ar = a(1 + r)$$

If a_1 , and a_2 have relative errors of $\pm 0.39\%$ and $\pm 0.02\%$, respectively, then

$$\begin{aligned}\tilde{a}_1 \tilde{a}_2 &= a_1(1 \pm 0.0039) a_2(1 \pm 0.00024) \\ &= a_1 a_2 (1 \pm 0.0039)(1 \pm 0.00024)\end{aligned}$$

Thus, the relative error in $\tilde{a}_1 \tilde{a}_2$ is

$$\begin{aligned}(1 \pm 0.0039)(1 \pm 0.00024) - 1 &= \\ \pm(0.0039) \pm(0.0039)(0.00024) \pm(0.00024) &= \\ \pm(0.0041) &\end{aligned}$$

Since the maximum value of $\sin \epsilon$ to be encountered occurs when the orthogonality error (ϵ) is 1 degree, $\sin \epsilon = 0.017$ maximum. The maximum value for H_y can be 0.6 gauss or 2048 units. Maximum error due to imprecision in the product $H_y \sin \epsilon$ is then

$$\begin{aligned}\text{Er Max} &= (2048 \times 0.017)(1 + .0041) - (2048 \times 0.017) \\ &= 0.1427 \text{ units}\end{aligned}$$

Since only the integer portion is retained in the final product, insignificant error can be attributed to imprecision of the $\sin \epsilon$ term in this case. Orthogonality error will be adequately corrected.

B) Subroutines ROTX and ROTY

These subroutines were developed in Chapter III and implement the equation of 2-11 required to compute horizontal

C-2

x and y magnetic field components. Equations to be implemented by the respective subroutines are

$$\begin{aligned} H_x = & H_{xm} \cos (\text{pitch}) + H_{ym} \sin (\text{pitch}) \sin (\text{roll}) \\ & + H_{zm} \sin (\text{pitch}) \cos (\text{roll}) \end{aligned} \quad (4-12)$$

and

$$H_y = H_{ym} \cos (\text{roll}) - H_{zm} \sin (\text{roll}) \quad (4-13)$$

where H_{xm} , H_{ym} and H_{zm} are measured field components made available from the magnetometer via the analog subsystem.

Since the transcendental functions are implemented using table lookup and are limited in precision to 8 bits, imprecision in these variables will dominate in generating error. In particular, the sin/cos terms will have relative error in the order of $\pm 1/256$ or $\pm 0.39\%$ while the measured field data has relative uncertainty of only $\pm 1/4096$ or $\pm 0.02\%$. Multiplications will result in addition of the bounds for the relative error as illustrated in section 4-4A above.

The transcendental terms above are limited in magnitude to 1.0 maximum while the field measurements can be 0.60 gauss max. In this case the individual product terms of (4-12) and (4-13) can have maximum errors of

$$E_r = (2048)(1 + 0.0041) - (2048) = 8.4 \text{ units}$$

Errors in H_y and H_x (4-12 and 4-13) will be maximum when roll and pitch are at 45 degrees and the fields are equal. In this case the error in H_y will be

$$EH_y = [(0.707)(2048)(1 + 0.0041) - (0.707)(2048)] - [(0.707)(2048)(1 - 0.0041) - (0.707)(2048)]$$

$$EH_y = 4.94 - 5.94 = 11.87 \text{ units}$$

Similarly, maximum error in H_x can be calculated as

$$EH_x = [(0.707)(2048)(1.0041) - (0.707)(2048)] \times 3$$

$$EH_x = 17.8 \text{ units maximum}$$

It should be noted that these error terms are worst case and peak at multiples of 45 degrees in yaw.

C) Subroutines COSY and SINY

These two subroutines compute the angle between the x axis sensor (when projected onto the horizontal plane) and the north-south horizontal vector of earth's magnetic field. The first two operations of these subroutines perform double precision multiplication and division. Since the data variables involved are 12 bits in length and the computations performed preserving 16 bits, no error is introduced.

The "ANGL" subroutine called by the above two subroutines computes the desired (x axis to horizontal vector) angle by completing an associative table look up procedure. The task required is to match a given data quantity either (H_x^2/H_h^2) or (H_y^2/H_h^2) with the contents of a memory cell. The address of this cell is then the required angle.

Since the table is limited in precision to 16 bits there are obviously cases where an interpolation is required to

ascertain the true address⁹. The function stored in tabular form is $\cos^2\theta$ where θ varies from 45 to 90 degrees. Maximum error will therefore be induced while attempting to locate solutions (angles near 90 degrees if inadequate precision is provided. Error in this region due to resolution of tabular data can be examined by noting the entries in Table 4-8

θ	$\cos^2\theta$	Most Significant Binary Bit (2^{-x})
90	0	-
89	0.000305	12
88	0.001218	9
87	0.00274	8

Table 4-8 $\cos^2\theta$ AND MOST SIGNIFICANT BINARY DIGITS

provided to indicate the relative magnitudes of $\cos^2\theta$ in the region of $\theta = 90$ degrees. We observe that the most significant binary digit affected at 89 degrees is binary decimal digit 12 implying that the resolution of H_x^2/H_h^2 or H_y^2/H_h^2 (the argument of $\cos^2\theta$) must be accurate to at least $1/2^{12}$ or 0.024%.

Considering the horizontal field of earth's magnetic vector as observed in laboratory experimentation at this latitude, we note that H_h is 730 units. At a heading of 89 degrees, $H_x = 730 \cos 89 = 12.7$ units. The argument would therefore be

$$\text{ARG} = H_x^2/H_h^2 = \frac{(12.7)^2}{(730)^2} = 0.000305$$

⁹The procedure determines the relative address by linear interpolation, then selects the closest address as the required angle for the solution.

Since, the squaring and division operations are conducted in double precision, precision is preserved and the algorithm should be able to resolve heading to at least one degree over all portions of the compass.

D) Errors Due to the Remaining Subroutines

Since all of the remaining subroutines work with data that has been rounded to a precision representing 1 degree or better and the computations involve addition or subtraction in double precision binary or binary coded decimal (BCD) format, we note that there will be no further appreciable error due to truncation or rounding.

4-5 MEASUREMENT ERROR SUMMARY

Errors due to sensors and measurement of their respective outputs were discussed in sections 4-2 and 4-3 above. Before proceeding with the analysis of errors, the total signal inaccuracy due to contribution from the many sources above will be summarized in Table 4-10. Total instrument error can then be computed by considering the propagation and enhancement of these errors during the computation process.

Since the errors in Table 4-9 are stochastically independent, we can compute error for any given signal level by finding the RSS of respective error sources. In this manner, the instrument error can be evaluated by considering all input signals with errors superimposed to produce an erroneous computation of heading.

PARAMETER	ERROR	COMMENT
1. Magnetometer		
Offset	≈ 0	Corrected by software
Orthogonality	≈ 0	Corrected by software
Noise	Negligible	
Gain	$\pm 0.01\%$	Proport. to signal level
Linearity	$\pm 0.01\%$	
2. Analog Subsystem		
Sampling	Negligible	Sampling rate & filtering adequate
Multiplexer		
Transfer Accuracy	$\pm 0.01\%$	Proport. to signal level
Settling Time	≈ 0	
Rate	≈ 0	
Input Leakage	≈ 0	
Sample and Hold		
Acquisition	≈ 0	
Hold	4mV	
Aperture Delay	≈ 0	
Offset	≈ 0	Corrected by software
Gain	≈ 0	Corrected by software
Nonlinearity	$\pm 0.01\%$	Proport. to signal level
Feedthrough	$\pm 0.01\%$	Proport. to signal level and frequency
A/D Converter		
Resolution	$\pm 1.2\text{mV}$	
Accuracy	$\pm 1.4\text{mV}$	
Offset	≈ 0	
Gain	≈ 0	

Table 4-9 SENSOR AND ANALOG SUBSYSTEM ERROR SUMMARY

4-6 SAMPLE ERROR ANALYSIS

Orthogonality correction using the algorithmic method can be verified by computing expected error prior to correction and comparing measured system output with the error prediction. Assuming that the angle between the x and y sensors exceeds 90 degrees as in Fig. 4-13, we can proceed to compute error by noting the following relationships

$$\begin{aligned} H_x &= H_h \cos (+\psi) \\ H_y &= H_h \sin (\psi) \\ H_{x_1} &= H_x \cos \epsilon - H_y \sin \epsilon \\ \text{True Yaw} = \psi_T &= \cos^{-1} \left(\frac{H_x}{(H_x^2 + H_y^2)^{\frac{1}{2}}} \right) \end{aligned}$$

Computed yaw

$$\begin{aligned} \psi_m &= \cos^{-1} \left[\frac{H_x \cos \epsilon - H_y \sin \epsilon}{(H_x \cos \epsilon - H_y \sin \epsilon)^2 + H_y^2)^{\frac{1}{2}}} \right] \\ &= \cos^{-1} \left[\frac{H_h \cos \psi \cos \epsilon - H_h \sin \psi \sin \epsilon}{[(H_h \cos \psi \cos \epsilon - H_h \sin \psi \sin \epsilon)^2 + H_h^2 \sin^2 \psi]^{\frac{1}{2}}} \right] \end{aligned}$$

Using small angle approximations with $\epsilon \approx 0.79^\circ$

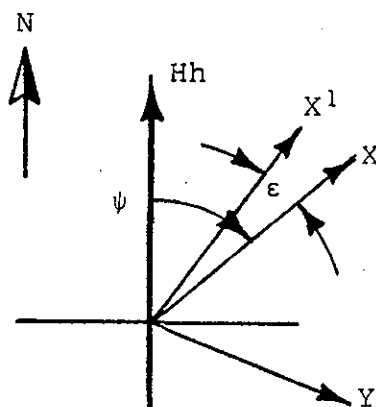
$$\cos \epsilon \approx 1 \text{ and } \sin \epsilon \approx 0.014$$

then

$$\psi_m = \cos^{-1} \left[\frac{H_h \cos \psi - 0.014 \sin \psi}{[H_h^2 (\cos \psi - 0.014 \sin \psi)^2 + H_h^2 \sin^2 \psi]^{\frac{1}{2}}} \right]$$

Computed error

$$\text{Error} = \psi_m - \psi$$

Fig. 4-13 ANGLE $(X - Y) > 90^\circ$

We can now evaluate computed yaw angle (ψ_m) given a particular yaw (ψ) and the horizontal field vector (Hh). Heading error for horizontal field vector of 730 units at various yaw angles with pitch and roll angles of zero degrees is tabulated in Table 4-10 and plotted along with actual measured yaw error (data taken during experimentation of Chapter V) in Fig. 4-14.

Heading (Degrees)	Computed Error (Degrees)	Heading (Degrees)	Computed Error (Degrees)
90	0.8	290	0.7
70	0.7	270	0.8
50	0.5	250	0.7
30	0.2	230	0.5
10	0.0	210	0.2
350	0.0	190	0.0
330	0.2	170	0.0
310	0.5	150	0.2
		130	0.5

Table 4-10 COMPUTED HEADING ERROR WITH $Hh = 730$ UNITS

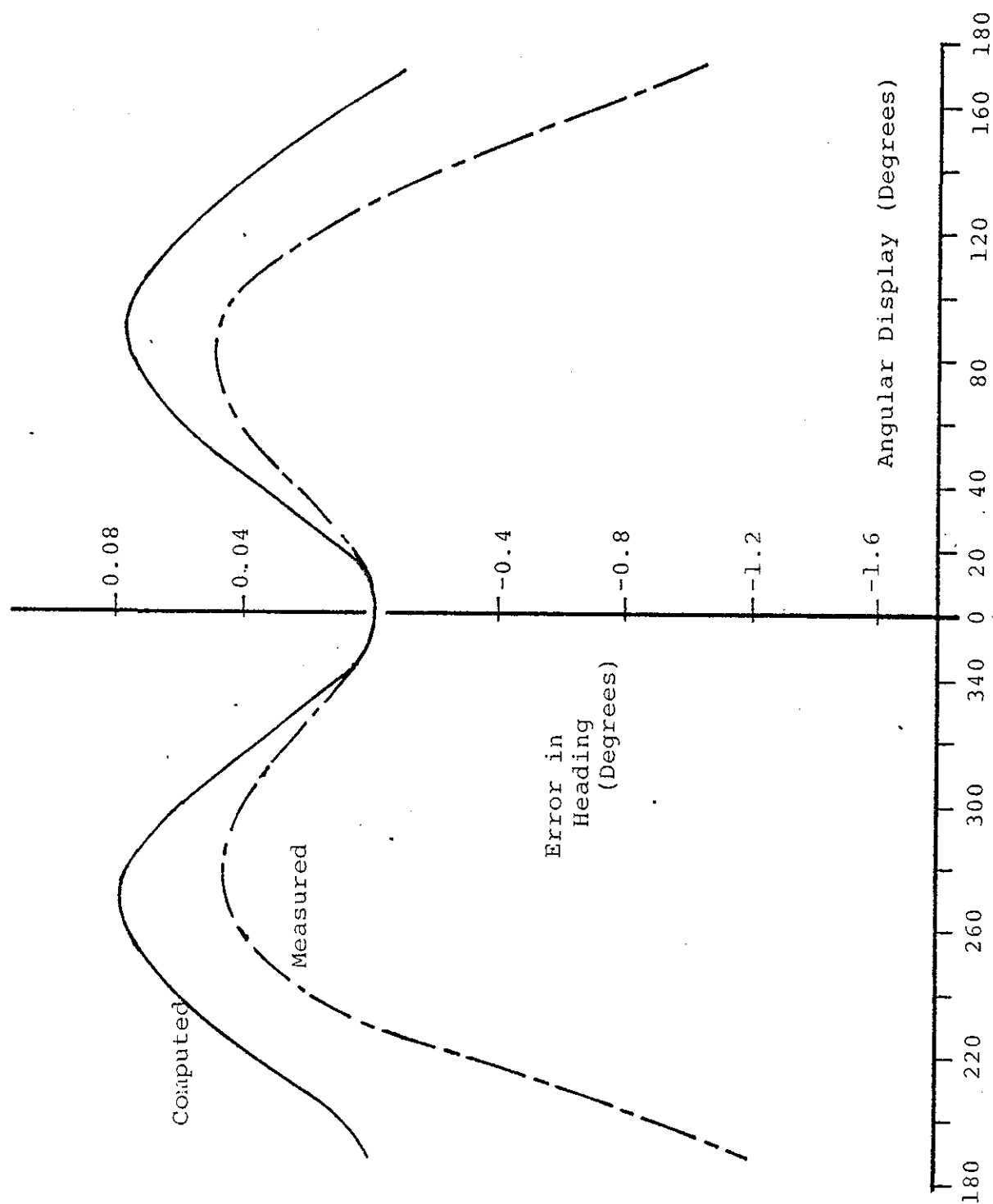


Fig. 4-14 COMPARISON OF COMPUTED AND MEASURED ORTHOGONALITY INDUCED ERROR

4-7 CONCLUSIONS

The preceeding error analysis has identified potential error sources along with relative magnitudes of error to be expected. Magnetometer sensor and analog subsystem errors were identified and analyzed individually. During this analysis it became apparent that errors due to sensor offset and nonorthogonality dominated and would severely limit total instrument performance. The relative magnitudes of these errors and their mode of contribution would have degraded system capacity.

By carefully characterizing the offset and orthogonality error it was determined that these systematic errors could be reduced by appropriate programming. A need to identify the extent of each error unique to the laboratory instrument imposed a need to evaluate the instrument empirically. Using earth's magnetic field and the laboratory test fixture (described in Chapter V) to provide control inputs each of the parameters was identified and measured. An algorithm with the empirically determined correction coefficients was included in the final system to reduce the error and to improve final system performance. The remaining potential error sources were tabulated and relative magnitudes noted.

Processing errors due to register precision and truncation were analyzed by considering pertinent subroutines individually. It was noted that the relative error bounds add when multiplying variables with relative error. In addition, it was noted that error accrued during processing is proportional to sensor signal levels involved. The final uncertainty is then proportional to actual aircraft attitude with error increasing as displacement from level flight occurs. Computational error is also noted to increase at particular headings causing the error function to peak at specific yaw angles.

The sample error analysis clearly shows that a correlation between sensor nonorthogonality induced error and measured (uncorrected) data exists. By predicting and computing an error function prior to experimentally verifying the result we gain confidence that the sensor characteristics derived empirically in previous sections are correct.

CHAPTER V

LABORATORY EVALUATION OF THE ATTITUDE INDEPENDENT
REMOTE MAGNETIC INDICATOR AND HEADING INSTRUMENT

5-1 INTRODUCTION

This chapter addresses laboratory evaluation of the microprocessor based computer designed to implement the heading measurement instrument. An integral part of this instrument was the three axis fluxgate magnetometer used to implement the attitude independent remote magnetic indicator of Chapter II. The laboratory evaluation was designed to investigate empirically the effects of physical parameters that would otherwise be impossible to assess.

Although phenomena such as noise, magnetic field gradient, sensor orthogonality errors and offset errors can be predicated, combined effects on the proposed instrument and remote magnetic indicator are best evaluated in the laboratory. In addition, it was noted that errors due to sensor offset and nonorthogonality could be corrected by software included with the sample subroutine. Determination of the effectiveness of this correction technique necessitated laboratory measurements of the errors (to determine correction constants) and comparison of data prior to and following corrections.

The chapter begins by discussing laboratory test apparatus designed to evaluate the instrument. Actual data measured and recorded during experimentation is then presented in both tabular and graphic form to facilitate comparison and evaluation. Finally, the laboratory data is discussed and it is concluded that the remote magnetic indicator used with the heading measurement instrument results in a viable alternative to conventional heading measurement systems. The microprocessor based

computer implementation of the instrument has added unique sensor measurement correction ability that enhances performance of otherwise marginal sensors. In this manner limitations in systems performance that now exist due to sensor inadequacy can be minimized without incurring the burden of using more expensive sensors.

5-2 TEST APPARATUS

A) Electronic Subsystem

The microprocessor based computer (illustrated in photos 5-1 and 5-2) was constructed on printed circuit boards consisting of a central processing card, two memory cards (2K bytes capacity each) and an output board. A separate analog subsystem card contained the multiplexer, sample and hold, analog to digital converter and trimming potentiometers. The circuit cards were all organized with edge connectors and mounted vertically into a hand wired backplane assembly as shown in photos 5-1 and 5-2.

The card in the left foreground of photo 5-1 served as the output display with three seven-segment displays displaying significant figures of system heading. A small printed circuit in the right foreground of photo 5-1 contained potentiometers used to generate analog signals proportional to roll and pitch signals (simulating gyroscope outputs). Cards shown vertically mounted in photo 5-2 can be identified from right to left as the analog subsystem, two memory cards and the central processing card. The large integrated circuit shown on the CPU card is the Signetics 2640 microprocessor.

B) Sensor Assembly

To evaluate the effects of combined aircraft pitch, roll

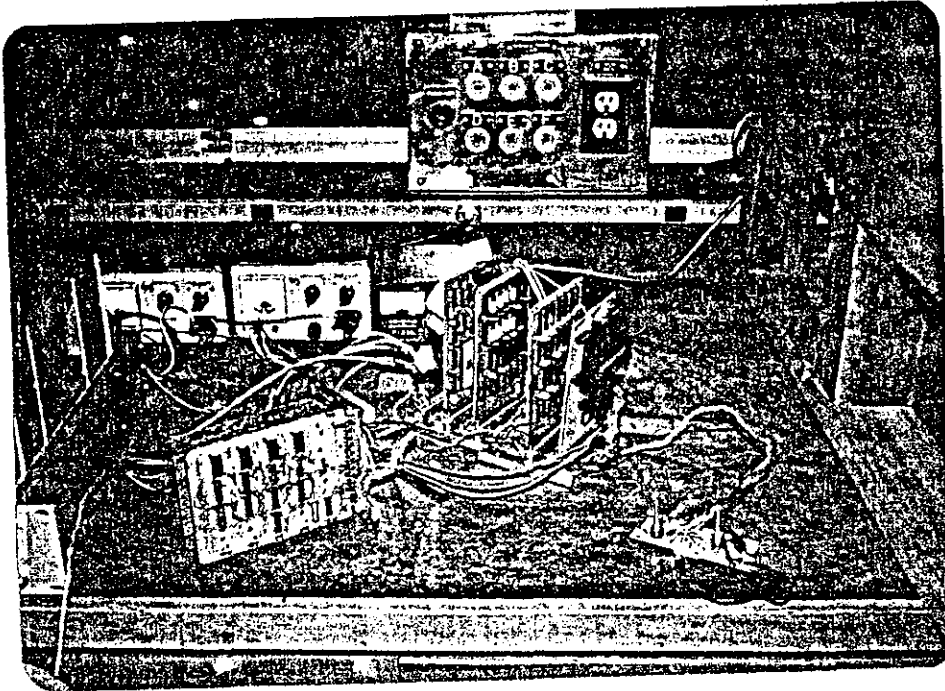


Photo 5-1 MICROPROCESSOR BASED HEADING COMPUTER

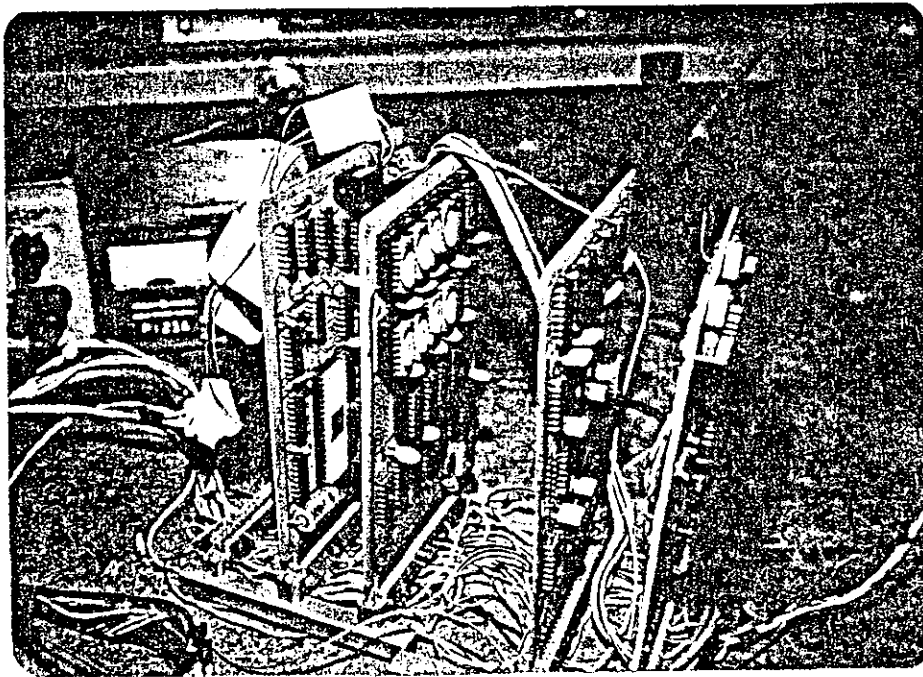


Photo 5-2 CENTRAL PROCESSOR, MEMORY AND
ANALOG SUBSYSTEM

and yaw a three axis gimbal apparatus was required. In addition, since angular measurements were required, a means of measuring angular rotation in each of the three axes was provided. The gimbal apparatus as illustrated in photos 5-3 and 5-4 was fitted with large protractors centered on the rotation axes. Pointers were provided to enable angular rotation measurements on the respective protractor scales. Since the angular precision on each protractor scale resolved angular position to 0.5 degrees, angular measurements to a resolution of at least 0.5 degrees were possible. Angular position was measured by estimating the decimal place of each measurement with accuracy to ± 0.5 degrees ensured.

Since the three axis magnetometer (housed in the rectangular block of photos 5-3 and 5-4) measured ambient magnetic fields the test apparatus was constructed of nonferrous material. This ensured that local fields due to residual magnetic fields in the test apparatus would be minimized. In addition, since the material had low permeability, there would be little deformation of the local field causing error due to changing field gradient.

The sensor package shown in photos 5-3 and 5-4 was physically mounted such that the sensors were centered as close to the center of the gimbal as possible. This precaution ensured that measurement error due to sensor translation was minimized¹. During instrument evaluation, the entire gimbal assembly and sensor were leveled and mounted in a Helmholtz coil assembly as illustrated in photo 5-5. Although the coils were not activated during experimentation, the rotations in heading were

¹Since the local magnetic field has a nonzero gradient, field measurements include a component due to translation of the sensor axes. This component of measurement produces unacceptable error in a system designed to measure field components that change due to rotation.

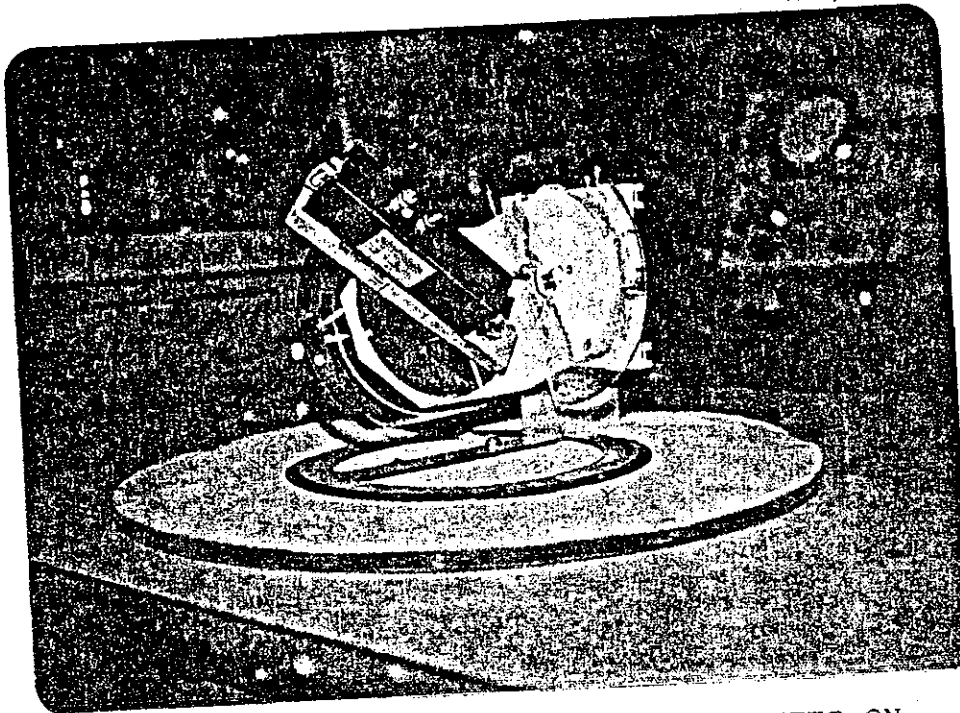


Photo 5-3 MAGNETOMETER SENSOR MOUNTED ON
GIMBALLED TEST FIXTURE

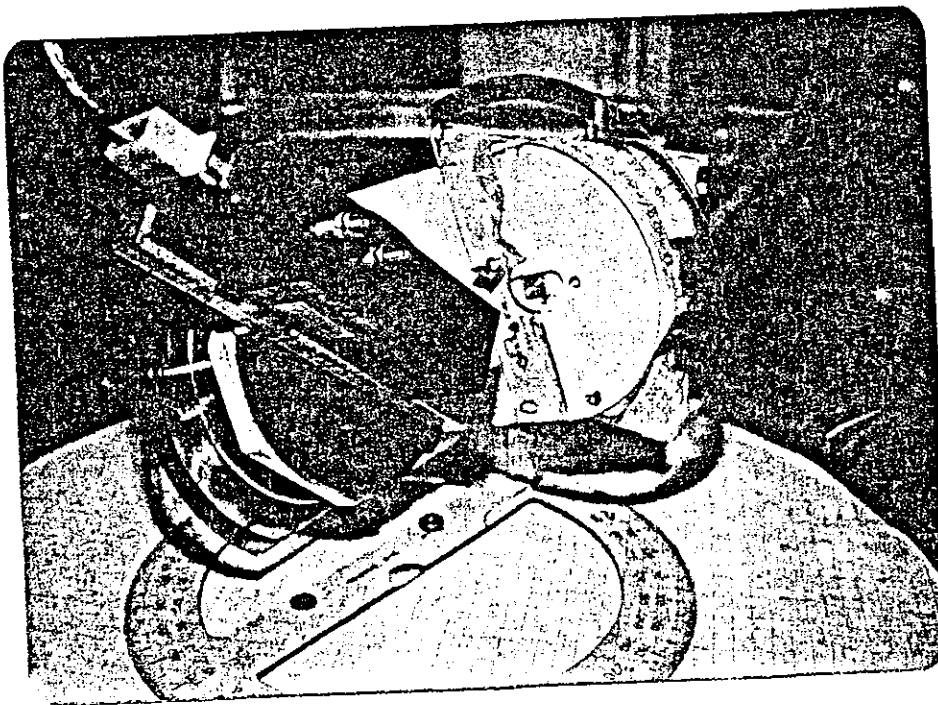


Photo 5-4 SENSOR AND GIMBAL ASSEMBLY WITH PROTRACTORS

carefully controlled since the gimbal assembly was an integral part of the Helmholtz coil fixture with the vertical rotation axis serving as the system yaw axis.

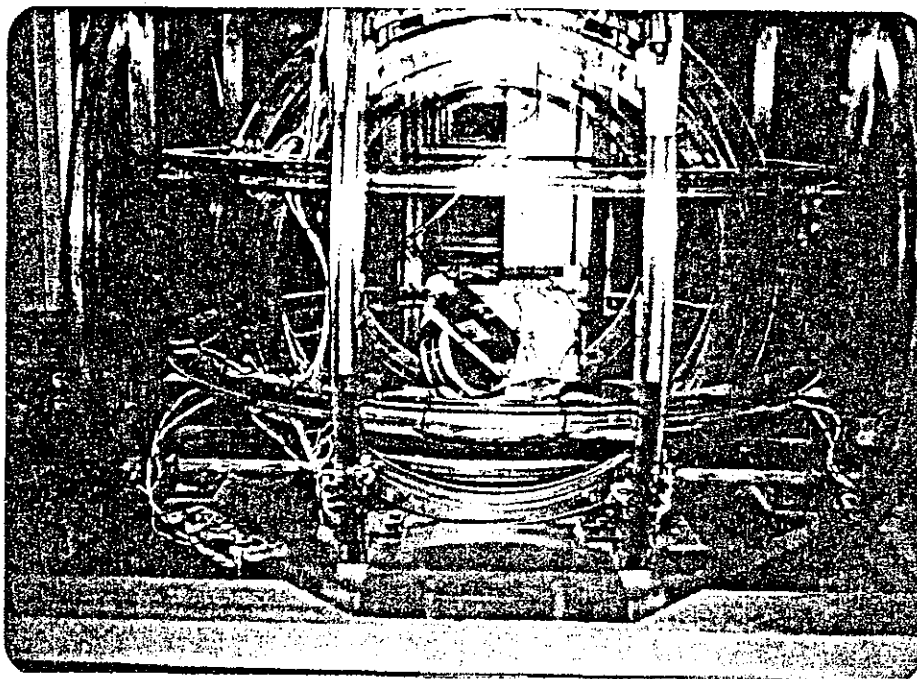


Photo 5-5 TEST FIXTURE MOUNTED IN HELMHOLTZ COIL ASSEMBLY

5-3 HEADING MEASUREMENTS WITH NO OFFSET CORRECTION

By maintaining heading of the test fixture constant (no rotation about the vertical axis) and varying both pitch and roll angle, the instrument display was observed to vary. This variation gave a direct measure of instrument error since a constant heading was maintained and a constant display was to be expected.

Data variations were recorded in Tables 5-1 and 5-2 and plotted on Figures 5-1 and 5-2. With only ± 10 degree variation in pitch combined with ± 30 degree variation in roll we note that the heading display varies 14 degrees. Obviously,

Roll Angle (Degrees)	$\theta = 0^\circ$	$\theta = 10^\circ$	$\theta = -10^\circ$
-30	000	353	4
-20	000	354	2
-10	359	357	0
0	359	359	358
10	359	000	355
20	358	002	354
30	358	004	353

Table 5-1 HEADING COMPUTED AT A FIXED YAW ANGLE
WITH NO OFFSET CORRECTION

Roll Angle (Degrees)	$\theta = 0^\circ$	$\theta = 10^\circ$	$\theta = -10^\circ$
-30	46	52	38
-20	45	49	41
-10	45	47	43
0	45	45	43
10	45	43	46
20	44	42	47
30	44	41	49

Table 5-2 HEADING COMPUTED AT A FIXED YAW ANGLE
WITH NO OFFSET CORRECTION

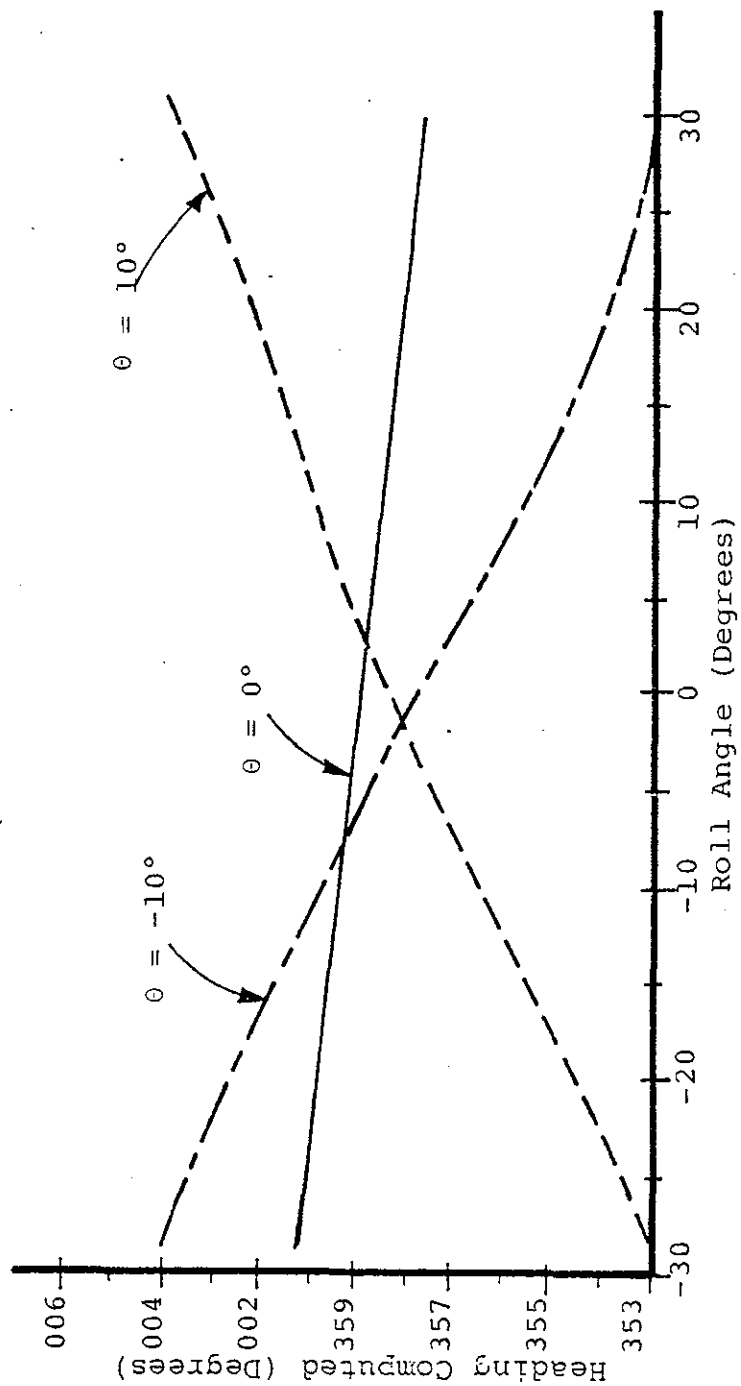


Fig. 5-1 HEADING COMPUTED AT A FIXED YAW ANGLE WITH VARYING θ AND ϕ (NO OFFSET CORRECTION)

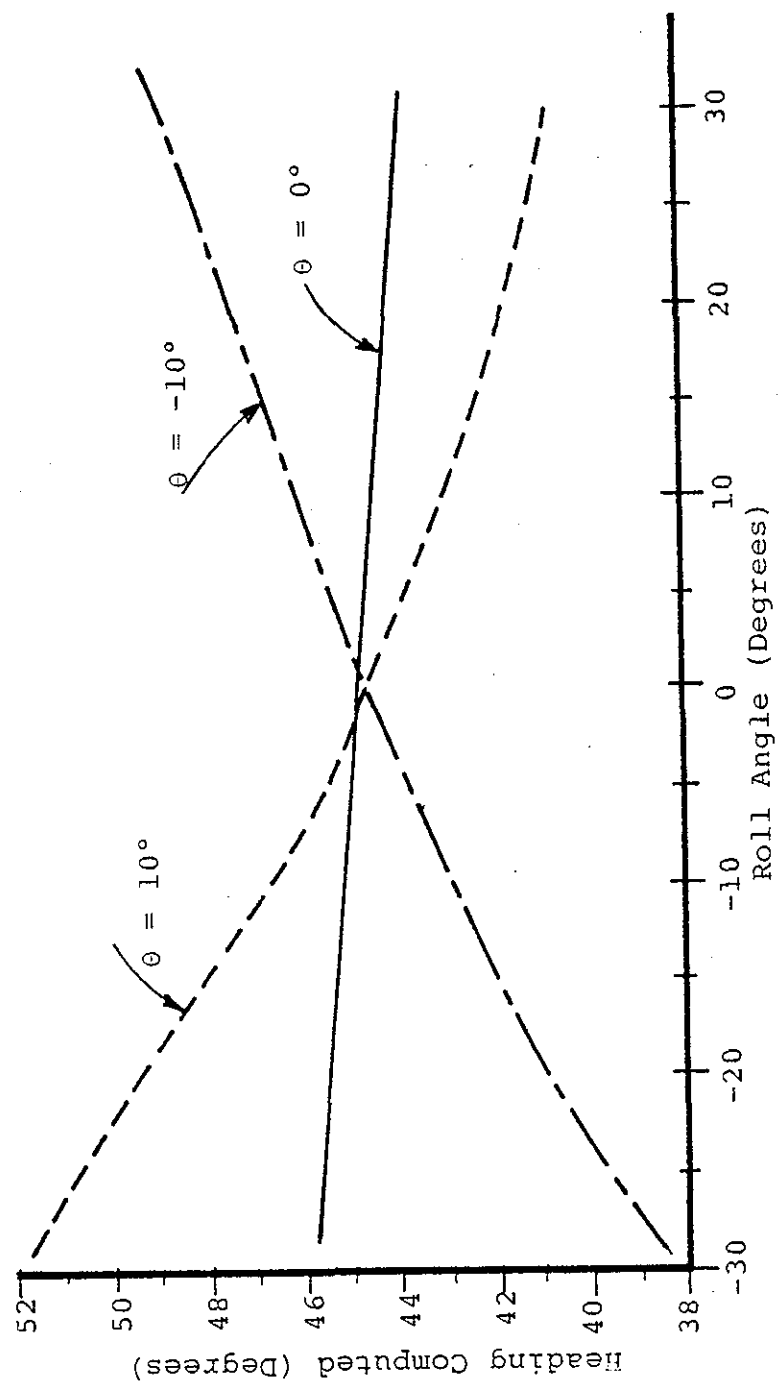


Fig. 5-2 HEADING COMPUTED AT A FIXED YAW ANGLE WITH VARYING
 θ AND ϕ (NO OFFSET CORRECTION)

instrument operation indicated excessive error requiring more elaborate sensors or correction of a sensor inadequacy.

5-4 HEADING MEASUREMENTS TO INVESTIGATE ORTHOGONALITY ERROR

System performance was evaluated by initially aligning the sensors with zero pitch and roll angle. Sensor Z was positioned vertically with positive direction downwards. By observing the Z axis output² as the test fixture was rotated about the vertical axis, adjustments were made in pitch and roll angle to minimize coning of the Z axis. Angular measurements on the respective roll and pitch axis protractors were then made to establish the initial reference attitude angles.

Heading measurement accuracy was evaluated by rotating the test fixture in the horizontal plane until the display flickered between (XX9) and (XX9+1). The rotation was then continued a very small amount until a steady display (multiple of 10 degrees) was observed³. Measurements ranging from 0 to 350 degrees were made by recording angular position required to produce specific heading data displays. Sets of data were recorded at various combinations of pitch and roll then tabulated in Tables 5-3 through 5-8. Relative error was computed by determining angular position expected at each display value and then computing the difference in angular positions. Errors at the roll extremes of ± 44 degrees are plotted for pitch angles of plus and minus 20 degrees on Fig. 5-3 through 5-6 inclusive.

²A special subroutine was used to display Z axis data directly in BCD format on the seven bar output display.

³This measurement technique ensured that all heading measurements were made identically. In addition, error due to system imprecision was reduced.

Data in Tables 5-5, 5-6 and Fig. 5-3, 5-4 were recorded with no sensor orthogonality error correction implemented. Data in Tables 5-7, 5-8 and Fig. 5-5, 5-6 was recorded with the sensor orthogonality correction implemented. Comparison of these data indicate that considerable improvement in accuracy is achieved by correcting sensor orthogonality error.

5-5 CONCLUSIONS

Laboratory evaluation of the heading measurement instrument has shown that the algorithms developed in previous chapters are viable. Operation of the device in a laboratory environment has enabled empirical evaluation of the system under adverse combinations of noise, field gradient and sensor plus instrument error sources.

Test apparatus described in section 5-2 served to enable controlled simulation of roll, pitch and yaw rotations. The apparatus was nonmagnetic in nature and contributed insignificant error due to field perturbation. Mounting of protractors and pointers on the test apparatus made angular measurements possible to a precision of at least ± 0.5 degrees.

Effects of sensor offsets were evaluated in section 5-3 by recording system heading computations when only roll and pitch varied. Since the variations in Figures 5-1 and 5-2 prior to offset correction exceed the maximum excursions of Figures 5-3 and 5-4 by at least a factor of two (angular excursions in first set also less than in the record) and we note that offset errors were corrected prior to recording data in the second set of data, we conclude that offset in magnetometers can be a

PITCH ANGLE 0 DEGREES
ROLL ANGLE 0 DEGREES

Heading Displayed (Degrees)	Angular Position (Degrees)	Relative Error (Degrees)
10	275.3	0.3
30	295.2	0.2
50	315.4	0.4
70	335.5	0.5
90	355.5	0.5
130	34.8	-0.2
150	54.3	-0.7
170	74.0	-1.0
190	94.0	-1.0
210	114.4	-0.6
230	135.0	0.0
250	155.5	0.5
270	174.7	-0.3
290	195.5	0.5
310	215.2	0.2
330	235.2	0.2
350	254.7	-0.3

Table 5-3 REFERENCE DATA MEASUREMENTS OF HEADING
TAKEN WITH NO ORTHOGONALITY CORRECTION

PITCH ANGLE 0 DEGREES

ROLL ANGLE 0 DEGREES

Heading Displayed (Degrees)	Angular Position (Degrees)	Relative Error (Degrees)
10	276.6	-0.4
30	296.6	-0.4
40	306.7	-0.3
50	316.7	-0.3
60	327.2	+0.2
70	337.0	0.0
90	355.9	-1.1
130	37.0	0.0
160	67.2	0.2
190	96.8	-0.2
220	126.9	-0.1
250	157.0	0.0
280	186.9	-0.1
310	216.6	-0.4
340	246.9	-0.1
350	256.4	-0.6

Table 5-4 HEADING MEASUREMENTS WITH OFFSET AND
ORTHOGONALITY CORRECTIONS MADE

Heading Displayed (Degrees)	Roll = 44°		Roll = 20°		Roll = -20°		Roll = -44°	
	Angular Position	Error	Angular Position	Error	Angular Position	Error	Angular Position	Error
10	276.3	1.3	276.5	1.5	275.0	0.0	274.0	-1.0
30	296.3	1.3					293.6	-1.4
40			306.1	1.1	304.0	-1.0		
50							313.8	-1.2
60	325.8	0.8						
70			335.6	1.6	334.3	-0.7	333.8	-1.2
90	355.0	0.0	354.0	-1.0	353.1	-1.9	353.0	-2.0
130	34.3	0.7	34.3	-0.7	34.6	-0.4	34.4	-0.6
160	64.5	-0.5	64.0	-1.0	65.0	0.0	65.0	0.0
190	94.3	-0.7	94.6	-0.4	95.0	0.0	95.5	0.5
220	125.2	0.2	125.3	0.3	126.0	1.0	126.5	1.5
250	156.6	1.6	156.2	1.2	156.7	1.7	157.0	2.0
280	186.6	1.6	186.8	1.8	186.5	1.5		
310	216.8	1.8	216.8	1.8	215.9	0.9	215.9	0.9
340	246.0	1.0	246.8	1.8	245.0	0.0		
350							224.9	-0.1

TABLE 5-5 HEADING MEASUREMENTS AT PITCH = 20° WITH NO
ORTHOgonALITY CORRECTION

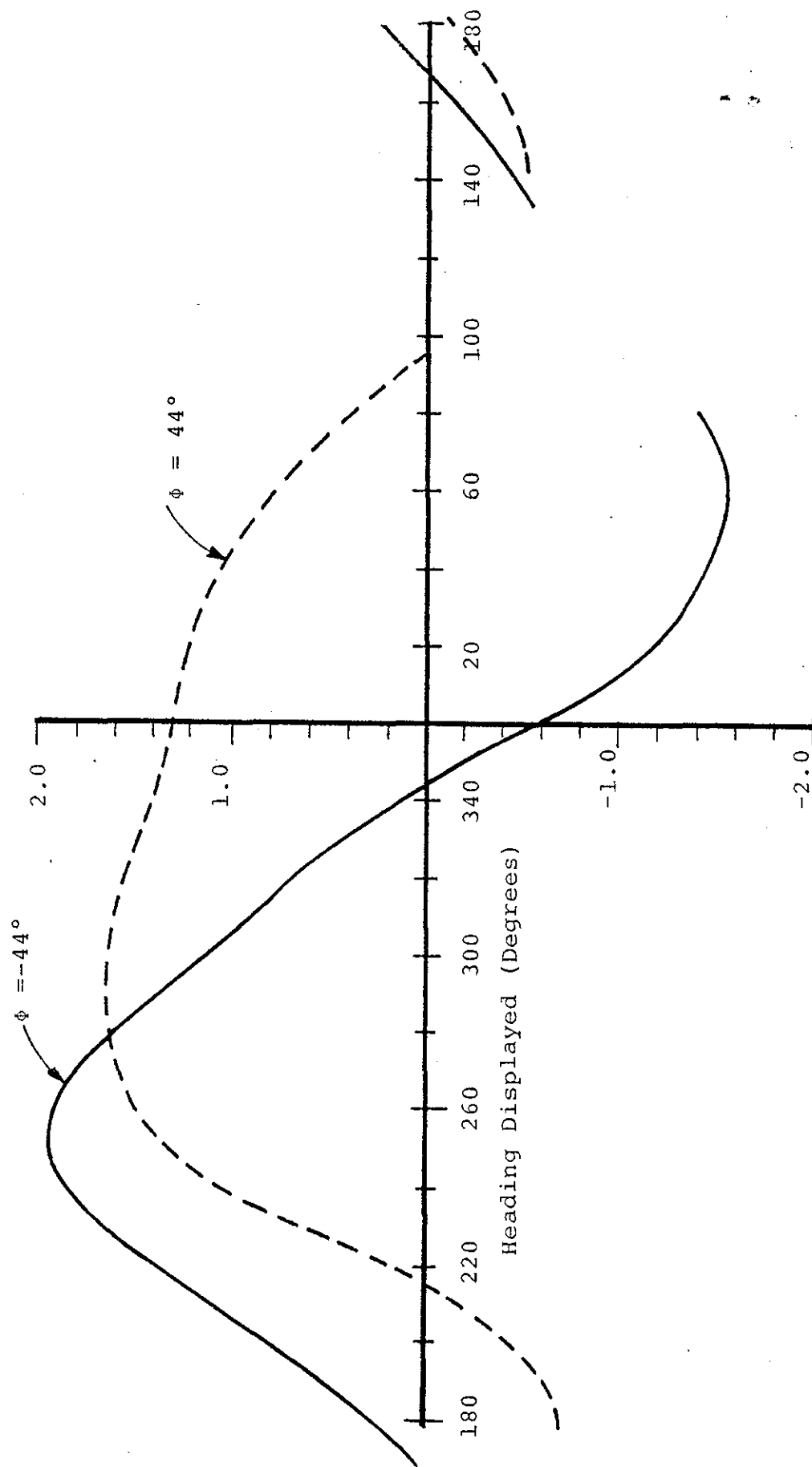


Fig. 5-3 HEADING MEASUREMENT ERROR AT PITCH = 20°
(NO ORTHOGONALITY CORRECTION)

Heading Displayed (Degrees)	Roll = 44°		Roll = 20°		Roll = -20°		Roll = -44°	
	Angular Position	Error	Angular Position	Error	Angular Position	Error	Angular Position	Error
10	276.1	1.1	275.1	0.1	274.2	-0.8	273.7	-1.3
30	296.2	1.2	295.9	0.9			293.6	-1.4
50	316.4	1.4	316.1	1.1			314.1	-0.9
70	336.5	1.5	336.4	1.4	335.5	0.5	334.6	-0.4
90	355.5	0.5	355.3	0.3	355.0	0.0	354.2	-0.8
130	36.0	1.0	36.4	1.4	135.7	0.7	135.7	0.7
150	55.3	0.3	55.9	0.9			55.8	0.8
170	74.5	-0.5	75.6	0.6			75.5	0.5
190	94.9	-0.1	95.3	0.3	95.5	0.5	95.5	0.5
210	115.0	0.0	115.4	0.4			115.6	0.6
220					125.5	0.5		
230	135.0	0.0	135.6	0.6			136.0	1.0
250	155.6	0.6	155.4	0.4	155.5	0.5	155.7	0.7
270	174.8	-0.2	174.8	-0.2			175.0	0.0
290	195.6	0.6	195.4	0.4			195.3	0.3
310	215.5	0.5	215.3	0.3	214.6	-0.4	214.5	-0.5
330	235.7	0.7	235.1	0.1			234.2	-0.8
350	255.6	0.6	255.2	0.2			253.8	-1.2

Table 5-6 HEADING MEASUREMENTS AT PITCH = -20°
WITH NO ORTHOGONALITY CORRECTION

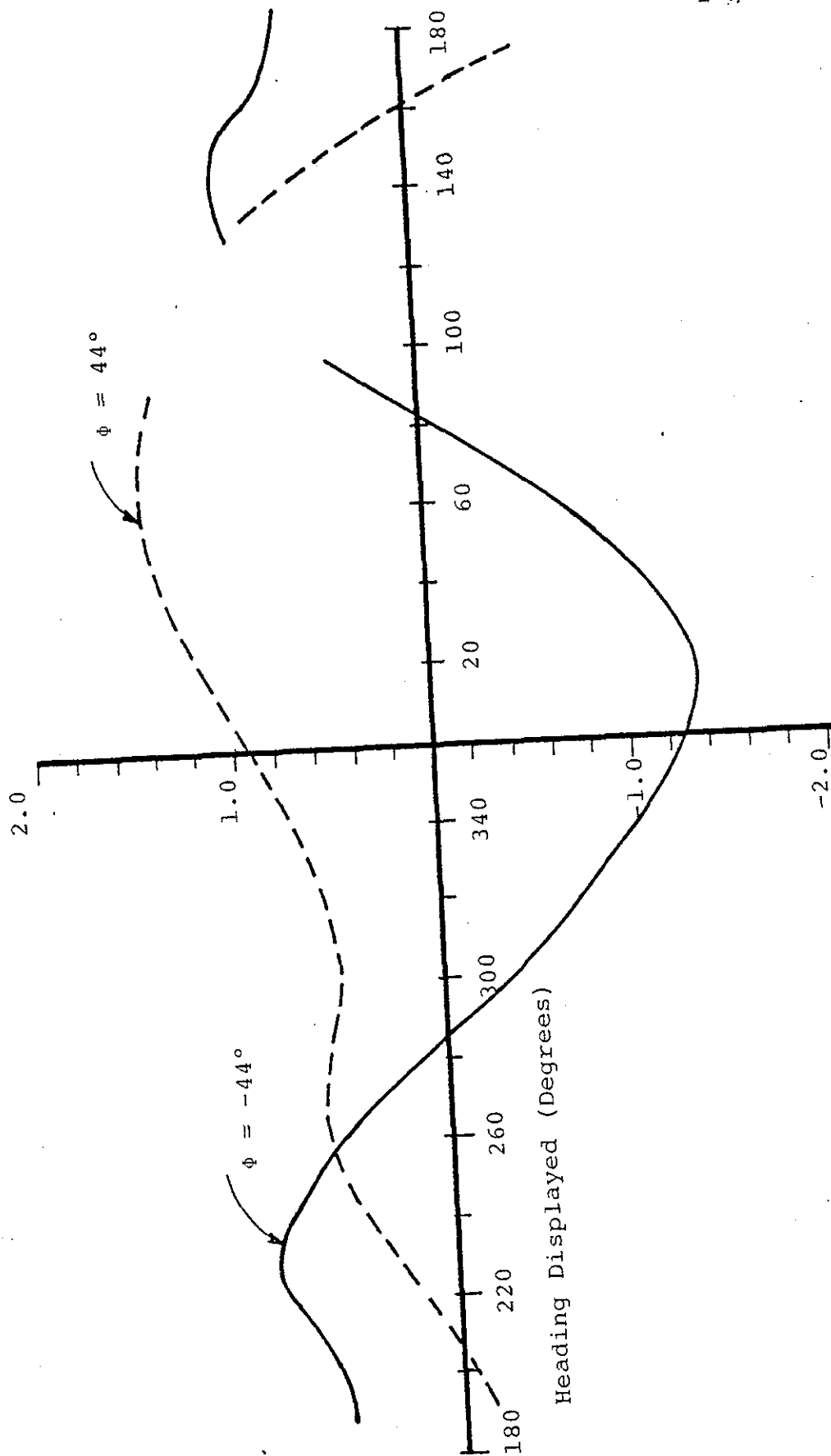


Fig. 5-4 HEADING MEASUREMENT ERROR AT PITCH = -20°
(NO ORTHOGONALITY CORRECTION)

Heading Displayed (Degrees)	Roll = 0°		Roll = 44°		Roll = -44°	
	Angular Position	Error	Angular Position	Error	Angular Position	Error
20	287.3	0.3	287.5	0.3	286.3	-0.7
40	307.2	0.2	307.5	0.3	306.0	-1.0
60	327.0	0.0	327.9	0.7	325.9	-1.1
80	346.3	-0.7	347.5	0.3	345.6	-1.4
90	355.9	-1.1	357.0	0.2	356.2	-1.8
140	46.9	-0.1	47.0	-0.2	46.5	-0.5
160	67.0	0.0	67.3	0.1	67.1	0.1
180	86.6	-0.4	86.5	-0.7	87.0	0.0
200	107.0	0.0	107.3	0.1	108.1	1.1
220	127.6	0.6	127.3	0.1	128.3	1.2
240	147.2	0.2	147.4	0.2	148.5	1.5
260	167.0	0.0	167.1	-0.1	168.5	1.5
280	187.3	0.3	187.1	-0.1	188.5	1.5
300	207.2	0.2	207.1	-0.1	208.0	1.0
320	227.3	0.3	227.0	-0.2	227.5	0.5
340	247.4	0.4	247.3	+0.1	247.4	0.4
0	266.4	-0.6	267.0	-0.2	266.0	-1.0

Table 5-7 HEADING MEASUREMENTS AT PITCH = 20°
WITH OFFSET AND ORTHOGONALITY CORRECTION
MADE

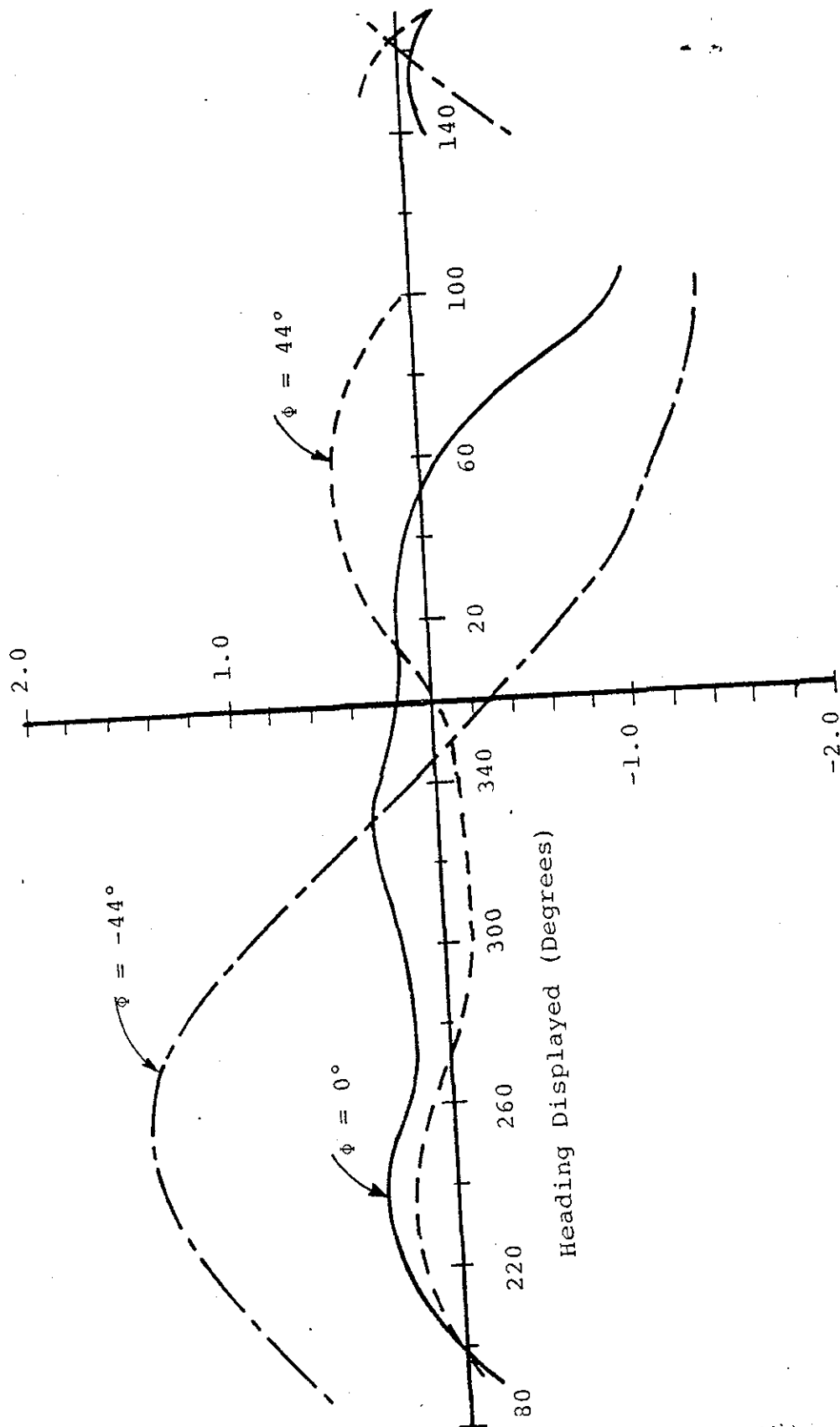


Fig. 5-5 HEADING MEASUREMENT ERROR AT PITCH -20°
(OFFSET AND ORTHOGONALITY ERROR CORRECTED)

Heading Displayed (Degrees)	Roll = 44°		Roll = -44°	
	Angular Position	Error	Angular Position	Error
20	287.0	-0.4	286.5	-0.3
40	307.0	-0.4	306.7	-0.1
60	327.0	-0.4	326.8	0.0
80	347.0	-0.4	346.8	0.0
90	356.7	-0.7	355.6	-0.2
140	47.8	0.4	48.0	1.2
160	67.7	0.3	68.0	1.2
180	87.0	-0.4	87.8	1.0
200	107.6	0.2	108.0	1.2
220	127.7	0.3	128.0	1.2
240	147.8	0.4	147.4	0.6
260	167.6	0.2	167.2	0.4
280	187.6	0.2	187.0	0.2
300	207.1	-0.3	206.5	-0.3
320	227.1	-0.3	226.6	-0.2
340	247.1	-0.3	246.9	0.1
0	266.3	-0.9	266.0	-0.8

TABLE 5-8 HEADING MEASUREMENTS AT PITCH = -20° WITH
 OFFSET AND ORTHOGONALITY ERROR CORRECTED

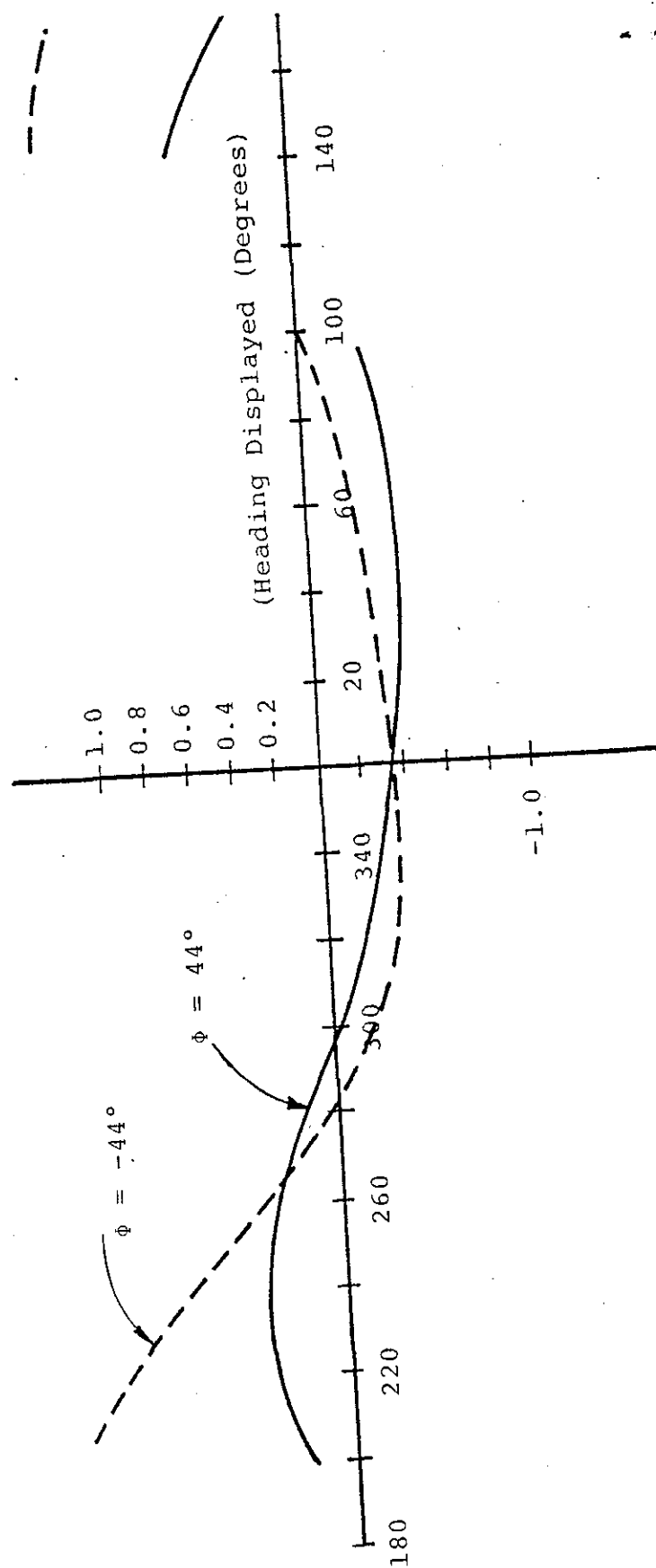


Fig. 5-6 HEADING MEASUREMENT ERROR AT PITCH = -20°
(OFFSET AND ORTHOGONALITY CORRECTED)

major error source⁴. Additionally, we note that the correction of offset error in sensors has been successful. Experimental results have verified that not only can offset errors be determined (Chapter IV), but a suitable algorithm can be implemented in the computer to improve system operation. It is postulated that offset error correction can be extended to include correction of varying offset values (functions of temperature and supply voltage) by monitoring error causing variables (example temperature) and computing correction constants prior to offset correction as above.

Errors induced by sensor nonorthogonality were predicted in Chapter IV section 4-2 and verified by plotting expected error along with measured error in Fig. 4-14. The curves of Fig. 4-14 were plotted for heading rotations with no pitch or roll angle. To evaluate system performance and the effect of orthogonality error with combined angular rotations, measurements of heading error were plotted in Fig. 5-3 through 5-6 inclusive.

Comparison of these data indicate that maximum excursions of error as a function of heading are significantly less when orthogonality corrections are made. It is also postulated that data could be improved further by similarly correcting orthogonality error in the Z axis sensor⁵.

In summary, the experimental evaluation has provided insight into the operation of an attitude independent remote magnetic indicator and heading computer in the "real world"

⁴This corroborates the observations predicted during error analysis in Chapter IV.

⁵We note that the error excursions are functions of pitch and roll and that Z axis data is used in the rotation algorithm.

environment complete with all contributing error sources. The error analysis evolved during development of the system has proven adequate in that an operational system was developed. Major error sources were measurable as predicted and the means of reducing their effects were successfully implemented. Correction of sensor offset and orthogonality error required an empirical evaluation of the respective sensor. These evaluations were performed, the errors characterized, correction coefficients determined, and correction algorithms implemented.

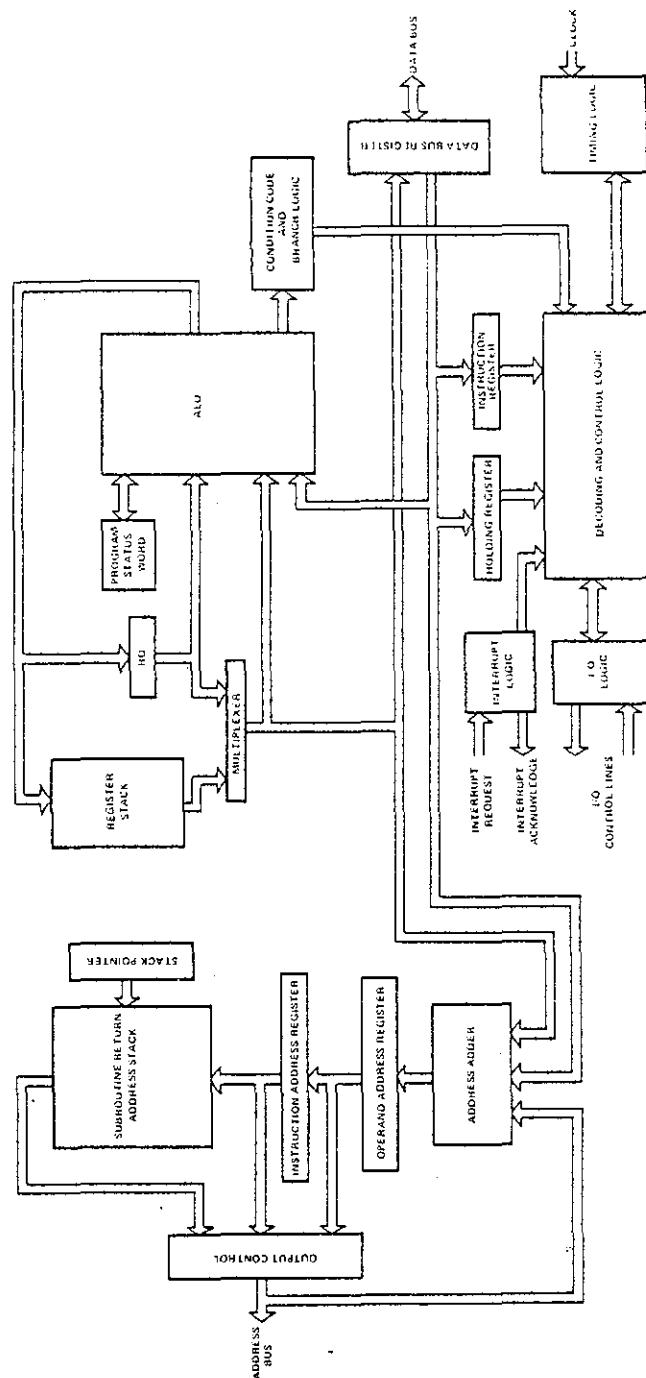
Successful implementation of these corrections was evidenced by significant reductions in system error. The correction methods presented can be extended in future with the net result that less demand is required of physical sensors if the sensor parameters can be established empirically prior to completion of instrument design. Utilization of a microprocessor in the instrument has added the computational flexibility required to facilitate accommodation of sensors with varying error magnitudes.

APPENDIX A

This appendix lists the instruction set of the Signetics 2650 microprocessor chip used to implement the heading instrument.

Instruction	Length (bytes)	Operation	Comments
LOAD/STORE INSTRUCTIONS			
LDDZ r	1	Load Register Zero	
LDD r	2	Load Immediate	
LDD r	2	Load Immediate	
LDD r	2	Load Relative	
LDD r	3	Load Absolute	
LDD r	1	Load Absolute	
LDD r	2	Store Register Zero	
LDD r	2	Store Relative	
LDD r	3	Store Absolute	
ARITHMETIC INSTRUCTIONS			
ADDZ r	1	Add to Register Zero	
ADD r	2	Add Immediate	
ADD r	2	Add Immediate	
ADD r	3	Add Relative	
ADD r	1	Add Absolute	
ADD r	2	Subtract from Register Zero	
ADD r	2	Subtract Immediate	
ADD r	3	Subtract Absolute	
LOGICAL INSTRUCTIONS			
ANDZ r	1	And to Register Zero	
AND r	2	And Immediate	
AND r	2	And Immediate	
AND r	3	And Relative	
AND r	1	And Absolute	
AND r	2	Inclusive or to Register Zero	
AND r	2	Inclusive or Immediate	
AND r	3	Inclusive or Relative	
AND r	3	Inclusive or Absolute	
AND r	1	Exclusive or to Register Zero	
AND r	2	Exclusive or Immediate	
AND r	3	Exclusive or Relative	
AND r	3	Exclusive or Absolute	
COMPARISON INSTRUCTIONS			
COMZ r	1	Compare to Register Zero	
COM r	2	Compare Immediate	
COM r	2	Compare Relative	
COM r	3	Compare Absolute	
ROTATE INSTRUCTIONS			
RRR r	1	Rotate Register Right	
RRR r	1	Rotate Register Left	
BRANCH INSTRUCTIONS			
BCTR v	2	Branch on Condition True Relative	
BCFR v	2	Branch on Condition False Relative	
BCTA v	3	Branch on Condition True Absolute	
BCTA v	3	Branch on Condition False Absolute	
BRNR r	2	Branch on Register Non-Zero Relative	
BRNR r	3	Branch on Register Non-Zero Absolute	
BRNR r	2	Branch on Incrementing Register Relative	
PROGRAM STATUS INSTRUCTIONS			
LPSU	1	Load Program Status, Upper	
LPSL	1	Load Program Status, Lower	
SFSU	1	Store Program Status, Upper	
SFSL	1	Store Program Status, Lower	
CFSU	2	Clear Program Status, Upper, Selective	
CFSL	2	Clear Program Status, Lower, Selective	
PFPU	2	Preset Program Status, Upper, Selective	
PFSL	2	Preset Program Status, Lower, Selective	
TPPU	2	Test Program Status, Upper, Selective	
TPSL	2	Test Program Status, Lower, Selective	
INPUT/OUTPUT INSTRUCTIONS			
WRD r	1	Write Data	
RED r	1	Read Data	
WRTC r	1	Write Control	
REDC r	1	Read Control	
WRTE v	2	Write Extended	
REDE v	2	Read Extended	
MISCELLANEOUS INSTRUCTIONS			
HALT	1	Halt, Enter Wait State	
DAR	1	Decimal Adjust Register	
TMR	1	Test Under Mask Immediate	
NOF	1	No Operation	

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BLOCK DIAGRAM

APPENDIX B

This appendix contains a listing of the assembly language program used to implement the remote magnetic indicator heading algorithm. The program was assembled on the A2650 cross assembler program operational on the HP 2100 computer at the University of Santa Clara.

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PIP ASSEMBLER VERSION 100 LEVEL 1 HEADLINE INSTRUMENT ASSEMBLY PROGRAM 1070 PAGE 2

LINE	ADDR	LAB	H1	B2	H3	H4	INSTR	SOURCE
3								
4	0000	R0	0000	0000	0000	0000	0000	
5	0001	R1	0001	0001	0001	0001	0001	
6	0002	R2	0002	0002	0002	0002	0002	
7	0003	R3	0003	0003	0003	0003	0003	
8	0000	UN	0000	0000	0000	0000	0000	
9	0000	Z	0000	0000	0000	0000	0000	
10	0001	P	0001	0001	0001	0001	0001	
11	0002	Q	0002	0002	0002	0002	0002	
12	0000	EU	0000	0000	0000	0000	0000	
13	0001	GT	0001	0001	0001	0001	0001	
14	0001	C	0001	0001	0001	0001	0001	
15	0002	LF	0002	0002	0002	0002	0002	
16	0003	UN	0003	0003	0003	0003	0003	
17	0002	CUM	0002	0002	0002	0002	0002	
18	0010	RS	0010	0010	0010	0010	0010	
19	0008	WC	0008	0008	0008	0008	0008	
20	000F	LOWR	000F	000F	000F	000F	000F	
21	00F0	UPPR	00F0	00F0	00F0	00F0	00F0	
22	0040	FLAG	0040	0040	0040	0040	0040	
23	0020	II	0020	0020	0020	0020	0020	
24	00FE	NSAM	00FE	00FE	00FE	00FE	00FE	
25	0001	MSB	0001	0001	0001	0001	0001	
26	0002	LSB	0002	0002	0002	0002	0002	
27	0004	THA	0004	0004	0004	0004	0004	
28	0008	PHI	0008	0008	0008	0008	0008	
29	0010	SBIT	0010	0010	0010	0010	0010	
30								
31								
32								
33	0450	DATA	0450	0450	0450	0450	0450	
34	045A	DATM	045A	045A	045A	045A	045A	
35	0464	LUPS	0464	0464	0464	0464	0464	
36	0465	TEMP	0465	0465	0465	0465	0465	
37	0457	SIND	0457	0457	0457	0457	0457	
38	0469	SINR	0469	0469	0469	0469	0469	
39	0466	HM2	0466	0466	0466	0466	0466	
40	0460	SIGN	0460	0460	0460	0460	0460	
41	046E	MAX2	046E	046E	046E	046E	046E	
42	0470	MY2	0470	0470	0470	0470	0470	
43	0472	MY2	0472	0472	0472	0472	0472	
44	0474	UUA0	0474	0474	0474	0474	0474	
45	0475	COSH	0475	0475	0475	0475	0475	
46	0477	ASLT	0477	0477	0477	0477	0477	
47	0479	OPM1	0479	0479	0479	0479	0479	
48	047B	OPM2	047B	047B	047B	047B	047B	
49	047D	SIEM	047D	047D	047D	047D	047D	
50	047E	SMES	047E	047E	047E	047E	047E	
51	047F	DATX	047F	047F	047F	047F	047F	
52	0481	DATY	0481	0481	0481	0481	0481	
53	0483	DATZ	0483	0483	0483	0483	0483	
54	0485	CUST	0485	0485	0485	0485	0485	

DATA STORAGE IN RAM

ORG H:4501

DATA RES 10

DATM RES 10

LUPS RES 1

TEMP RES 2

SIND RES 2

SINR RES 2

HM2 RES 2

SIGN RES 1

MAX2 RES 2

MY2 RES 2

UUA0 RES 2

COSH RES 2

ASLT RES 2

OPM1 RES 2

OPM2 RES 2

SIEM RES 1

SMES RES 1

DATX RES 2

DATY RES 2

DATZ RES 2

CUST RES 1

RAW DATA

CORRECTED DATA

HM SQUARED DATA

HA SQUARED DATA

OUTPUT

OUTPUT

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PIP ASSEMBLER VERSION SCU LEVEL 1 HEADING INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 4

LINE	ADDR	LABL	B1	B2	B3	B4	ERROR SOURCE
82	0598		CE	CF	00	01	DATA
			D2	D3	D3	D4	
			D5	06	07		
83	05A3		D8	09	09	DA	DATA
			D8	0C	0D	DD	
			DE	DF	E0		
84	05AE		E1	E1	E2	E3	DATA
			E3	E4	E5	E6	
			E6	E7	E8		
85	05H9	05H9	FF	FF	FF	FF	CUS
			FF	FF	FF	FF	
			FF	FF	FF	FF	
86	05C3		FF	FF	FF	FF	DATA
			FF	FF	FF	FF	
			FE	FE	FE	FE	
87	05C0		FE	FD	FD	FD	DATA
			FD	FC	FC	FC	
			FC	FA	FA	FA	
88	0507		F8	F8	F8	FA	DATA
			FA	FA	F9	F9	
			F9	FA			
89	05E1		F8	F7	F7	F7	DATA
			F6	F6	F5	F5	
			F4	F4			
90	05E8		F4	F3	F3	F2	DATA
			F2	F1	F1	F0	
			EF	EF			
91	05F5		EE	EE	FD	ED	DATA
			EC	EB	EB	EA	
			EA	E9	E8	EA	
92	0601		E7	E6	E6	E5	DATA
			E4	E3	E3	E2	
			E1	E1			
93	0608		E0	DF	DE	DD	DATA
			DD	DC	DB	DA	
			D9	D9			
94	0615		D8	07	D6	D5	DATA
			D4	D3	D3	D2	
			D1	D0			
95	061F		CF	CE	CD	CC	DATA
			CB	CA	C9	C8	
			C7	C4			
96	0629		C5	C4	C3	C2	DATA
			C1	CA	BF	BE	
			D0	DC			
97	0633		D8	BA	H9	BA	DATA
			B7	B6	B5	B3	
			B2	B1			
98	063D		R0	AF	AE	AD	DATA
			AB	AA	A9	AA	
			A7	A4			
99	0648		A3	A2	A1	9F	DATA
			9E	9D	9C	9A	
			99	9C	97	95	

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PIP ASSEMBLER VERSION SCU LEVEL 1 HEADING INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 5

LINE	ADDR	1AHL	B1	B2	B3	B4	ERROR	SOURCE
100	0654		94	93	92	90		DATA H194,93,92,90,8F,8E,8C,8A,88,87
101	065E		84	84	84	83		DATA H187,86,84,83,82,80,7F,7E,7C,7B,7A
102	0668		74	74	77	75		DATA H17A,78,77,75,74,73,71,70,6E,6D,6C
103	0673		64	63	61	60		DATA H16A,59,57,56,54,53,51,50,4E,4D
104	067E		54	53	51	50		DATA H15A,59,57,56,54,53,51,50,4E,4D
105	068H		44	44	44	47		DATA H14A,4A,44,47,45,44,42,41,3F,3E,3C
106	0693		34	34	36	35		DATA H13B,39,38,36,35,33,31,30,2E,2D
107	069D		24	24	24	27		DATA H12B,2A,24,27,25,24,22,20,1F,1D
108	06A7		14	1A	19	17		DATA H11C,1A,19,17,15,14,12,11,0F,0E
109	06B1		04	0A	09	07		DATA H10C,0A,09,07,06,04,03,01,00
110	06BA	06BA	7F	74	77	72		COSM DATA H17F,7B,77,72,6E,69,65,61,5C,58,54
111	06C5		50	44	47	43		DATA H150,46,47,43,3F,3C,3B,34,31,20,2A
112	06D0		31	2D	2A	20		DATA H127,23,20,1D,1B,18,15,13,11,0E,0C
113	06DB		1B	1A	15	13		DATA H10H,09,07,06,04,03,02,01,00,00,00,00
114	06EB	06EB	FF	FF	FF	FF		COSL DATA H1FF,88,12,9E,2F,CS,63,08,B7,72,38,0C
115	06F4		47	72	38	0C		DATA H1FU,63,EB,FF,2B,0C,C3,32,B9,59,15,EC
116	0700		28	6C	C3	32		DATA H1E0,12,22,72,E2,73,26,F8,F4,10,52,D8

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P/P ASSEMBLER VERSION SCU LEVEL 1 HEADING INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 6

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LINE ADDR LABEL B1 B2 B3 B4 B5 B6 B7 B8 B9 B10 B11 B12 B13 B14 B15 B16 B17 B18 B19 B20 B21 B22 B23 B24 B25 B26 B27 B28 B29 B30 B31 B32 B33 B34 B35 B36 B37 B38 B39 B40 B41 B42 B43 B44 B45 B46 B47 B48 B49 B50 B51 B52 B53 B54 B55 B56 B57 B58 B59 B60 B61 B62 B63 B64 B65 B66 B67 B68 B69 B70 B71 B72 B73 B74 B75 B76 B77 B78 B79 B80 B81 B82 B83 B84 B85 B86 B87 B88 B89 B90 B91 B92 B93 B94 B95 B96 B97 B98 B99 B100 B101 B102 B103 B104 B105 B106 B107 B108 B109 B110 B111 B112 B113 B114 B115 B116 B117 B118 B119 B120 B121 B122 B123 B124 B125 B126 B127 B128 B129 B130 B131 B132 B133 B134 B135 B136 B137 B138 B139 B140 B141 B142 B143 B144 B145 B146 B147 B148 B149 B150 B151 B152 B153 B154 B155 B156

117 070C 43 F5 CD CC DATA H:43,F5,C0,CC,F1,3E,B3,4F,13,00,
118 0716 0716 01 02 04 04 BCD DATA H:01,02,04,08,16,32,64,00,
119 071E 071E 03 SINE DATA H:03,
120 0720 0720 07 08 09 0A ORG H:750,
121 0721 0721 0B 0C 0D 0E *****
122 0722 0722 0F 10 11 12 *****
123 0723 0723 13 14 15 16 *****
124 0724 0724 17 18 19 1A *****
125 0725 0725 1B 1C 1D 1E *****
126 0726 0726 1F 20 21 22 *****
127 0727 0727 23 24 25 26 *****
128 0728 0728 27 28 29 2A *****
129 0729 0729 2B 2C 2D 2E *****
130 0730 0730 2F 30 31 32 *****
131 0731 0731 33 34 35 36 *****
132 0732 0732 37 38 39 3A *****
133 0733 0733 3B 3C 3D 3E *****
134 0734 0734 3F 40 41 42 *****
135 0735 0735 43 44 45 46 *****
136 0736 0736 47 48 49 4A *****
137 0737 0737 4B 4C 4D 4E *****
138 0738 0738 4F 50 51 52 *****
139 0739 0739 53 54 55 56 *****
140 0740 0740 57 58 59 5A *****
141 0741 0741 5B 5C 5D 5E *****
142 0742 0742 5F 60 61 62 *****
143 0743 0743 63 64 65 66 *****
144 0744 0744 67 68 69 6A *****
145 0745 0745 6B 6C 6D 6E *****
146 0746 0746 6F 70 71 72 *****
147 0747 0747 73 74 75 76 *****
148 0748 0748 77 78 79 7A *****
149 0749 0749 7B 7C 7D 7E *****
150 0750 0750 7F 80 81 82 *****
151 0751 0751 83 84 85 86 *****
152 0752 0752 87 88 89 8A *****
153 0753 0753 8B 8C 8D 8E *****
154 0754 0754 8F 90 91 92 *****
155 0755 0755 93 94 95 96 *****
156 0756 0756 97 98 99 9A *****

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PIP ASSEMBLER VERSION SCU LEVEL 1 HEADING INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 9

LINE ADDR LABEL H1 B2 H3 B4 ERROM SOURCE

```

210 07F2          CE 64 59          STRA,R0      DATM-1,R2      STORE MS BITS
211 07F5          18 0A          BCIN,UN      FINI
212 07F7 07F7    44 7F          ANDI,R0      H17F:      SIGN BIT = 0
213 07F9          CE 64 5A          STRA,R0      DATA,R2      STORE NEW DATA
214 07FC          0E 24 50          LODA,R0      DATA,R2**   GET LS DATA
215 07FF          CE 64 5A          STRA,R0      DATA,R2      STORE AS NEW DATA
216 0802 0802    FB 5A          FINI        BORR,R3      CONT
217 0804          0C 04 5C          LODA,R0      OF HY SHZ (SENSOR ORIENTATION)
218 0807          00 04 5E          LODA,R1      DATM-2      CHANGE SIGN OF HY & HZ
219 080A          24 90          EORI,R0      H180:
220 080C          25 80          EORI,R1      H180:
221 080E          CC 04 5C          STRA,R0      DAT4-2
222 0811          CD 04 5E          STRA,R1      DATM-4
223 0814          07 00          LODI,R3      0
224 0816          3F 0A 2A          BSTA,UN      OFST
225 0819          07 02          LODI,R3      2
226 081B          3F 0A 2A          BSTA,UN      OFST
227 081E          07 04          LODI,R3      4
228 0820          3F 0A 2A          BSTA,UN      OFST
229 0823          C0
230 0824          07 07          LODI,R3      7
231 0826          3F 0F 4B          BSTA,UN      ORTH
232 0829          17          RETC,UN
233
234
235
236

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PIP ASSEMBLER VERSION SCU LEVEL 1 HEADLINE INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 9

LINE ADDR LABEL R1 R2 R3 R4 FROM SOURCE

```

238 082A 002A 0F 0A 5A *****
239 082B 002A 0F 0A 5A *****
240 082C 002A 0F 0A 5A *****
241 082D 002A 0F 0A 5A *****
242 082E 002A 0F 0A 5A *****
243 082F 002A 0F 0A 5A *****
244 0830 002A 0F 0A 5A *****
245 0831 002A 0F 0A 5A *****
246 0832 002A 0F 0A 5A *****
247 0833 002A 0F 0A 5A *****
248 0834 002A 0F 0A 5A *****
249 0835 002A 0F 0A 5A *****
250 0836 002A 0F 0A 5A *****
251 0837 002A 0F 0A 5A *****
252 0838 002A 0F 0A 5A *****
253 0839 002A 0F 0A 5A *****
254 083A 002A 0F 0A 5A *****
255 083B 002A 0F 0A 5A *****
256 083C 002A 0F 0A 5A *****
257 083D 002A 0F 0A 5A *****
258 083E 002A 0F 0A 5A *****
259 083F 002A 0F 0A 5A *****
260 0840 002A 0F 0A 5A *****
261 0841 002A 0F 0A 5A *****
262 0842 002A 0F 0A 5A *****
263 0843 002A 0F 0A 5A *****
264 0844 002A 0F 0A 5A *****
265 0845 002A 0F 0A 5A *****
266 0846 002A 0F 0A 5A *****
267 0847 002A 0F 0A 5A *****
268 0848 002A 0F 0A 5A *****
269 0849 002A 0F 0A 5A *****
270 084A 002A 0F 0A 5A *****
271 084B 002A 0F 0A 5A *****
272 084C 002A 0F 0A 5A *****
273 084D 002A 0F 0A 5A *****
274 084E 002A 0F 0A 5A *****
275 084F 002A 0F 0A 5A *****
276 0850 002A 0F 0A 5A *****
277 0851 002A 0F 0A 5A *****
278 0852 002A 0F 0A 5A *****
279 0853 002A 0F 0A 5A *****
280 0854 002A 0F 0A 5A *****
281 0855 002A 0F 0A 5A *****
282 0856 002A 0F 0A 5A *****
283 0857 002A 0F 0A 5A *****
284 0858 002A 0F 0A 5A *****
285 0859 002A 0F 0A 5A *****
286 085A 002A 0F 0A 5A *****
287 085B 002A 0F 0A 5A *****
288 085C 002A 0F 0A 5A *****
289 085D 002A 0F 0A 5A *****

```

OFST LODA,R0 DATA,R3 MS BYTE OF DATA
STRZ R1
ANDI,R0 H'7F' SHIP SIGN
ANDI,R1 H'80' SAVE SIGN
STRA,R0 RSLT
STRA,R1 SRES
LODA,R0 DATA,R3
STRA,R0 RSLT,R1
LODA,R0 USET,R3
STRA,R0 TEMP
LODA,R0 USET,R3
STRA,R0 TEMP,R1
LODA,R0 SOST,R3
STRA,R0 STE,R1
COM
PUSL MS BANK=1
BSTA,UN SADI, MS BANK=0
CPUSL MS
LODA,R0 RSLT
STRA,R0 DATA,R3
LODA,R0 RSLT,R1
STRA,R0 DATA,R3
RSLT,UN

BINARY MULT. FOR A TWO-BYTE INTEGER
MULT. BY A SINGLE-BYTE INTEGER
MULTIPLICAND IS IN OPR1,R1
MULTIPLICAND IS IN OPR2,OPR2,R1
RESULT WILL BE IN RSLT,RSLT,R1
(2 BYTES ARE DISCARDED.)

BEGIN SUBROUTINE
SMPLY PPSL MC SET MODE
LOUO LODA,R2 OPR1,R1
LOO0 RAR,R2
FORZ R0
RSL,R0
MRRM,R0 L'0C4
LOU1,R1 2
LOU2 LODA,R0 RSLT,R1,R1
LOU2 ADDA,R0 OPR2,R1,R1
MRRM,R0 RSLT,R1,R1
LOU2

THIS ROTATES MULTIPLIER BY 1 BIT TO GET LSB INTO CARRY
ROT. RIGHT WITH CARRY
CLEAR R0
GET CARRY INTO LSH
BRANCH IF C=0
INDEX
ADD MULTIPLICAND TO PRODUCT
FINISH THE ADD

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PIP ASSEMBLER VERSION 500 LEVEL 1 HEADING INSTRUMENT ASSEMBLY PROGRAM 1974 PAGE 11
LINE ADDR LABEL M1 M2 M3 M4 FROM SOURCE
342 08E6 00F6 77 04
343 08E8 0C 04 00
344 08E9 C1
345 08EC C1
346 08ED 05 7F
347 08EF 07 00
348 08F1 0F 04 07
349 08F4 00 05 00
350 08F7 0C 04 08
351 08FA 00 04 09
352 08FD 0C 04 05
353 0900 0C 04 7A
354 0903 0C 04 5A
355 0906 C1
356 0907 44 7F
357 0909 45 00
358 090A 0C 04 7B
359 090E C1 04 06
360 0911 0C 04 08
361 0914 0C 04 7C
362 0917 0F 04 06
363 091A 0C 04 77
364 091D 0C 04 08
365 0920 0C 04 78
366 0923 0C 04 0C
367 0926 3F 0F 40
368 0929 0C 04 08
369 092C 0C 04 7A
370 092F 3F 04 66
371 0932 0C 04 07
372 0935 0C 04 7E
373 0938 00 04 06
374 093E 0C 04 70
375 0941 0C 04 0B
376 0944 00 04 0C
377 0947 0C 04 05
378 094A 0C 04 06
379 094C 75 07
380 094E 0F 04 08
381 094F 0C 04 78
382 0952 0C 04 00
383 0955 0C 04 77

*****
* S.M. ROTX TO CORRECT HX DATA USING ALGORITHM *
* HAXXX=COS(PITCH)*SIN(PITCH)*[HYMMSIN( *
* CULL)*ZMCOS(COLL)] *
* ENTER WITH "HAX DATA" IN TABLE DATA *
* EXIT WITH "OJIFIED HX IN "DATA" *
* CALLS S.M. HZM *
* CALLS S.M.S. "SAOD" & "SHPM" TO DO *
* STORED MAGNITUDE AND/SUBI AND MULTIPLY *****
*UTX PPSL MC-C ANITH WITH CARRY, C=1
*LODA,M0 R1 THETA (PITCH)
*STRZ R1
*ANDI,M1 M17F1 STRIP OFF SIGN
*ANDI,M3 M1801 SAVE SIGN
*STR,M0 SINI SIGN (THETA)
*LODA,M0 SIN,M1 SIN(THETA)
*STR,M0 SIN,M1
*LODA,M0 COS,M1 COS(THETA)
*STR,M0 COSI
*STR,M0 OPR1,M1 MULTIPLIER
*LODA,M0 DATA HX MSB15
*STRZ M1
*ANDI,M0 M17F1 STRIP OFF SIGN
*ANDI,M1 M1801 SAVE SIGN
*STR,M0 OPR2 MULTIPLICAND
*STR,M1 SIGA
*LODA,M0 OPR1,M1
*STR,M0 OPR2,M1
*BSTA,M0 SAPPY FORM HX COS (THETA)
*LODA,M0 RSLT MOVE PRODUCT
*STR,M0 CAUF
*LODA,M0 RSLF,M1
*STR,M0 OPRF
*BSTA,M0 M17R1
*LODA,M0 SIN,M1 SIN (THETA)
*STR,M0 OPR1,M1 MULTIPLIER
*STR,M0 SAPPY HZ*SIGN(THETA)
*LODA,M0 SINI SIGN OF THETA
*STR,M0 SIGA FOR USE BY SAND
*LODA,M0 OPRF
*STR,M0 OPRF
*STR,M0 TEMP,M1
*STR,M1 COM FLAG = ADD
*PSL COM FORM NEW HX
*STR,M0 SAPPY
*LODA,M0 RSLF,M1 MOVE NEW HX
*LODA,M0 DATA,M1
*LODA,M0 RSLT

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VIP ASSEMBLER VERSION SCU LEVEL 1 HEADING INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 14

LINE ADDR L A M L A1 R2 R3 R4 FROM SOURCE

```

483 09FD      RETC,UN
484 09FE      17
485 0A00      14 17
486
487 0A02      0A02 0C 64 76
488 0A05      AE 64 64
489 0A08      CE 64 76
490 0A0B      FA 76
491 0A0D      H5 01
492 0A0F      9C 09 E0
493 0A12      0A12 44 7F
494 0A14      CC 04 77
495 0A17      17
496
497
498
499 0A1B      0A1B 0C 04 7E
500 0A1C      C3
501 0A1E      06 02
502 0A21      2C 04 70
503 0A24      9E 0A 36
504 0A26      75 01
505 0A29      0A29 0E 64 64
506 0A2C      AE 64 76
507 0A2F      CE 64 76
508 0A31      FA 76
509 0A32      53
510 0A35      CC 04 77
511 0A38      17

```

* START HERE IF TEMP IN "TEMP" IS NEGATIVE
 * XNEG
 * START HERE IF TEMP IN "TEMP" IS POSITIVE
 * XPOS
 * START HERE IF SUBTRACTION IS REQUIRED
 * L.L. (KSLT, KSLT+1) - (TEMP, TEMP+1)
 * SSUB
 * SIGN OF RESULT
 * BK, IF SIGNS SAME
 * SLUP
 * RETC,UN

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PLP ASSEMBLER VERSION SCU LEVEL 1 HEADUNG INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 15

LINE ADDR LABEL H1 H2 H3 H4 FROM SOURCE

```

513      U436 0A16 77 01      * START HERE IF BOTH TERMS SAME SIGN
514      U438 0A18 0E 64 76      C=1
515      U439 0A19 0E 64 76      RSLT = TEMP - RSLT
516      U43A 0A1A 0E 64 76      SUBR, R0
517      U43B 0A1B 0E 64 76      TEMP-1, R2
518      U43C 0A1C 0E 64 76      STRA, R0
519      U43D 0A1D 0E 64 76      RSLT-1, R2
520      U43E 0A1E 0E 64 76      BLUP
521      U43F 0A1F 0E 64 76      TEST CARRY
522      U440 0A20 0E 64 76      START 2'S COMPL
523      U441 0A21 0E 64 76      LOOP TO DO
524      U442 0A22 0E 64 76      2'S COMPL.
525      U443 0A23 0E 64 76      CLUP
526      U444 0A24 0E 64 76      TEST SIGN
527      U445 0A25 0E 64 76      MIN IF NEG.
528      U446 0A26 0E 64 76      FINS
529      U447 0A27 0E 64 76      STRA, R0
530      U448 0A28 0E 64 76      RSLT-1, R2
531      U449 0A29 0E 64 76      CLUP
532      U44A 0A2A 0E 64 76      SUBR, R0
533      U44B 0A2B 0E 64 76      TEMP-1, R2
534      U44C 0A2C 0E 64 76      STRA, R0
535      U44D 0A2D 0E 64 76      RSLT-1, R2
536      U44E 0A2E 0E 64 76      CLUP
537      U44F 0A2F 0E 64 76      SUBR, R0
538      U450 0A30 0E 64 76      TEMP-1, R2
539      U451 0A31 0E 64 76      STRA, R0
540      U452 0A32 0E 64 76      RSLT-1, R2
541      U453 0A33 0E 64 76      CLUP
542      U454 0A34 0E 64 76      SUBR, R0
543      U455 0A35 0E 64 76      TEMP-1, R2
544      U456 0A36 0E 64 76      STRA, R0
545      U457 0A37 0E 64 76      RSLT-1, R2
546      U458 0A38 0E 64 76      CLUP
547      U459 0A39 0E 64 76      SUBR, R0
548      U45A 0A3A 0E 64 76      TEMP-1, R2
549      U45B 0A3B 0E 64 76      STRA, R0
550      U45C 0A3C 0E 64 76      RSLT-1, R2
551      U45D 0A3D 0E 64 76      CLUP
552      U45E 0A3E 0E 64 76      SUBR, R0
553      U45F 0A3F 0E 64 76      TEMP-1, R2
554      U460 0A40 0E 64 76      STRA, R0
555      U461 0A41 0E 64 76      RSLT-1, R2
556      U462 0A42 0E 64 76      CLUP
557      U463 0A43 0E 64 76      SUBR, R0
558      U464 0A44 0E 64 76      TEMP-1, R2
559      U465 0A45 0E 64 76      STRA, R0
560      U466 0A46 0E 64 76      RSLT-1, R2
561      U467 0A47 0E 64 76      CLUP
562      U468 0A48 0E 64 76      SUBR, R0
563      U469 0A49 0E 64 76      TEMP-1, R2
564      U46A 0A4A 0E 64 76      STRA, R0
565      U46B 0A4B 0E 64 76      RSLT-1, R2
566      U46C 0A4C 0E 64 76      CLUP
567      U46D 0A4D 0E 64 76      SUBR, R0
568      U46E 0A4E 0E 64 76      TEMP-1, R2
569      U46F 0A4F 0E 64 76      STRA, R0
570      U470 0A50 0E 64 76      RSLT-1, R2
571      U471 0A51 0E 64 76      CLUP

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ORIGINAL PAGE IS POOR

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MIP ASSEMBLER VERSION SOURCE LEVEL 1 HEADUNG INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 16
LINE ADDR LABEL B1 B2 B3 B4 FROM SOURCE
543
544
545
546
547
548
549
550
551 0A71 0A71 77 04
552 0A73 0C 04 62
553 0A76 C1
554 0A77 45 7F
555 0A79 2C 04 5E
556 0A7C 44 80
557 0A7E DATE CC 04 70
558 0A81 00 04 49
559 0A84 CC 04 75
560 0A87 00 04 00
561 0A8A CC 04 7A
562 0A8D CC 04 5E
563 0A90 44 7F
564 0A92 CC 04 78
565 0A95 CC 04 5F
566 0A98 CC 04 7C
567 0A9B 3F 04 66
568 0A9E CC 04 77
569 0AA1 CC 04 65
570 0AA4 CC 04 78
571 0AA7 CC 04 66
572 0AAA CC 04 5C
573 0AAB C1
574 0AAD 45 7F
575 0AAE CC 04 76
576 0AB0 44 80
577 0AB3 CC 04 7E
578 0AB5 CC 04 5D
579 0ABA CC 04 7C
580 0ABR CC 04 75
581 0ABE CC 04 7A
582 0AC1 3F 04 66
583 0AC4
584
585 0AC7 77 02
586 0AC9 3F 04 66
587 0ACC CC 04 77
588 0ACF CC 04 77
589 0AD2 CC 04 76
590 0AD5 CC 04 76
591 0AD8 17

*****
* S.N. ROTY TO ADJUST HY DATA USING ALGORITHM *
* HY=HY+COS(ROLL)*ZM+SIN(ROLL) *
* USES SIGN AND MAGNITUDE DATA FROM TABL DATM *
* STORES NEW DATA INTO DATY, DATY+1 *
* CALLS S.M.S. "SADD" & "SMPLY" TO PERFORM SIGNED *
* MAGNITUDE ARITHMETIC *
*****
* ROTY PPST WC+C *****
* LODA,R0 DATM+H GET ROLL ANGLE PHI
* STRZ R1 STRIP OFF SIGN
* EORA,R0 DATM+4 DETERMINE SIGN OF PROD.
* ANDI,R0 HI80+
* STRA,R0 STEM
* LODA,R0 COS+H1 CUS (PHI)
* STRA,R0 COSK SIN (PHI)
* LODA,R0 SIN+R1 MULTIPLIER
* STRA,R0 OPRI+1 GET HZ
* LODA,R0 DATM+4 STRIP SIGN
* ANDI,R0 HI7F+ MULTIPLICAND
* STRA,R0 OPR2 FORM 22+SIN(PHI)
* LODA,R0 DATM+5 MOVE PRODUCT
* STRA,R0 OPR2+1
* BSTA,UN SMPLY
* LODA,R0 RSLT
* STRA,R0 TFMP
* LODA,R0 RSLT+1
* STRA,R0 TFMP+1
* BEGIN FORMING 2ND TERM
* LODA,R0 DATI+2
* STRZ R1
* ANDI,R1 HI7F+
* STRA,R1 OPR2
* ANDI,R0 HI80+
* STRA,R0 SRES
* LODA,R0 DATM+3
* STRA,R0 OPR2+1
* LODA,R0 COSK
* STRA,R0 OPR1+1
* BSTA,UN SMPLY
* PPST COM
* BSTA,UN SADD
* LODA,R0 RSLT
* STRA,R0 DATY
* LODA,R0 RSLT+1
* STRA,R0 DATY+1
* RETC,UN

```


PIP ASSEMBLER VERSION 500 LEVEL 1 HEADING INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 16

LINE ADDR L=HL R1 B2 R3 R4 FROM SOURCE

```

641 *****
642 * A SUBROUTINE TO COMPUTE HEADING WHEN *
643 * ( 1/2-1135 < YAW < (1/2-1145 DEGREES *
644 *****
645 SINY LOD1,R1 2 INDEX
646 LUP LOD1,R0 MY2-1,R1 LOAD OPRI-1,OPRI
647 STRA,R0 OPRI-1,R1
648 BDRR,R1 LUP
649 EORZ R0
650 BSTA,UN V1V1 FORM MY2/MH2
651 BSTA,UN ANGL FORM ARCCOS(MY2/MH2)
652 BSTA,UN BCDA CONVERT TO BCD
653 BSTA,UN H*90* CALC. 90-ANGLE
654 BSTA,UN C*WC
655 SURZ R1
656 DAR,R0
657 STRZ R1
658 BSTA,UN HNG
659 RETC,UN
660 *****

```


LINE	ADDR	LA-LC	R1	R2	R3	R4	ERROR	SOURCE
714	0B9D	0E	04	77				L0DA,R2
715	0BA0	05	17					L0DI,R1
716	0BA2	07	17					L0DI,R3
717	0BA4	00	6A	NA				L0DA,R0
718	0BA7	75	01					CPSL
719	0BA9	53						RHR,R3
720	0BA2	18	1F					BCTR,R2
721	0BAC	E2						COMZ
722	0BAD	19	00					BCTR,GT
723	0BAF	1A	1P					BCTR,LT
724	0BB1	F4	01					COMI,R0
725	0BB3	1D	0C	43				BCTR,GT
726	0BB6	1C	0C	49				BCTR,GT
727	0BB9	1F	0C	27				BCTR,UN
728	0BBC	75	01					CPSL
729	0BBE	01						L0DZ
730	0BBF	83						ADDZ
731	0BC0	C1						STRZ
732	0BC1	1B	61					BCTR,UN
733	0BC3	0BC3	77	01				PPSL
734	0BC5	01						L0DZ
735	0BC6	A3						SUBZ
736	0BC7	C1						STRZ
737	0BCA	1B	5A					BCTR,UN
738	0BCA	0BCA	07	0A				L0DI,R3
739	0BCC	0BCC	00	6A	NA			L0DA,R0
740	0BCF	F2						COMZ
741	0BD0	19	05					BCTR,GT
742	0BD2	1A	09					BCTR,LT
743	0BD4	1F	04	B1				BCTR,UN
744	0BD7	0BD7	75	01				CPSL
745	0BD9	85	01					ADDI,R1
746	0BD8	1A	04					BCTR,UN
747	0BD0	0BD0	77	01				PPSL
748	0BDJ	A5	01					SUBI,R1
749	0BE1	0BE1	F8	69				BHR,R3
750								L0DA,R0
751	0BE3	0D	6A	NA				COMZ
752	0BE6	E2						BCTR,GT
753	0BE7	19	1A					STRZ
754								L0DA,R0
755	0BE9	C3						PPSL
756	0BEA	0D	6A	NA				SUBZ
757	0BED	77	01					CPSL
758	0BEF	A3						RHR,R0
759	0BF0	75	01					CPSL
760	0BF2	50						ADDZ
761	0BF3	75	01					CPSL
762	0BF5	83						COMZ
763	0BF6	F2						ADDI,R1
764	0BF7	1F	01					PPSL
765	0BFA	1F	01					

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PIP ASSEMBLER VERSION SCU LEVEL 1 HEADING INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 22

LINE ADDR LABEL R1 R2 R3 R4 FROM SOURCE
818 0C60 05 29
819 0C62 1H 5F
820
821 *****
822 * A SUBROUTINE TO CONVERT BINARY ANGLE TO BCD *
823 * ENTR WITH R0=ANGLE(IN) & EXIT R1=BCD FOURIV. *
824 *****
825 0C64 0C64 07 07
826 0C66 05 00
827 0C68 0C68 75 01
828 0C6A 00
829 0C6B C2
830 0C6C 9A 0A
831 0C6E 01
832 0C6F 75 01
833 0C71 04 06
834 0C73 0F 07 15
835 0C76 94
836 0C77 C1
837 0C7A 02
838 0C79 0C79 0A 00
839 0C7B 17
840
841

      LODI,R1 41
      BCTH,UN QUIT
*****
* A SUBROUTINE TO CONVERT BINARY ANGLE TO BCD *
* ENTR WITH R0=ANGLE(IN) & EXIT R1=BCD FOURIV. *
*****
BCDA LODI,R3 7
      LODI,R1 0
      CPCL C
      RRL,R0
      STRZ R2
      BCFR,N NINC
      LODZ R1
      CPCL C
      ADDI,R0 R166
      ADDA,R0 BCD-1,R3
      DAR,R0
      STRZ R1
      LODZ R2
      BCFR,R3 BRCH
      NINC GO BACK TIL DONE
      ***** LEAVE WITH BCD EQUIV. OF YAW1 IN R1
      METC,UN
*****

```

PIP ASSEMBLER VERSION SCU LEVEL 1 HEADING INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 23

```

LINE ADDR LABEL N1 N2 N3 N4 FROM SOURCE
843      UC7C UC7C 77 04 IF
844      UC7E UC7E 0C 04 IF
845      UC81 UC81 1A 1A
846      UC83 UC83 0C 04 M1
847      UC86 UC86 1A 1A
848      UC88 UC88 F5 00
849      UC8A UC8A 1D 0C
850      UC8C UC8C 04 60
851      UC8E UC8E A1
852      UC90 UC90 94
853      UC92 UC92 C3
854      UC94 UC94 0B 04
855      UC96 UC96 0B 00
856      UC98 UC98 96
857      UC9A UC9A 1B 27
858      UC9C UC9C 06 00
859      UC9E UC9E 01
860      UC9F UC9F C3
861      UC9C UC9C 1B 27
862      UC9E UC9E 0C 04 M1
863      UC9F UC9F 1A 1A
864      UC9C UC9C 0C 04 M1
865      UC9E UC9E 1A 1A
866      UC9C UC9C 0C 04 M1
867      UC9E UC9E 1A 1A
868      UC9C UC9C 0C 04 M1
869      UC9E UC9E 1A 1A
870      UC9C UC9C 0C 04 M1
871      UC9E UC9E 1A 1A
872      UC9C UC9C 0C 04 M1
873      UC9E UC9E 1A 1A
874      UC9C UC9C 0C 04 M1
875      UC9E UC9E 1A 1A
876      UC9C UC9C 0C 04 M1
877      UC9E UC9E 1A 1A
878      UC9C UC9C 0C 04 M1
879      UC9E UC9E 1A 1A
880      UC9C UC9C 0C 04 M1
881      UC9E UC9E 1A 1A
882      UC9C UC9C 0C 04 M1
883      UC9E UC9E 1A 1A
884      UC9C UC9C 0C 04 M1
885      UC9E UC9E 1A 1A
886      UC9C UC9C 0C 04 M1
887      UC9E UC9E 1A 1A
888      UC9C UC9C 0C 04 M1
889      UC9E UC9E 1A 1A
890      UC9C UC9C 0C 04 M1
891      UC9E UC9E 1A 1A
892      UC9C UC9C 0C 04 M1
893      UC9E UC9E 1A 1A
894      UC9C UC9C 0C 04 M1
895      UC9E UC9E 1A 1A
896      UC9C UC9C 0C 04 M1
897      UC9E UC9E 1A 1A
898      UC9C UC9C 0C 04 M1
899      UC9E UC9E 1A 1A
900      UC9C UC9C 0C 04 M1
901      UC9E UC9E 1A 1A
902      UC9C UC9C 0C 04 M1
903      UC9E UC9E 1A 1A
904      UC9C UC9C 0C 04 M1
905      UC9E UC9E 1A 1A
906      UC9C UC9C 0C 04 M1
907      UC9E UC9E 1A 1A
908      UC9C UC9C 0C 04 M1
909      UC9E UC9E 1A 1A
910      UC9C UC9C 0C 04 M1
911      UC9E UC9E 1A 1A
912      UC9C UC9C 0C 04 M1
913      UC9E UC9E 1A 1A
914      UC9C UC9C 0C 04 M1
915      UC9E UC9E 1A 1A
916      UC9C UC9C 0C 04 M1
917      UC9E UC9E 1A 1A
918      UC9C UC9C 0C 04 M1
919      UC9E UC9E 1A 1A
920      UC9C UC9C 0C 04 M1
921      UC9E UC9E 1A 1A
922      UC9C UC9C 0C 04 M1
923      UC9E UC9E 1A 1A
924      UC9C UC9C 0C 04 M1
925      UC9E UC9E 1A 1A
926      UC9C UC9C 0C 04 M1
927      UC9E UC9E 1A 1A
928      UC9C UC9C 0C 04 M1
929      UC9E UC9E 1A 1A
930      UC9C UC9C 0C 04 M1
931      UC9E UC9E 1A 1A
932      UC9C UC9C 0C 04 M1
933      UC9E UC9E 1A 1A
934      UC9C UC9C 0C 04 M1
935      UC9E UC9E 1A 1A
936      UC9C UC9C 0C 04 M1
937      UC9E UC9E 1A 1A
938      UC9C UC9C 0C 04 M1
939      UC9E UC9E 1A 1A
940      UC9C UC9C 0C 04 M1
941      UC9E UC9E 1A 1A
942      UC9C UC9C 0C 04 M1
943      UC9E UC9E 1A 1A
944      UC9C UC9C 0C 04 M1
945      UC9E UC9E 1A 1A
946      UC9C UC9C 0C 04 M1
947      UC9E UC9E 1A 1A
948      UC9C UC9C 0C 04 M1
949      UC9E UC9E 1A 1A
950      UC9C UC9C 0C 04 M1
951      UC9E UC9E 1A 1A
952      UC9C UC9C 0C 04 M1
953      UC9E UC9E 1A 1A
954      UC9C UC9C 0C 04 M1
955      UC9E UC9E 1A 1A
956      UC9C UC9C 0C 04 M1
957      UC9E UC9E 1A 1A
958      UC9C UC9C 0C 04 M1
959      UC9E UC9E 1A 1A
960      UC9C UC9C 0C 04 M1
961      UC9E UC9E 1A 1A
962      UC9C UC9C 0C 04 M1
963      UC9E UC9E 1A 1A
964      UC9C UC9C 0C 04 M1
965      UC9E UC9E 1A 1A
966      UC9C UC9C 0C 04 M1
967      UC9E UC9E 1A 1A
968      UC9C UC9C 0C 04 M1
969      UC9E UC9E 1A 1A
970      UC9C UC9C 0C 04 M1
971      UC9E UC9E 1A 1A
972      UC9C UC9C 0C 04 M1
973      UC9E UC9E 1A 1A
974      UC9C UC9C 0C 04 M1
975      UC9E UC9E 1A 1A
976      UC9C UC9C 0C 04 M1
977      UC9E UC9E 1A 1A
978      UC9C UC9C 0C 04 M1
979      UC9E UC9E 1A 1A
980      UC9C UC9C 0C 04 M1
981      UC9E UC9E 1A 1A
982      UC9C UC9C 0C 04 M1
983      UC9E UC9E 1A 1A
984      UC9C UC9C 0C 04 M1
985      UC9E UC9E 1A 1A
986      UC9C UC9C 0C 04 M1
987      UC9E UC9E 1A 1A
988      UC9C UC9C 0C 04 M1
989      UC9E UC9E 1A 1A
990      UC9C UC9C 0C 04 M1
991      UC9E UC9E 1A 1A
992      UC9C UC9C 0C 04 M1
993      UC9E UC9E 1A 1A
994      UC9C UC9C 0C 04 M1
995      UC9E UC9E 1A 1A
996      UC9C UC9C 0C 04 M1
997      UC9E UC9E 1A 1A
998      UC9C UC9C 0C 04 M1
999      UC9E UC9E 1A 1A

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PIP ASSEMBLER VERSION SOURCE LEVEL 1 HEADLINE INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 24

```

LINE ADDR L=H M1 M2 M3 M4 P=KOR SOURCE
876 0CA3 04 00
877 0CA5 75 01
878 0CA7 84 66
879 0CA9 81
880 0CAA 94
881 0CAB C3
882 0CAC 06 01
883 0CAE 86 66
884 0CB0 86 00
885 0CB2 96 00
886 0CB3 18 04
887 0CB5 0C 05
888 0CB7 0C 07
889 0CB8 0C 08
890 0CB9 0C 09
891 0CBA 0C 0A
892 0CBC 0C 0B
893 0CBD 0C 0C
894 0CCE 0C 0D
895 0CDF 0C 0E
896 0CE0 0C 0F
897 0CE1 0C 10
898 0CE2 0C 11
899 0CE3 0C 12
900 0CE4 0C 13
901 0CE5 0C 14
902 0CE6 0C 15
903 0CE7 0C 16
904 0CE8 0C 17
905 0CE9 0C 18
906 0CEA 0C 19
907 0CEB 0C 1A
908 0CEC 0C 1B
909 0CED 0C 1C
910 0CEE 0C 1D
911 0CEF 0C 1E
912 0CF0 0C 1F
913 0CF1 0C 20
914 0CF2 0C 21
915 0CF3 0C 22
916 0CF4 0C 23
917 0CF5 0C 24
918 0CF6 0C 25
919 0CF7 0C 26
920 0CF8 0C 27
921 0CF9 0C 28
922 0CFA 0C 29
923 0CFB 0C 2A
924 0CFC 0C 2B
925 0CFD 0C 2C
926 0CFE 0C 2D
927 0CF0 0C 2E

* ENTER HERE IF HX=NEG & HY=POS
  LODI,R0 H180
  CPSL C
  ADDI,R0 H166
  ADDI,R1
  DAK,R0
  STRZ R3
  LODI,R2 H101
  ADDI,R2 H166
  ADDI,R2 0
  DAK,R2
  BCTR,UN FINE
  * ENTER HERE IF HX & HY = NEG
  NHY LODI,R0 H180
  DO SUBZ R1 SUB. YAW1 LSR
  DAK,R0
  STRZ R3
  LODI,R2 H101
  SUBI,R2 0
  DAK,R2

* **** HEADOUT OF DATA *****
  FINE
  WRITE,R2 H1FF
  WRITE,R3 H1FF
  WRITE,R3 LSR
  RETC,UN
  ORG H1E40
  * S.M. TO CALC. THE HZ COMPONENT IN X-Z PLANE
  * HZ=HY*ST((PHI) + HZCOS(PHI))
  * EXIT WITH HZ IN UPK2,OPR2+1
  * *****
  HZR1 LODA,R1 DAIM+8
  LODA,R2 DAIM+8
  ANDI,R1 H180
  ANDI,R2 H1FF
  STRA,R1 TRUE
  LODA,R0 SIN,R2
  STRA,R0 SIN
  LODA,R0 COS,R2
  STRA,R0 UPK1+1
  LODA,R0 DAIM+4
  LODA,R1 DAIM+5
  STRA,R0 UPK2
  STRA,R1 UPK2+1
  BSTR,UN SUPY
  LODA,R0 HSLI
  LODA,R1 HSLI+1
  STRA,R0 ANUP

```

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PIP ASSEMBLER V-RS:IN SCU LEVEL 1 HEADUNG INSTRUMENT ASSEMBLY PROGRAM 1-76 PAGE

LINE ADDR 1 A-D 01 02 03 04 FROM SOURCE

928	0E71	CD 04 0A	STR4,R1	BRUP	
929	0E74	CC 04 09	LODA,R0	STNR	
930	0E77	CC 04 7A	STR4,R0	OPR1+1	
931	0E7A	CC 04 5C	LODA,R0	DATA+2	HY
932	0E7D	CD 04 5D	LODA,R1	DATA+3	
933	0E80	C2	STR2	R2	
934	0E81	44 7F	AND1,R0	H7F1	
935	0E83	46 8C	AND1,R2	H780	
936	0E85	7E 04 0D	LODA,R2	TRUF	DETERMINE SIG
937	0E88	CC 04 7A	STR4,R0	OPR2	
938	0E8B	CC 04 7C	STR4,R1	OPR2+1	
939	0E8F	CE 04 7E	STR4,R2	SRES	
940	0E91	3F 04 0D	BSTA,UN	SMPY	HY=SIN(PH1)
941	0E94	CC 04 09	LODA,R0	ARUF	
942	0E97	CC 04 0A	LODA,R1	BRUF	
943	0E9A	CC 04 05	STR4,R0	TEMP+1	
944	0E9D	CD 04 06	STR4,R1	TEMP+1	
945	0E9D	75 02	CPSL	COM	AUU
946	0EA2	20	LORZ	R0	
947	0EA3	CC 04 7D	STR4,R0	STEM	HZ=COX(PH1)=PUS.
948	0EA6	3F 04 0B	BSTA,UN	SADD	
949	0EA9	CC 04 77	LODA,R0	RSLT	
950	0EAC	CC 04 78	LODA,R1	RSLT+1	
951	0EAF	CC 04 7A	STR4,R0	OPR2	
952	0EB2	CC 04 7C	STR4,R1	OPR2+1	
953	0EB5	77 02	PPSL	COM	
954	0EB7	17	RETC,IN		

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PIP ASSEMBLER VERSION SCU LEVEL 1 HEADING INSTRUMENT ASSEMBLY PROGRAM 1976 PAGE 26

LINE ADDR LABEL B1 B2 B3 B4 ERROR SOURCE

```

956      UERR 0E1B 75 01      C      CPSEL      C      HY MSB
957      UERR 0C 04 5C      LODA,R0  DATM*2  HY L56
958      UERR 0D 04 5D      LODA,R1  DATM*3  HY L56
959      UERR 0E 07 1E      LODA,R2  SINE  SINERROR)
960      UERR C3      STRZ  R3      STRIP SIGN
961      UERR 44 7F      ANDI,R0  M17F1  SAVE SIGN
962      UERR 47 80      ANDI,R3  M1801  SIGN OF HY* SINERR)
963      UERR CC 04 78      STRA,R0  DPR2  FURN PROD.
964      UERR CC 04 7C      STRA,R1  DPR2*1  HX MSH
965      UERR CE 04 7A      STRA,R2  DPR1*1  HX L56
966      UERR CF 04 7E      STRA,R3  SWPS  SIGN OF HY* SINERR)
967      UERR 3F 0A A6      BSTA,UN  SWPY  FURN PROD.
968      UERR 0C 04 5A      LODA,R0  DATM  HX MSH
969      UERR 0D 04 5B      LODA,R1  DATM*1  HX L56
970      UERR C2      STRZ  R2      SIGN OF HY* SINERR)
971      UERR 44 7F      ANDI,R0  M17F1  FURN PROD.
972      UERR 46 80      ANDI,R2  M1801  HX MSH
973      UERR CC 04 65      STRA,R0  TEMP  HX L56
974      UERR CD 04 66      STRA,R1  TEMP*1  SIGN OF HY* SINERR)
975      UERR CE 04 7D      STRA,R2  STEA  FURN PROD.
976      UERR 75 02      CPSEL  COM  HX L56
977      UERR 3F 09 98      BSTA,UN  SADD  SIGN OF HY* SINERR)
978      UERR 0C 04 77      LODA,R0  RSLT  FURN PROD.
979      UERR 0D 04 78      LODA,R1  RSLT*1  HX MSH
980      UERR CC 04 5A      STRA,R0  DATM  HX L56
981      UERR CU 04 5B      STRA,R1  DATM*1  SIGN OF HY* SINERR)
982      UERR 77 02      PPSEL  COM  FURN PROD.
983      UERR 17      REFC,UN  MODIFIED 4X
984      UERR 17      REFC,UN  MODIFIED 4X
985      UERR 17      REFC,UN  MODIFIED 4X
986      UERR 17      REFC,UN  MODIFIED 4X
987      UERR 17      REFC,UN  MODIFIED 4X
988      UERR 17      REFC,UN  MODIFIED 4X
989      UERR 17      REFC,UN  MODIFIED 4X
990      UERR 17      REFC,UN  MODIFIED 4X
991      UERR 17      REFC,UN  MODIFIED 4X
992      UERR 17      REFC,UN  MODIFIED 4X
993      UERR 17      REFC,UN  MODIFIED 4X

```

TOTAL ASSEMBLY ERRORS = 0

APPENDIX C

The transcendental functions used throughout the heading computation algorithm were implemented using a table look up procedure. To generate the respective look up tables in computer memory data was first generated using algol programs. This technique expedited modifications to tabular data and provided output data in a convenient (hexadecimal) format.

Programs that calculated $\cos(\theta)$ and $\cos^2(\theta)$ to eight bit and sixteen bit resolution respectively are included.

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PAGE 001

```

001 00000 HPAI 1,"RP"
002 00000 BFGT1
003 00001 1.....
004 00001 1 A PROGRAM TO GENERATE A COS-COS TABLE FOR A
005 00001 1 MICROPROCESSOR BASED SYSTEM
006 00001 1 ADDRESS: ANGLE, COS(ANGLE), AND DATA IN
007 00001 1 BOTH BINARY AND HEX FORMAT IS TABULATED
008 00001 1.....
009 00001 INTEGER A,B,C,D,E,F
010 00010 RPAI THETA,STHETA,AP,ASTH1
011 00020 RPAI ARRAY AN(0:255,0:15)
012 21070 INTEGER ARRAY VAL(0:15):="0","1","2","3","4","5",
013 21102 "6","7","8","9","A","B",
014 21107 "C","D","E","F"
015 21114 INTEGER ARRAY MULT(0:3):=8,2,11
016 21124 INTEGER ARRAY HEX(0:255,0:3)
017 23136 WRITE (A,1(1:1))
018 23175 WRITE (A,8(1:4X,"A",5X,"THETA",4X,"COS-COS",5X,
019 23226 "BINARY",14X,"HEX",11))
020 23242 WRITE (A,8(5X,"(ADDRESS)",3X,"(DEG)",18X," DATA ",11))
021 23276 FOR A:= 45 TO 90 DO
022 23304 BEGIN
023 23304 AX:=A
024 23310 THETA:= AX*PI/180
025 23316 STHETA:=(COS(THETA))^2
026 23330 HI:=0
027 23332 ASTH:=STHETA
028 23336 WHILE HI<17 DO
029 23341 BEGIN
030 23342 ISHI:= 2*ASTH
031 23350 IF STH>1 THEN
032 23355 BEGIN
033 23355 AN(A,HI):=1
034 23367 ASTH:=ASTH-1
035 23375 END ELSE AN(A,HI):=0
036 23405 HI:=HI+1
037 23440 ENDO
038 23441 HI:=0
039 23443 FOR C:=0 TO 3 DO
040 23451 BEGIN
041 23451 HI:=4*C
042 23455 FI:=0
043 23457 FOR F:=0 TO 3 DO
044 23465 BEGIN
045 23465 FI:=F*MULT(F)*AN(A,HI)
046 23520 HEX(A,C):= VAL(F)
047 23533 ENDO
048 23537 ENDO
049 23543 THETA:= THETA*180/PI
050 23553 WRITE (B,1(5X,15,2(3X,FA,6),3X,10(1,5X,4A2),A,
051 23604 THETA,STHETA, FOR HI= 0 TO 15 DO
052 23620 AN(A,HI), FOR FI= 0 TO 3 DO HEX(A,FI))
053 23653 ENDO
054 23657 ENDO

```

PROGRAM= 0236A3 ERRORS=000

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A	THETA	COS*COS	BINARY	HEX
(ADDR.)	(DEG)		DATA	
45	45.00000	.500000	0111111111111111	7 F F F
46	46.00000	.482550	0111101110001000	7 8 8 8
47	47.00000	.465122	0111011100010010	7 7 1 2
48	48.00000	.447736	0111001010011110	7 2 9 E
49	49.00000	.430413	0110111000101111	6 E 2 F
50	50.00000	.413176	0110100111000101	6 9 C 5
51	51.00000	.396044	0110010101100011	6 5 6 J
52	52.00001	.379039	0110000100001000	6 1 0 8
53	53.00000	.362181	0101110010110111	5 C 8 7
54	54.00000	.345491	0101100001110010	5 8 7 2
55	55.00000	.328990	0101010000111000	5 4 3 8
56	56.00000	.312697	0101000000001100	5 0 0 C
57	57.00000	.296632	0100101111110000	4 8 F 0
58	58.00000	.280814	0100011111100011	4 7 E 3
59	59.00000	.265244	0100001111101000	4 3 E 8
60	60.00001	.250000	0011111111111111	3 F F F
61	61.00000	.235040	0011110000101011	3 C 2 8
62	62.00000	.220403	0011100001101100	3 8 6 C
63	63.00000	.206107	0011010011000011	3 4 C 3
64	64.00000	.192149	0011000100110010	3 1 3 2
65	65.00000	.178606	0010110110111001	2 D 8 9
66	66.00000	.165435	0010101001011001	2 A 5 9
67	67.00000	.152671	0010011100010101	2 7 1 5
68	68.00000	.140330	0010001111101100	2 3 E C
69	69.00000	.128427	0010000011100000	2 0 E 0
70	70.00000	.116978	0001110111110010	1 D F 2
71	71.00000	.105995	0001101100100010	1 8 2 2
72	72.00000	.095491	0001100001110010	1 8 7 2
73	73.00000	.085481	0001010111100010	1 5 E 2
74	74.00000	.075976	0001001101110011	1 3 7 3
75	75.00000	.066987	0001000100100110	1 1 2 6
76	76.00000	.058526	0000111011111011	0 E F 8
77	77.00002	.050603	0000110011110100	0 C F 4
78	78.00000	.043227	0000101100010000	0 8 1 0
79	79.00000	.036408	0000100101010010	0 9 5 2
80	80.00000	.030154	0000011110111000	0 7 8 8
81	81.00000	.024472	0000011001000011	0 6 4 J
82	82.00000	.019349	0000010011110101	0 4 F 5
83	83.00000	.014852	0000001111001101	0 3 C 0
84	84.00002	.010926	0000001011001100	0 2 C C
85	85.00000	.007596	0000000111100001	0 1 F 1
86	86.00000	.004866	0000000100111110	0 1 3 E
87	87.00000	.002739	0000000010110011	0 0 8 J
88	88.00000	.001218	0000000001001111	0 0 4 F
89	89.00000	.000305	0000000000010011	0 0 1 3
90	90.00000	.000000	0000000000000000	0 0 0 0

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PAGE 001

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001 00000 HPAI .1, "RPM"
002 00000 HPGIN
003 00001 A*****
004 00001 A A PROGRAM TO GENERATE A COS TABLE FOR A
005 00001 A MICROPROCESSOR BASED SYSTEM
006 00001 A ADDRESS, ANGLE, COS(ANGLE), AND DATA IN
007 00001 A BOTH BINARY AND HEX FORMAT IS TABULATED
008 00001 A*****
009 00001 INTEGER A,B,C,D,E,F;
010 00010 REAL THETA,STHETA,AR,HSTH;
011 00020 REAL ARRAY AN(0:256,0:16);
012 21070 INTEGER ARRAY VAL(0:15);
013 21102 "0","1","2","3","4","5",
014 21107 "6","7","8","9","A",
015 21114 "B","C","D","E","F";
016 21124 INTEGER ARRAY MULT(0:15);
017 21136 WRITE (A,B(1:H));
018 21175 WRITE (B,1//.9X,"A",5X,"THETA",4X,"COS(THETA)",2X, "BINARY",6X,"HEX",
019 23240 /);
020 23243 WRITE (A,B(5X,"(ADDR)",3X,"(DEG)",18X," DATA ",//));
021 23277 FOR A:= 45 TO 90 DO
022 23305 BEGIN
023 23305 AR:=A;
024 23311 THETA:= AR*PI/180;
025 23317 STHETA:= COS(THETA);
026 23323 H:=0;
027 23325 HSTH:=STHETA;
028 23331 WHILE H<9 DO
029 23334 BEGIN
030 23335 HSTH:= 2*HSTH;
031 23343 IF HSTH>1 THEN
032 23350 BEGIN
033 23350 AN(A,B):=1;
034 23362 HSTH:=HSTH-1;
035 23370 END; ELSE AN(A,B):=0;
036 23403 H:=B+1;
037 23406 END;
038 23407 H:=0;
039 23411 FOR C:=0 TO 3 DO
040 23417 BEGIN
041 23417 D:=4*C;
042 23450 E:=0;
043 23452 FOR F:=0 TO 7 DO
044 23460 BEGIN
045 23460 F:=F*MULT[F]*AN(A,B)*E;
046 23513 HEX(A,C):= VAL(F);
047 23526 END;
048 23532 END;
049 23536 THETA:= THETA*180/PI;
050 23546 WRITE (B,1//.5X,15,2(3X,FR,6),3X,BF1.0,5X,242),A,THETA,STHETA,
051 23605 FOR H:=0 TO 7 DO AN(A,B),FOR D:=0 TO 3 DO HEX(A,D));
052 23646 END;
053 23652 END;

```

PROGRAM= 023656 ERRORS=000

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A (ADDR.)	THETA (DEG)	COS(THETA)	BINARY DATA	HEX
45	45.00000	.707107	1.11.1.1	8 5
46	46.00000	.694659	1.11...1	8 1
47	47.00000	.681998	1.1.111.	A E
48	48.00000	.669131	1.1.1.11	A 8
49	49.00000	.656059	1.1.1111	A 7
50	50.00000	.642788	1.1.1.1.	A 4
51	51.00000	.629320	1.1...1	A 1
52	52.00001	.615662	1...111.1	9 0
53	53.00000	.601815	1...11.1.	9 A
54	54.00000	.587785	1...1.11.	9 6
55	55.00000	.573576	1...1.1.	9 2
56	56.00000	.559193	1...1111	8 F
57	57.00000	.544639	1...1.11	8 8
58	58.00000	.529919	1...111	8 7
59	59.00000	.515038	1...1.11	8 3
60	60.00001	.500000	.1111111	7 F
61	61.00000	.484810	.11111..	7 C
62	62.00000	.469471	.1111...	7 8
63	63.00000	.453991	.111.1..	7 4
64	64.00000	.438371	.111....	7 0
65	65.00000	.422618	.11.11..	6 C
66	66.00000	.406737	.11.1...	6 8
67	67.00000	.390731	.11.1..	6 4
68	68.00000	.374607	.1.11111	5 F
69	69.00000	.358348	.1.11.11	5 8
70	70.00000	.342020	.1.1.111	5 7
71	71.00000	.325568	.1.1.11	5 3
72	72.00000	.309017	.1.1111	4 F
73	73.00000	.292372	.1.1.1.	4 A
74	74.00000	.275637	.1...11.	4 6
75	75.00000	.258819	.1...1.	4 2
76	76.00000	.241922	.1111.1	3 0
77	77.00002	.224951	.111.1.	3 9
78	78.00000	.207912	.11.1.1	3 5
79	79.00000	.190809	.11....	3 0
80	80.00000	.173648	.1.11..	2 C
81	81.00000	.156435	.1.1.1...	2 8
82	82.00000	.139173	.1.1.11	2 3
83	83.00000	.121849	.111111	1 F
84	84.00002	.104528	.11.1.	1 A
85	85.00000	.087156	.1.11.	1 6
86	86.00000	.069757	.1...1.	1 1
87	87.00000	.052336	.11.1.	0 D
88	88.00000	.034900	.1...	0 8
89	89.00000	.017452	.1...	0 4
90	90.00000	.000000		0 0

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